

Mind the Gap: A Formal Investigation of the Relationship Between Log and Model Complexity – Extended Version

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Abstract. Simple process models are key for effectively communicating the outcomes of process mining. An important question in this context is whether the complexity of event logs used as inputs to process discovery algorithms can serve as a reliable indicator of the complexity of the resulting process models. Although various complexity measures for both event logs and process models have been proposed in the literature, the relationship between input and output complexity remains largely unexplored. In particular, there are no established guidelines or theoretical foundations that explain how the complexity of an event log influences the complexity of the discovered model. This paper examines whether formal guarantees exist such that increasing the complexity of event logs leads to increased complexity in the discovered models. We study 18 log complexity measures and 17 process model complexity measures across five process discovery algorithms. Our findings reveal that only the complexity of the flower model can be established by an event log complexity measure. For all other algorithms, we investigate which log complexity measures influence the complexity of the discovered models. The results show that current log complexity measures are insufficient to decide which discovery algorithms to choose to construct simple models. We propose that authors of process discovery algorithms provide insights into which log complexity measures predict the complexity of their results.

1 Introduction

Processes are everywhere in our daily lives. Starting from handling orders in an online shop, ranging over the executions of treatments in hospitals, to things as mundane as following a recipe. It comes to no surprise that organisations are eager to find and optimise such processes in a structured and automated fashion. To aid organisations with this task is the goal of *process mining* [1]. This relatively young research discipline essentially consists of three phases: Techniques for *process discovery* automatically find a process model for previously recorded data of the system. Since there are many process discovery techniques to choose from,

conformance checking enables its users to decide which process model represents the data best without having to scan through the entire dataset [2]. Finally, during *process enhancement*, the discovered and selected models give conclusions on how to adapt the real process to make it more efficient or rule-conformant.

Since the last phase depends on the specific process at hand, research in process mining is especially interested in the first two phases. As such, the literature presents a vast amount of process discovery techniques that still regularly finds new additions. The quality of the resulting models is checked within four quality dimensions: *Fitness* rewards models that can replay all behaviour in the data. *Precision*, on the other hand, rewards models that do not deviate from this behaviour. The model M of Fig. 1 shows that fitness and precision alone are not enough to ensure good model-quality, since M has perfect fitness and precision, but is merely another way to represent the raw data. Thus, *generali-*

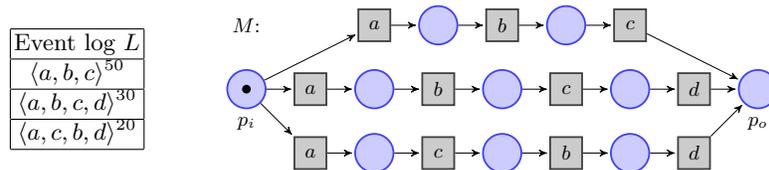


Fig. 1. An event log L and its trace net M with perfect fitness and precision.

sation rewards models that deviate from the recorded data, if these deviations are possible executions in the process. The *simplicity* dimension rewards models that are easy to read and understand.

High simplicity is crucial to analyse the model during the process enhancement phase, and to present the findings to stake-holders and decision-makers. Furthermore, low simplicity in a process model indicates the existence of errors in the model [3]. Due to its importance, multiple measures for this dimension emerged in the literature. We call these measures *simplicity measures*, if simpler models receive higher values, or *complexity measures*, if simpler models receive lower values. High complexity in process models is often the result of complex input data, rather than the fault of process discovery techniques [4]. In turn, complexity measures for recorded data are as important, as they aim to estimate the complexity of the model before process discovery [5].

Yet, to this date, there is no proved theoretical connection between complexity measures for data and for models. In this paper, we analyse whether complexity measures for data can predict the complexity of models mined with specific process discovery techniques. We describe the state of the art in Section 2 and set the scene with the necessary definitions in Section 3. In Section 4, we investigate how increasing complexity of the underlying data influences the complexity of automatically discovered models. We investigate two baseline discovery algorithms and three more advanced mining techniques and discuss what

types of complexity measures for data are currently missing. Finally, in Section 5, we summarise and give suggestions for future research.

2 Related Work

Complex process models come with several disadvantages. Mendling [3] showed that complex models are more likely to contain errors and that complexity measures can predict these errors, highlighting the importance of the simplicity dimension. To further emphasise this importance, Reijers et al. [7] investigated the influence of complex structures in process models to their understandability. They found that measures that punish connectors in a model are best-suited to predict its understandability. Yet, they found that personal factors like experience have the highest impact on understandability. Lieben et al. [8] showed via a factor analysis that most of the complexity measures in the literature fall into four different dimensions. Thereby, they considerably reduce the amount of complexity measures process analysts have to choose from when evaluating simplicity. Schalk et al. [9] further deepened this analysis by comparing mathematical properties of complexity measures inside the same dimension.

On the side of complexity measures for data, Günther [5] found that poor quality in data means poor quality in discovered process models. They therefore defined multiple complexity measures for so-called event logs, which are typically used to store recorded data in business processes. The goal of the defined complexity measures is to evaluate the structure of event logs, and to select a suitable process discovery algorithm for the analysis of these logs [5, p. 50]. Furthermore, they propose to use these measures to estimate the computational complexity of process mining algorithms. Yet, concrete guidelines for which process discovery algorithm to choose when certain log complexity scores are high are missing. Augusto et al. [10] therefore analysed the influence of log complexity on the fitness, precision, size, and control flow complexity of three high-level discovery algorithms. Using statistical analysis, they found that only the number of different event names in the event log (variety) and the average edit distance between two traces of the log are good predictors. Furthermore, they defined four new graph-entropy-based complexity measures, out of which one is a good predictor for the fitness of the model returned by the split miner.

Surprised by these findings, in this paper, we investigate whether there is a theoretical connection between existing log complexity measures and the complexity of discovered process models. To do so, we use the models of five simple process discovery techniques and research the effect of increasing log complexity on their model complexity. We use the 18 log complexity measures collected by Augusto et al. [10] and the 17 model complexity measures collected by Lieben et al. [8]. Since only the model complexity scores of the flower model show a direct connection to existing log complexity measures, we continue the analysis by providing measures that are better-suited to predict model complexity of the discovered models. This way, we enable users of log complexity measures to draw the right conclusions.

3 Basic Definitions

We define $\mathbb{N} := \{1, 2, 3, \dots\}$ as the set of natural numbers, $\mathbb{N}_0 := \mathbb{N} \cup \{0\}$ as the set of non-negative natural numbers, and \mathbb{R}_0^+ as the set of non-negative real numbers. Let A be an alphabet. A *trace* over A is a sequence of elements drawn from A , i.e., $\sigma = \langle a_1, \dots, a_n \rangle$, where $a_1, \dots, a_n \in A$. The *length* of such a trace is denoted by $|\sigma| := n$. The (unique) trace with length 0 is denoted by ϵ and called the *empty trace*. For all $i \in \{1, \dots, n\}$, we write $\sigma(i) := a_i$ to address the element at the i -th position in the trace. For two arbitrary traces $\sigma_1 = \langle a_1, \dots, a_k \rangle$ and $\sigma_2 = \langle b_1, \dots, b_l \rangle$ over A , we define their *concatenation* as the trace $\sigma_1 \cdot \sigma_2 := \langle a_1, \dots, a_k, b_1, \dots, b_l \rangle$. For a trace σ , the n -ary concatenation of σ is defined inductively as $\sigma^0 = \epsilon$ and $\sigma^{n+1} = \sigma \cdot \sigma^n$ for $n \geq 0$.

For any set D , we define a *multiset* m as a total function $m : D \rightarrow \mathbb{N}_0$, where for any $d \in D$, $m(d)$ is the number of occurrences of the element d in the multiset m . For two multisets m_1, m_2 , we define $m_1 + m_2$ as the multiset $(m_1 + m_2)$ with $\forall d \in D : (m_1 + m_2)(d) = m_1(d) + m_2(d)$. We write $m_1 \sqsubseteq m_2$ if $\forall d \in D : m_1(d) \leq m_2(d)$, and $m_1 \sqsubset m_2$ if $m_1 \sqsubseteq m_2$ and $m_1 \neq m_2$. We define the *support* of a multiset m as the set $\text{supp}(m) := \{d \in D \mid m(d) > 0\}$. An *event log* L is a multiset of traces. We represent event logs the way shown in the example of Fig. 1, by adding the frequency of each trace to its superset.

Definition 1 (Petri nets and workflow nets). A (unlabeled) Petri net is a triple $N = (P, T, F)$, where P is the set of places, T is the set of transitions, $P \cap T = \emptyset$, and $F \subseteq (P \times T) \cup (T \times P)$ is the flow relation. For any place $p \in P$, we define its *preset* as $\bullet p := \{t \in T \mid (t, p) \in F\}$ and its *postset* as $p^\bullet := \{t \in T \mid (p, t) \in F\}$. We define pre- and postsets of transitions accordingly.

A workflow net is a 7-tuple $W = (P, T, F, \ell, A, p_i, p_o)$, where (P, T, F) defines a Petri net, $\ell : T \rightarrow (A \cup \{\tau\})$ is a function assigning a label of A or the special label $\tau \notin A$ to the transitions in the net, and where $p_i, p_o \in P$ are places with:

- p_i is the only place without incoming arcs, i.e. $\bullet p_i = \emptyset$,
- p_o is the only place without outgoing arcs, i.e. $p_o^\bullet = \emptyset$,
- every node lies on some path from p_i to p_o .

Transitions $t \in T$ with $\ell(t) = \tau$ are called *silent transitions*.

Fig. 1 shows an example for a workflow net M . To visually distinguish between places and transitions, we draw places as circles and transitions as rectangles. As M demonstrates, the labeling function enables us to assign the same label to multiple different transitions. Furthermore, every arc in a Petri net has a place as start point and a transition as end point or a transition as start point and a place as end point. In other words, there can never be arcs between two places or between two transitions.

It is possible that multiple arcs leave or enter a place or a transition. If multiple arcs leave a place, the transitions in its postset compete for the tokens in the place. Thus, such places initiate a choice between the transitions in its postset. On the other hand, if multiple arcs leave a transition, then this transition

initiates a parallel execution. Most complexity measures are interested in these special types of nodes in a Petri net. Thus, we next define the notion of *connectors* in a workflow net.

Definition 2 (Connectors in workflow nets). *Let $W = (P, T, F, \ell, p_i, p_o)$ be a workflow net, where $t \in T$ is a transition and $p \in P$ is a place.*

- If $|p^\bullet| > 1$, we call p an **xor-split**.
- If $|\bullet p| > 1$, we call p an **xor-join**.
- If $|t^\bullet| > 1$, we call t an **and-split**.
- If $|\bullet t| > 1$, we call t an **and-join**.

Accordingly, we define

- the set of **xor-splits** in W as $\mathcal{S}_{xor}^W := \{p \in P \mid |p^\bullet| > 1\}$,
- the set of **xor-joins** in W as $\mathcal{J}_{xor}^W := \{p \in P \mid |\bullet p| > 1\}$,
- the set of **and-splits** in W as $\mathcal{S}_{and}^W := \{t \in T \mid |t^\bullet| > 1\}$,
- the set of **and-joins** in W as $\mathcal{J}_{and}^W := \{t \in T \mid |\bullet t| > 1\}$.

Note that these sets are not necessarily disjoint. The set of xor-connectors in W is $\mathcal{C}_{xor}^W := \mathcal{S}_{xor}^W \cup \mathcal{J}_{xor}^W$, the set of and-connectors in W is $\mathcal{C}_{and}^W := \mathcal{S}_{and}^W \cup \mathcal{J}_{and}^W$ and the set of all connectors is $\mathcal{C}^W := \mathcal{C}_{xor}^W \cup \mathcal{C}_{and}^W$.

Most of the discovery techniques we investigate produce workflow nets. Yet, we are aware that organisations often use directly follows graphs (DFG) and extend our analyses to this model-type.

Definition 3 (Directly follows graph). *Let L be an event log over a set of activity names A . For $x, y \in A$, we write $x >_L y$ if there is a trace $\sigma \in L$ with $\sigma(i) = x$ and $\sigma(i+1) = y$ for some $i \in \{1, \dots, |\sigma|\}$. The directly follows graph for L is the graph $DFG(L) = (V, E)$ with $V := A \cup \{\triangleright, \square\}$, where $\triangleright, \square \notin A$, and with*

$$\begin{aligned} E := & \{(\triangleright, x) \mid \exists \sigma \in L : \sigma(1) = x\} \\ & \cup \{(x, y) \mid x >_L y\} \\ & \cup \{(x, \square) \mid \exists \sigma \in L : \sigma(|\sigma|) = x\}. \end{aligned}$$

For an event log L and its directly follows graph $DFG(L)$, we denote the set of vertices in $DFG(L)$ by $V(DFG(L))$ and the set of edges in $DFG(L)$ by $E(DFG(L))$.

Fig. 2 shows an example of a directly follows graph for the example event log L shown in Fig. 1.

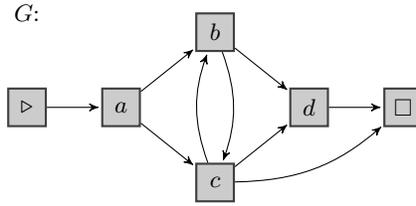


Fig. 2. The directly follows graph G for the event log L of Fig. 1.

3.1 Complexity of Process Models

For this section, let \mathcal{M} be the set of all process models. We define a model-complexity measure as a function $\mathcal{C}^M : \mathcal{M} \rightarrow \mathbb{R}_0^+$, assigning a non-negative, real-valued score to workflow nets. For our analyses, we investigate the model complexity measures collected by Lieben et al [8] and redefined for workflow nets by Schalk et al. [9]. To make this paper self-contained, we repeat their formal definitions here. Let $W = (P, T, F, \ell, A, p_i, p_o)$ be a workflow net.

- The **size** [3] C_{size} of the workflow net W is the number of nodes in its graphical representation. More precisely, the size of W is its number of places plus its number of transitions, $C_{\text{size}}(W) = |P| + |T|$.
- The **connector mismatch** [3] C_{MM} aims to estimate the amount of **xor**-splits that were closed by **and**-joins and the amount of **and**-splits that were closed by **xor**-joins in W . Such connector mismatches often occur in practice, but render a workflow net more complex. To avoid checking all paths in a workflow nets to find these connector mismatches, we calculate the difference of arcs exiting **xor**-splits and of arcs entering **xor**-joins:

$$MM_{\text{xor}}^W := \left| \sum_{t \in S_{\text{xor}}^W} |t \bullet| - \sum_{t \in J_{\text{xor}}^W} |\bullet t| \right|$$

Analogously, we calculate the difference of arcs exiting **and**-splits and of arcs entering **and**-joins, giving us:

$$MM_{\text{and}}^W := \left| \sum_{t \in S_{\text{and}}^W} |t \bullet| - \sum_{t \in J_{\text{and}}^W} |\bullet t| \right|$$

We combine these two sub-measures to the connector mismatch measure $C_{\text{MM}}(M) = MM_{\text{xor}}^W + MM_{\text{and}}^W$.

- The **connector heterogeneity** [3] $C_{\text{CH}}(W)$ of W is the entropy of its connector types. If the workflow net W has only one type of connectors, the score of this measure is 0. On the other hand, if it contains every connector-type equally often, the score of this measure is 1. To achieve this, we define:

$$C_{\text{CH}}(W) = - \left(\frac{|C_{\text{and}}^W|}{|C^W|} \cdot \log_2 \left(\frac{|C_{\text{and}}^W|}{|C^W|} \right) + \frac{|C_{\text{xor}}^W|}{|C^W|} \cdot \log_2 \left(\frac{|C_{\text{xor}}^W|}{|C^W|} \right) \right)$$

- The **cross-connectivity metric** [14] C_{CC} identifies how strong the connection between two nodes in W is. The idea is that two activities that always occur together in an execution sequence, are stronger connected than two activities that are independent of each other. This means, alternative activities are loosely connected. Accordingly, we define the weight of a transition in W as:

$$w_W(v) := \begin{cases} \frac{1}{|\bullet v| + |v \bullet|} & \text{if } v \in \mathcal{C}_{xor}^W \\ 1 & \text{if } v \in \mathcal{C}_{and}^W \\ 1 & \text{otherwise.} \end{cases}$$

Thus, places that have more than one outgoing or incoming arc get a weight less than 1, while all other nodes in W have weight 1. Weights are extended to the edges of the workflow net by defining $w_W((u, v)) = w_W(u) \cdot w_W(v)$ for any edge $(u, v) \in F$. For a simple path $\rho = v_1, v_2, \dots, v_{k-1}, v_k$, we set its weight to $w_W(\rho) = w_W((v_1, v_2)) \cdot \dots \cdot w_W((v_{k-1}, v_k))$ and define the value of a connection as:

$$V_W(v_i, v_j) := \max(\{w_W(\rho) \mid \rho \text{ is a simple path in } W \text{ from } v_i \text{ to } v_j\} \cup \{0\})$$

To calculate the score of the cross-connectivity metric, we take the average of all connection-values and subtract the result from 1:

$$C_{CC}(W) = 1 - \frac{\sum_{v_1, v_2 \in P \cup T} V_W(v_1, v_2)}{(|P| + |T|) \cdot (|P| + |T| - 1)}$$

- The **token split** [3] C_{ts} is the minimum amount of edges that need to be removed, such that the resulting net has no **and**-splits anymore. In turn, $C_{ts}(W) = \sum_{t \in \mathcal{S}_{and}} (|t \bullet| - 1)$.
- The **control flow complexity** [15] C_{CFC} estimates the cognitive load of a person that tries to understand the workflow net. The idea is that parallel splits add some complexity, but keep the amount of possible control flows unchanged. Split-connectors that start exclusive choices, however, add k possible control flows, where k is the amount of edges leaving the connector node. With this, $C_{CFC}(W) = |\mathcal{S}_{and}^W| + \sum_{p \in \mathcal{S}_{xor}^W} |p \bullet|$.
- The **separability** [3] C_{sep} is the ratio of cut-vertices in the workflow net. In graph-theory, a cut-vertex is a node whose removal results in an increase of the amount of connected components of the graph. If the graph has many cut-vertices, there are fewer structures in the graph where all nodes are connected to each other. Since the initial place p_i and the output place p_o can never be cut-vertices, we calculate the ratio of cut-vertices by dividing by $|P| + |T| - 2$ and set $C_{sep}(W) = 1 - \frac{|\{v \in P \cup T \mid v \text{ is a cut-vertex in } W\}|}{|P| + |T| - 2}$.
- The **average connector degree** [3] C_{acd} is the average amount of incoming and outgoing arcs of connector nodes, $C_{acd}(W) = \frac{1}{|\mathcal{C}^W|} \cdot \sum_{x \in \mathcal{C}^W} (|\bullet x| + |x \bullet|)$.
- The **maximum connector degree** [3] C_{mcd} is the maximum amount of incoming and outgoing arcs of connector nodes, so we define this measure as $C_{mcd}(W) = \max\{(|\bullet x| + |x \bullet|) \mid x \in \mathcal{C}^W\}$.

- The **sequentiality** [3] C_{seq} is the ratio of arcs between non-connector nodes, $C_{\text{seq}}(W) = 1 - \frac{1}{|F|} \cdot |\{(x, y) \in F \mid x, y \notin \mathcal{C}^W\}|$. The idea behind this measure is that sequences in a workflow net are easier to understand than parallelism or exclusive choices.
- The **depth** [3] C_{depth} is the maximum nesting of connectors in the workflow net. The depth can be calculated by taking the minimum of the in-depth and the out-depth. Then, the in-depth of a node v is the minimum amount of connectors encountered on a simple path from p_i to v . The out-depth of a node v is the minimum amount of connectors encountered on a simple path from v to p_o . More formally, let $\mathcal{S}^W := \mathcal{S}_{\text{and}}^W \cup \mathcal{S}_{\text{xor}}^W$ be the set of all split nodes in W and $\mathcal{J}^W := \mathcal{J}_{\text{and}}^W \cup \mathcal{J}_{\text{xor}}^W$ the set of all join nodes in W . For every simple path $\rho = (v_1, \dots, v_n)$ starting in p_i and ending in v , we define:

$$\lambda_W(v_1) = \lambda_W(p_i) := 0$$

$$\lambda_p(v_n) := \begin{cases} \lambda_W(v_{n-1}) + 1 & \text{if } v_{n-1} \in \mathcal{S}^W \wedge v_n \notin \mathcal{J}^W \\ \lambda_W(v_{n-1}) & \text{if } v_{n-1} \in \mathcal{S}^W \wedge v_n \in \mathcal{J}^W \\ \lambda_W(v_{n-1}) & \text{if } v_{n-1} \notin \mathcal{S}^W \wedge v_n \notin \mathcal{J}^W \\ \lambda_W(v_{n-1}) - 1 & \text{if } v_{n-1} \notin \mathcal{S}^W \wedge v_n \in \mathcal{J}^W \end{cases}$$

$$\lambda_W(v) := \max \left\{ 0, \max_{\rho \text{ a path from } p_i \text{ to } v} \lambda_p(v) \right\} \quad (\text{for any } v \neq p_i)$$

We define the out-depth in the same way, but with the net \overleftarrow{W} , where all edge directions reversed and where p_o takes the place of p_i . With this, the depth of the workflow net W is $C_{\text{depth}}(W) = \max\{\min\{\lambda_W(v), \lambda_{\overleftarrow{W}}(v)\} \mid v \in P \cup T\}$.

- The **diameter** [3] C_{diam} is the length of the longest simple path in W . Thus, we define $C_{\text{diam}}(W) = \max\{|k| \mid v_1, \dots, v_k \text{ is a simple path from } p_i \text{ to } p_o\}$.
- The **cyclicity** [3] C_{cyc} is the ratio of nodes in W that lie on a cycle. Since the nodes p_i and p_o can never lie on a cycle by definition, we take this ratio by dividing by $|P| + |T| - 2$ and get the following formal definition for cyclicity: $C_{\text{cyc}}(W) = \frac{1}{|P| + |T| - 2} \cdot |\{x \in P \cup T \mid x \text{ lies on a cycle in } W\}|$.
- The **coefficient of network connectivity** [3] C_{CNC} relates the number of arcs to the number of nodes, i.e. $C_{\text{CNC}}(W) = \frac{|F|}{|P| + |T|}$.
- The **density** [3] C_{dens} relates the number of arcs in W to the total possible amount of arcs in W . Since it is only possible to connect places to transitions and transitions to places, there are $2 \cdot |T| \cdot |P|$ possible arcs in a Petri net. In a workflow net, however, the input place p_i and the output place p_o can only have at most $|T|$ incoming or outgoing edges each. Thus, in total there can be $2 \cdot |T| \cdot (|P| - 1)$ edges in a workflow net. With this, we define the density of a workflow net W as $C_{\text{dens}}(W) = \frac{|F|}{2 \cdot |T| \cdot (|P| - 1)}$.
- The **number of duplicate tasks** [16] C_{dup} is the amount of repetitions in the transition labels. There are two possible ways to define this measure: Either by counting all label repetitions, including duplicate τ -labels, or by just counting label repetitions $\neq \tau$. The latter is useful in cases where silent

τ -transitions are only considered as routing mechanisms. In these cases, τ -repetitions could be even beneficial for how easy W is to understand. Therefore, we define $C_{\text{dup}}(W) = \sum_{a \in A} (\max(|\{t \in T \mid \ell(t) = a\}|, 1) - 1)$.

- The **number of empty sequence flows** [17] C_\emptyset is the number of places that have only **and**-splits in their preset and **and**-joins in their postset. Such places are often implicit and can be left out completely. Thus, we define this measure as $C_\emptyset(W) = |\{p \in P \mid \bullet p \subseteq \mathcal{S}_{\text{and}}^N \wedge p^\bullet \subseteq \mathcal{J}_{\text{and}}^N\}|$.

The formal definitions of these complexity measures for workflow nets are reported in Table 1. For later convenience, we define the set of all inspected model

Table 1. The complexity measures for workflow nets we investigate in this paper.

Measure	Definition	Reference
$C_{\text{size}}(W)$	$ P + T $	[3, p.118]
$C_{\text{MM}}(W)$	$MM_{\text{xor}}^W + MM_{\text{and}}^W$	[3, p.125]
$C_{\text{CH}}(W)$	$-\left(\frac{ C_{\text{and}}^W }{ C^W } \cdot \log_2\left(\frac{ C_{\text{and}}^W }{ C^W }\right) + \frac{ C_{\text{xor}}^W }{ C^W } \cdot \log_2\left(\frac{ C_{\text{xor}}^W }{ C^W }\right)\right)$	[3, p.126]
$C_{\text{CC}}(W)$	$1 - \frac{\sum_{n_1, n_2 \in P \cup T} V_W(n_1, n_2)}{(P + T) \cdot (P + T -1)}$	[14]
$C_{\text{ts}}(W)$	$\sum_{t \in \mathcal{S}_{\text{and}}} (t^\bullet - 1)$	[3, p.128]
$C_{\text{CFC}}(W)$	$ \mathcal{S}_{\text{and}}^W + \sum_{p \in \mathcal{S}_{\text{xor}}^W} p^\bullet $	[15]
$C_{\text{sep}}(W)$	$1 - \frac{ \{v \in P \cup T \mid v \text{ is a cut-vertex in } W\} }{ P + T -2}$	[3, p.122]
$C_{\text{acd}}(W)$	$\frac{1}{ C^W } \cdot \sum_{x \in C^W} (\bullet x + x^\bullet)$	[3, p.120]
$C_{\text{mcd}}(W)$	$\max\{(\bullet x + x^\bullet) \mid x \in C^W\}$	[3, p.121]
$C_{\text{seq}}(W)$	$1 - \frac{1}{ F } \cdot \{(x, y) \in F \mid x, y \notin C^W\} $	[3, p.123]
$C_{\text{depth}}(W)$	$\max\{\min\{\lambda_W(v), \lambda_{\overline{W}}(v)\} \mid v \in P \cup T\}$	[3, p.124]
$C_{\text{diam}}(W)$	$\max\{ k \mid v_1, \dots, v_k \text{ is a simple path from } p_i \text{ to } p_o\}$	[3, p.119]
$C_{\text{cyc}}(W)$	$\frac{1}{ P + T -2} \cdot \{x \in P \cup T \mid x \text{ lies on a cycle in } W\} $	[3, p.127]
$C_{\text{CNC}}(W)$	$\frac{ F }{ P + T }$	[3, p.120]
$C_{\text{dens}}(W)$	$\frac{ F }{2 \cdot T \cdot (P -1)}$	[3, p.120]
$C_{\text{dup}}(W)$	$\sum_{a \in A} (\max(\{t \in T \mid \ell(t) = a\} , 1) - 1)$	[16]
$C_\emptyset(W)$	$ \{p \in P \mid \bullet p \subseteq \mathcal{S}_{\text{and}}^N \wedge p^\bullet \subseteq \mathcal{J}_{\text{and}}^N\} $	[17]

complexity measures of this paper as $MoC := \{C_{\text{size}}, C_{\text{MM}}, C_{\text{CH}}, C_{\text{CC}}, C_{\text{ts}}, C_{\text{CFC}}, C_{\text{sep}}, C_{\text{acd}}, C_{\text{mcd}}, C_{\text{seq}}, C_{\text{depth}}, C_{\text{diam}}, C_{\text{cyc}}, C_{\text{CNC}}, C_{\text{dens}}, C_{\text{dup}}, C_\emptyset\}$. In

the next subsection, we will present the complexity measures for event logs that we use for our analyses.

3.2 Complexity of Event Logs

Let \mathcal{L} be the set of all event logs. Similar to model complexity measures, we define a log complexity measure as a function $\mathcal{C}^L : \mathcal{L} \rightarrow \mathbb{R}_0^+$. Thus, a log complexity measure assigns a non-negative, real-valued score to event logs. In this paper, we investigate the log complexity measures collected by Augusto et al. [10]. In the following, let L be an event log over a set of activities A .

- The **magnitude** [5] C_{mag} is the total number of events in the event log. In other words, the magnitude is the sum of trace-sizes in L , where duplicates are counted as well. Thus, we set $C_{\text{mag}} = \sum_{\sigma \in L} L(\sigma) \cdot |\sigma|$. For the event log L shown in Fig. 1, we have $C_{\text{mag}}(L) = 3 \cdot 50 + 4 \cdot 30 + 4 \cdot 20 = 350$.
- The **variety** [5] C_{var} is the number of distinct event names in an event log, so $C_{\text{var}}(L) = |\{a \in A \mid \exists \sigma \in L : \exists i \in \{1, \dots, |\sigma|\} : \sigma(i) = a\}|$. For the event log L shown in Fig. 1, we have $C_{\text{var}}(L) = |\{a, b, c, d\}| = 4$.
- The **length** [5] C_{len} is the number of traces in the event log, where duplicates are counted as well. Thus, $C_{\text{len}}(L) = \sum_{\sigma \in L} L(\sigma)$. Note that the original paper [5] and the paper by Augusto et al. [10] call this measure the **support** of an event log. To avoid confusion with the set of unique elements in a multiset, which we also call support, we renamed this measure to length. For the event log L shown in Fig. 1, we have $C_{\text{len}}(L) = 50 + 30 + 20 = 100$.
- The **minimum trace length** [10] $C_{\text{TL-min}}$ is the minimum length of a trace in the event log, $C_{\text{TL-min}}(L) = \min\{|\sigma| \mid \sigma \in L\}$. For the event log L shown in Fig. 1, we have $C_{\text{TL-min}}(L) = \min\{3, 4, 4\} = 3$.
- The **average trace length** [1] $C_{\text{TL-avg}}$ is the average length of the traces in the event log, $C_{\text{TL-avg}}(L) = \frac{\sum_{\sigma \in L} L(\sigma) \cdot |\sigma|}{\sum_{\sigma \in L} L(\sigma)}$. For the event log L shown in Fig. 1, we have $C_{\text{TL-avg}}(L) = \frac{50 \cdot 3 + 30 \cdot 4 + 20 \cdot 4}{50 + 30 + 20} = \frac{350}{100} = 3.5$.
- The **maximum trace length** [10] $C_{\text{TL-max}}$ is the maximum length of a trace in the event logs, $C_{\text{TL-max}}(L) = \max\{|\sigma| \mid \sigma \in L\}$. For the event log L shown in Fig. 1, we have $C_{\text{TL-max}}(L) = \max\{3, 4, 4\} = 4$.
- The **level of detail** [10] C_{LOD} is the amount of distinct simple paths in the DFG of L , so $C_{\text{LOD}}(L) = |\{p \mid p \text{ is a simple DFG-path from } \triangleright \text{ to } \square\}|$. Note that Günther [5] defines the level of detail as the average amount of distinct event names per trace. We use the definition for the level of detail of Augusto et al. [10], because their work is more recent and the work of Günther contains no complexity measures that counts the amount of distinct simple paths in the directly follows graph of L . For the event log L shown in Fig. 1, we get the directly follows graph G shown in Fig. 2. This directly follows graph contains 6 distinct simple paths from \triangleright to \square : $(\triangleright, a, c, \square)$, $(\triangleright, a, b, c, \square)$, $(\triangleright, a, b, d, \square)$, $(\triangleright, a, c, d, \square)$, $(\triangleright, a, b, c, d, \square)$, and $(\triangleright, a, c, b, d, \square)$. Thus, $C_{\text{LOD}}(L) = 6$ for this example.

- The **number of ties** [1] $C_{t\text{-comp}}$ is the amount of activity-pairs (a, b) , such that a is followed by b in some traces, but b is never followed by a in any trace. With the notation of Definition 3, we define this complexity measures as $C_{t\text{-comp}}(L) = |\{(a, b) \mid a >_L b \wedge b \not>_L a\}|$. For the event log L shown in Fig. 1, we have $C_{t\text{-comp}}(L) = |\{(a, b), (a, c), (b, d), (c, d)\}| = 4$.
- The **Lempel-Ziv complexity** [18] C_{LZ} is based on the complexity measure LZ for finite sequences, proposed by Lempel and Ziv [11]. This measure understands the event log as a single sequence by concatenating all traces and calculating the Lempel-Ziv complexity. This is essentially the number of distinct prefixes found while scanning through the sequence from left to right. With this, $C_{LZ}(L) = LZ(\prod_{\sigma \in L} \sigma^{L(\sigma)})$. For an example, consider the event log $L = [\langle a, b, c \rangle^2, \langle a, b, c, d \rangle, \langle a, c, b, d \rangle]$, where only the trace $\langle a, b, c \rangle$ occurs more than once in L . We turn this event log into the finite sequence $abcabcabdacbd$ and compute its Lempel-Ziv complexity. We find the unique prefixes $a, b, c, d, ab, ac, bc, bd$, and ca , so $C_{LZ}(L) = 9$.
- The **number of distinct traces** [1] $C_{DT\text{-}\#}$ is the amount of traces in the support of the event log, $C_{DT\text{-}\#}(L) = |supp(L)|$. For the event log L shown in Fig. 1, we have $C_{DT\text{-}\#}(L) = |\{\langle a, b, c \rangle, \langle a, b, c, d \rangle, \langle a, c, b, d \rangle\}| = 3$.
- The **percentage of distinct traces** [10] $C_{DT\text{-}\%}$ is the amount of traces in the support of the event log, divided by the total amount of traces in the event log, duplicates included. More formally, $C_{DT\text{-}\%}(L) = \frac{|supp(L)|}{\sum_{\sigma \in L} L(\sigma)}$. For the event log L shown in Fig. 1, we have $C_{DT\text{-}\%}(L) = \frac{3}{100} = 0.03$.
- The **structure** [10] C_{struct} is the average amount of distinct events per trace, $C_{struct}(L) = \frac{\sum_{\sigma \in L} L(\sigma) \cdot |\{a \in A \mid \exists i \in \{1, \dots, |\sigma|\} : \sigma(i) = a\}|}{\sum_{\sigma \in L} L(\sigma)}$. Note that Günther [5] calls this measure level of detail instead of structure. For Günther, the structure of an event log is the number of directly follows relations divided by the maximum number of possible directly follows relations. Since we have a similar measure with $C_{t\text{-comp}}$ and the work of Augusto et al. is more recent, we use their definition of the structure of an event log. For the event log L shown in Fig. 1, we have $C_{struct}(L) = \frac{50 \cdot 3 + 30 \cdot 4 + 20 \cdot 4}{350} = 1$.
- The **average affinity** [5] $C_{affinity}$ is the average amount of neighborhoods two traces of the event log have in common. For a trace $\sigma \in L$, we define $F(\sigma) = \{(a, b) \mid \exists i \in \{1, \dots, |\sigma| - 1\} : \sigma(i) = a \wedge \sigma(i + 1) = b\}$ as the set of direct neighborhoods in σ . Then, the affinity between two traces $\sigma_1, \sigma_2 \in L$ is defined as $A(\sigma_1, \sigma_2) = \frac{|F(\sigma_1) \cap F(\sigma_2)|}{|F(\sigma_1) \cup F(\sigma_2)|}$. For the average affinity, we do not compare the affinity of a trace to itself, as this would yield 1. However, we do compare the affinity of a trace σ with all other traces, even if they are copies of σ . Thus, $C_{affinity}(L) = \frac{\sum_{\sigma_1 \in L} \sum_{\sigma_2 \in (L - \{\sigma_1\})} A(\sigma_1, \sigma_2)}{(\sum_{\sigma \in L} L(\sigma)) \cdot ((\sum_{\sigma \in L} L(\sigma)) - 1)}$. For the event log L shown in Fig. 1, $A(\langle a, b, c \rangle, \langle a, b, c, d \rangle) = \frac{3}{4}$, $A(\langle a, b, c \rangle, \langle a, c, b, d \rangle) = \frac{0}{5}$, and $A(\langle a, b, c, d \rangle, \langle a, c, b, d \rangle) = \frac{0}{6}$. Thus, for the average affinity score, we get $C_{affinity}(L) = \frac{50 \cdot (49 \cdot 1 + 30 \cdot \frac{3}{4}) + 30 \cdot (50 \cdot \frac{3}{4} + 29 \cdot 1) + 20 \cdot (19 \cdot 1)}{100 \cdot 99} = \frac{5950}{9900} = 0.601$.
- The **deviation from random** [18] $C_{dev\text{-}R}$ is an indicator for how far the event log deviates from a completely random log, where all possible neighbor-

hoods occur equally often. To define this measure, we start by defining the amount of total neighborhood-relations in L as $n_{\rightarrow}(L) = \sum_{\sigma \in L} (|\sigma| - 1)$. For activities a_1, a_2 and a trace σ , $n_{\rightarrow}^{(a_1, a_2)}(\sigma) = |\{i \mid \sigma(i) = a_1 \wedge \sigma(i+1) = a_2\}|$ denotes the number of times a_1 is directly followed by a_2 in σ . This definition can be straightforwardly extended to the event log L by setting $n_{\rightarrow}^{(a_1, a_2)}(L) = \sum_{\sigma \in L} L(\sigma) \cdot n_{\rightarrow}^{(a_1, a_2)}(\sigma)$. Now, the deviation from random of

L is $C_{\text{dev-R}}(L) = 1 - \sqrt{\sum_{(a_1, a_2) \in A \times A} \left(\frac{n_{\rightarrow}^{(a_1, a_2)}(L) - \frac{n_{\rightarrow}(L)}{|A|^2}}{n_{\rightarrow}(L)} \right)^2}$. For the event

log L shown in Fig. 1, we have $n_{\rightarrow}(L) = 250$, $n_{\rightarrow}^{(a, b)}(L) = n_{\rightarrow}^{(b, c)}(L) = 80$, $n_{\rightarrow}^{(a, c)}(L) = n_{\rightarrow}^{(b, d)}(L) = n_{\rightarrow}^{(c, b)}(L) = 20$, and $n_{\rightarrow}^{(c, d)}(L) = 30$. All other activity-pairs receive the value 0. In turn, we get the following complexity score for L :

$$C_{\text{dev-R}}(L) = 1 - \sqrt{2 \cdot \left(\frac{80 - \frac{250}{64}}{250} \right)^2 + 3 \cdot \left(\frac{20 - \frac{250}{64}}{250} \right)^2 + \left(\frac{30 - \frac{250}{64}}{250} \right)^2} \approx 0.5433$$

- The **average edit-distance** [18] $C_{\text{avg-dist}}$ is the average amount of insert- and delete-operations needed to transform one trace into another. More general, the edit distance $ED(v, w)$ between two words v and w is the amount of insert- and delete-operations needed to transform v into w . There are variants where a replace-operation is allowed as well. Since every replace-operation can be simulated by a delete-operation, followed by an insert-operation, we do not consider this alternative and define the average edit distance of the event log L as $C_{\text{avg-dist}}(L) = \frac{\sum_{\sigma_1 \in L} \sum_{\sigma_2 \in L - [\sigma_1]} ED(\sigma_1, \sigma_2)}{\left(\sum_{\sigma \in L} L(\sigma) \right) \cdot \left(\left(\sum_{\sigma \in L} L(\sigma) \right) - 1 \right)}$. For the event log L shown in Fig. 1, we have $ED(\langle a, b, c \rangle, \langle a, b, c, d \rangle) = 1$, $ED(\langle a, b, c \rangle, \langle a, c, b, d \rangle) = 3$, and $ED(\langle a, b, c, d \rangle, \langle a, c, b, d \rangle) = 2$. Thus, we get $C_{\text{avg-dist}}(L) = \frac{50 \cdot (30 \cdot 1 + 20 \cdot 3) + 30 \cdot (50 \cdot 1 + 20 \cdot 2) + 20 \cdot (50 \cdot 3 + 30 \cdot 2)}{100 \cdot 99} = \frac{11400}{9900} = 1.15$.
- The **variant-entropy** [10] $C_{\text{var-e}}$ is based on the prefix automaton originally constructed for precision-estimation by Muñoz-Gama et al. [12]. The prefix automaton is a graph that contains all prefixes of traces in L . Each node representing a prefix in the event log receives a weight corresponding to how often there is a trace with the prefix in the event log. Two prefixes are connected by an edge with label a in the automaton if adding a to the end of the prefix in the source-node leads to the prefix in the target node. Fig. 3 shows an example for the event log L shown in Fig. 1. To

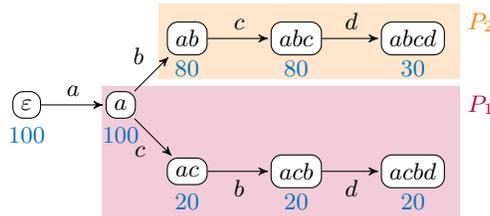


Fig. 3. The prefix automaton for the event log L of Fig. 1 with partitions P_1, P_2 .

calculate the variant entropy, we first take the set of nodes in the prefix automaton that are not labeled ε and call it S . In the example above, we have $S = \{a, ab, ac, abc, acb, abcd, acbd\}$. Then, for a partition P_1, \dots, P_n of the graph defined by the extended prefix automaton, we calculate the variant entropy as $C_{\text{var-e}}(L) = |S| \cdot \ln(|S|) - \sum_{i=1}^n (|P_i| \cdot \ln(|P_i|))$. In the example above, we would get $C_{\text{var-e}}(L) = 7 \cdot \ln(7) - 4 \cdot \ln(4) - 3 \cdot \ln(3) \approx 4.7804$.

- The **normalized variant-entropy** [10] $C_{\text{nvar-e}}$ follows the same ideas as its non-normalized counterpart, but makes sure that the returned scores lie between 0 and 1, so two entropy values are easier to compare to each other. Formally, with the notions as defined for the variant entropy, we have
$$C_{\text{nvar-e}}(L) = \frac{|S| \cdot \ln(|S|) - \sum_{i=1}^n (|P_i| \cdot \ln(|P_i|))}{|S| \cdot \ln(|S|)}$$
. For the event log L shown in Fig. 1, we would get $C_{\text{nvar-e}}(L) = \frac{7 \cdot \ln(7) - 4 \cdot \ln(4) - 3 \cdot \ln(3)}{7 \cdot \ln(7)} \approx 0.3509$.
- The **sequence-entropy** [10] $C_{\text{seq-e}}$ works similar as the variant entropy, but also uses the information about frequencies of traces in the event log L . To do so, this measure assigns a weight $w(s)$ to each state s in the prefix automaton, which corresponds to the amount of traces having the word represented by the state as a prefix. In Fig. 3, these weights are indicated as blue numbers below their states. For the set of states S in the prefix automaton that are not labeled ε , we set $W = \sum_{s \in S} w(s)$. For a partition P_i of the prefix automaton, we set $W_i = \sum_{p \in P_i} w(p)$. Then, for n partitions P_1, \dots, P_n of the prefix automaton, the sequence entropy of the event log is $C_{\text{seq-e}}(L) = W \cdot \ln(W) - \sum_{i=1}^n W_i \cdot \ln(W_i)$. For the event log L of Fig. 1, we use the same prefix automaton as shown in Fig. 3 and get the complexity score $C_{\text{seq-e}}(L) = 350 \cdot \ln(350) - 160 \cdot \ln(160) - 190 \cdot \ln(190) \approx 241.3142$.
- The **normalized sequence-entropy** [10] $C_{\text{nseq-e}}$ is the normalized variant of the sequence-entropy,
$$C_{\text{nseq-e}} = \frac{W \cdot \ln(W) - \sum_{i=1}^n W_i \cdot \ln(W_i)}{W \cdot \ln(W)}$$
. For the event log L shown in Fig. 1, $C_{\text{nseq-e}}(L) = \frac{350 \cdot \ln(350) - 160 \cdot \ln(160) - 190 \cdot \ln(190)}{350 \cdot \ln(350)} \approx 0.1177$.

Like before, Table 2 reports the formal definitions of the log complexity measures we will analyze in this paper. We define the set of all inspected log complexity measures as $LoC := \{C_{\text{mag}}, C_{\text{var}}, C_{\text{len}}, C_{\text{TL-avg}}, C_{\text{TL-max}}, C_{\text{LOD}}, C_{\text{t-comp}}, C_{\text{LZ}}, C_{\text{DT-#}}, C_{\text{DT-\%}}, C_{\text{struct}}, C_{\text{affinity}}, C_{\text{dev-R}}, C_{\text{avg-dist}}, C_{\text{var-e}}, C_{\text{nvar-e}}, C_{\text{seq-e}}, C_{\text{nseq-e}}\}$. Note that the log complexity measure $C_{\text{TL-min}}$ is not part of this set. An explanation for this will follow in the next section. We are now ready to dive into the analyses of the relationships between log- and model complexity. While computing the log complexity scores, we use the **Python**-implementation of Vidgof [19] to avoid calculation errors. Since this implementation does not provide functions for calculating $C_{\text{t-comp}}$, C_{LOD} , and $C_{\text{avg-dist}}$, as defined in [10], we added functions for these log complexity measures to the implementation.

Table 2. The complexity measures for event logs we investigate in this paper.

Measure	Definition	Reference
$C_{\text{mag}}(L)$	$\sum_{\sigma \in L} L(\sigma) \cdot \sigma $	[5, p.52]
$C_{\text{var}}(L)$	$ \{a \in A \mid \exists \sigma \in L : \exists i \in \{1, \dots, \sigma \} : \sigma(i) = a\} $	[5, p.53]
$C_{\text{len}}(L)$	$\sum_{\sigma \in L} L(\sigma)$	[5, 53]
$C_{\text{TL-min}}(L)$	$\min\{ \sigma \mid \sigma \in L\}$	[10]
$C_{\text{TL-avg}}(L)$	$\frac{\sum_{\sigma \in L} L(\sigma) \cdot \sigma }{\sum_{\sigma \in L} L(\sigma)}$	[1, p.365]
$C_{\text{TL-max}}(L)$	$\max\{ \sigma \mid \sigma \in L\}$	[10]
$C_{\text{LOD}}(L)$	$ \{p \mid p \text{ is a simple DFG-path from } \triangleright \text{ to } \square\} $	[10]
$C_{\text{t-comp}}(L)$	$ \{(a, b) \mid a >_L b \wedge b \not\prec_L a\} $	[1, p.366]
$C_{\text{LZ}}(L)$	$LZ(\prod_{\sigma \in L} \sigma^{L(\sigma)})$	[18]
$C_{\text{DT-}\#}(L)$	$ \text{supp}(L) $	[1, p.366]
$C_{\text{DT-}\%}(L)$	$\frac{ \text{supp}(L) }{\sum_{\sigma \in L} L(\sigma)}$	[10]
$C_{\text{struct}}(L)$	$\frac{\sum_{\sigma \in L} L(\sigma) \cdot \{a \in A \mid \exists i \in \{1, \dots, \sigma \} : \sigma(i) = a\} }{\sum_{\sigma \in L} L(\sigma)}$	[10]
$C_{\text{affinity}}(L)$	$\frac{\sum_{\sigma_1 \in L} \sum_{\sigma_2 \in (L - [\sigma_1])} A(\sigma_1, \sigma_2)}{(\sum_{\sigma \in L} L(\sigma)) \cdot ((\sum_{\sigma \in L} L(\sigma)) - 1)}$	[5, p.55]
$C_{\text{dev-R}}(L)$	$1 - \sqrt{\sum_{(a_1, a_2) \in A \times A} \left(\frac{\binom{n \rightarrow (a_1, a_2)}{L} - \frac{n \rightarrow (L)}{ A ^2}}{n \rightarrow (L)} \right)^2}$	[18]
$C_{\text{avg-dist}}(L)$	$\frac{\sum_{\sigma_1 \in L} \sum_{\sigma_2 \in L - [\sigma_1]} ED(\sigma_1, \sigma_2)}{(\sum_{\sigma \in L} L(\sigma)) \cdot ((\sum_{\sigma \in L} L(\sigma)) - 1)}$	[18]
$C_{\text{var-e}}(L)$	$ S \cdot \ln(S) - \sum_{i=1}^n (P_i \cdot \ln(P_i))$	[10]
$C_{\text{nvar-e}}(L)$	$\frac{ S \cdot \ln(S) - \sum_{i=1}^n (P_i \cdot \ln(P_i))}{ S \cdot \ln(S)}$	[10]
$C_{\text{seq-e}}(L)$	$W \cdot \ln(W) - \sum_{i=1}^n W_i \cdot \ln(W_i)$	[10]
$C_{\text{nseq-e}}(L)$	$\frac{W \cdot \ln(W) - \sum_{i=1}^n W_i \cdot \ln(W_i)}{W \cdot \ln(W)}$	[10]

4 Relationship of Log- and Model Complexity

As event logs grow over time, they typically become more complex, as they contain more behavior of the system. Thus, we are interested in the question: For two event logs L_1, L_2 with $L_1 \sqsubset L_2$ and $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$, what can we say about the relation between $\mathcal{C}^M(M_1)$ and $\mathcal{C}^M(M_2)$, where M_1 is a model discovered for L_1 and M_2 is a model discovered for L_2 ? A first intuition is that the model complexity should increase as well, i.e. $\mathcal{C}^M(M_1) < \mathcal{C}^M(M_2)$. However, when the used discovery algorithm can filter out noise or infrequent behavior, this is not necessarily the case. With noise-filtering, it is possible that we would like the model complexity to stay unchanged or even lower in certain cases. We therefore need to be cautious which mining algorithms we investigate in our analyses. In this paper, we solve this issue by understanding noise-filtering as a preprocessing step and expect the event logs to contain no noise at all. Furthermore, we won't investigate the effects of changing the minimal trace length in the event log to model complexity, as $L_1 \sqsubset L_2$ directly implies $C_{\text{TL-min}}(L_1) \geq C_{\text{TL-min}}(L_2)$.

With these requirements, we would expect that $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ implies $\mathcal{C}^M(M_1) < \mathcal{C}^M(M_2)$. This section is therefore dedicated to find the relation $R \in \{<, \leq, =, \geq, >, X\}$, such that $(\mathcal{C}^L, \mathcal{C}^M) \in R$, where

$$\begin{aligned}
< &= \{(\mathcal{C}^L, \mathcal{C}^M) \mid \forall L_1, L_2 : \mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) \Rightarrow \mathcal{C}^M(M_1) < \mathcal{C}^M(M_2)\} \\
\leq &= \{(\mathcal{C}^L, \mathcal{C}^M) \mid \forall L_1, L_2 : \mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) \Rightarrow \mathcal{C}^M(M_1) \leq \mathcal{C}^M(M_2)\} \setminus (< \cup =) \\
= &= \{(\mathcal{C}^L, \mathcal{C}^M) \mid \forall L_1, L_2 : \mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) \Rightarrow \mathcal{C}^M(M_1) = \mathcal{C}^M(M_2)\} \\
\geq &= \{(\mathcal{C}^L, \mathcal{C}^M) \mid \forall L_1, L_2 : \mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) \Rightarrow \mathcal{C}^M(M_1) \geq \mathcal{C}^M(M_2)\} \setminus (> \cup =) \\
> &= \{(\mathcal{C}^L, \mathcal{C}^M) \mid \forall L_1, L_2 : \mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) \Rightarrow \mathcal{C}^M(M_1) > \mathcal{C}^M(M_2)\} \\
X &= (LoC \times MoC) \setminus (< \cup \leq \cup = \cup \geq \cup >)
\end{aligned}$$

In the remainder of this section, we will investigate which of these relations hold for five different discovery algorithms. To do so, in each subsection, we first fix the investigated mining algorithm and find general properties for them. For quick reference, we then report our findings in a table, before providing proofs for each entry in the table. Note that, in the PDF-version of this paper, the entries in the tables can be clicked to show their respective proof.

4.1 Flower Model

As a first baseline mining algorithm, we investigate the algorithm that always returns the flower model for an input event log. Thus, let L be an event log over a set of activities $A = \{a_1, a_2, \dots, a_n\}$. Then, the flower model is the net shown in Fig. 4, which allows for all behavior using only activities a_1, a_2, \dots, a_n . It is easy to see that the flower model is mostly affected by the amount of different activity names used in the underlying event log, C_{var} . We find that all other log complexity measures are unaffected by the amount of different activity names in the event log.

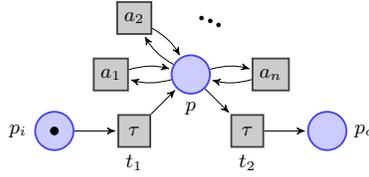


Fig. 4. The flower model for an event log L , using activities $A = \{a_1, a_2, \dots, a_n\}$.

Lemma 1. *Let $\mathcal{C}^L \in \text{LoC} \setminus \{C_{\text{var}}\}$ be a log complexity measure. Then, there are event logs L_1, L_2 with $L_1 \sqsubset L_2$ and $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$, but $C_{\text{var}}(L_1) = C_{\text{var}}(L_2)$.*

Proof. Consider the following event logs:

$$\begin{aligned} L_1 &= [\langle a, b, c, d \rangle^2, \langle a, b, c, d, e \rangle^2, \langle d, e, a, b \rangle^2] \\ L_2 &= L_1 + [\langle a, b, c, d, e \rangle^2, \langle d, e, a, b, c \rangle, \langle c, d, e, a, b \rangle, \langle e, c, d, a, b, c \rangle] \end{aligned}$$

These two event logs have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-\%}}$
L_1	26	5	6	4.3333	5	6	5	13	3	0.5
L_2	52	5	11	4.7273	6	23	7	21	6	0.5455

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	4.3333	0.56	0.5757	2.6667	6.1827	0.3126	16.0483	0.1894
L_2	4.6364	0.5829	0.6039	2.9091	29.0428	0.4543	60.0209	0.2921

Thus, all log complexity measures increased, except C_{var} , which is the same for L_1 and L_2 . Therefore, these event logs show the conjecture for every log complexity measure $\mathcal{C}^L \in \text{LoC} \setminus \{C_{\text{var}}\}$. \square

For two event logs L_1, L_2 and their flower models M_1, M_2 , we can conclude with Lemma 1 and the discussion above that M_1 and M_2 differ in their structure if and only if $C_{\text{var}}(L_1) \neq C_{\text{var}}(L_2)$. Furthermore, we can see that an increase in variety means that the flower model receives a new transition, thus increasing most model complexity scores for the flower model. If $L_1 \sqsubset L_2$, it is not possible that the model complexity scores of the flower model decrease.

Lemma 2. *Let L_1, L_2 be event logs with $L_1 \sqsubset L_2$. Let M_1, M_2 be the flower models for L_1 and L_2 . Then, $\mathcal{C}^M(M_1) \leq \mathcal{C}^M(M_2)$ for any model complexity measure $\mathcal{C}^M \in \{C_{\text{size}}, C_{\text{CC}}, C_{\text{CFC}}, C_{\text{sep}}, C_{\text{acd}}, C_{\text{mcd}}, C_{\text{seq}}, C_{\text{cyc}}, C_{\text{CNC}}\}$.*

Proof. Let L_1, L_2 be two event logs with $L_1 \sqsubset L_2$. Then, $C_{\text{var}}(L_1) \leq C_{\text{var}}(L_2)$, since every trace in L_1 must be part of L_2 , and thus, L_1 cannot contain any activity names that are not present in L_2 . With this observation, we prove $\mathcal{C}^M(M_1) \leq \mathcal{C}^M(M_2)$ for each of the model complexity measures separately.

- **Size** C_{size} : The flower model of an event log L has exactly 3 places and exactly $2 + C_{\text{var}}(L)$ transitions. Thus, we get

$$C_{\text{size}}(M_1) = 5 + C_{\text{var}}(L_1) \stackrel{C_{\text{var}}(L_1) \leq C_{\text{var}}(L_2)}{\leq} 5 + C_{\text{var}}(L_2) = C_{\text{size}}(M_2).$$

- **Cross Connectivity** C_{CC} : Let M be the flower model for an event log L and let $n := C_{\text{var}}(L)$. The only connector in the flower model is the place labeled p in Fig. 4. Thus, to calculate the cross connectivity of the flower model, this place receives weight $\frac{1}{2n+2}$, while all other nodes receive weight 1. With this, we can calculate that

$$C_{\text{CC}}(M) = \frac{4n^4 + 44n^3 + 143n^2 + 164n + 59}{4(n+1)^2(n+4)(n+5)}$$

which is monotonic increasing for increasing n , as

$$\begin{aligned} & \frac{d}{dn} \left(\frac{4n^4 + 44n^3 + 143n^2 + 164n + 59}{4(n+1)^2(n+4)(n+5)} \right) \\ &= \frac{389 + 729n + 575n^2 + 213n^3 + 26n^4}{4(1+n)^3(4+n)^2(5+n)^2} > 0. \end{aligned}$$

Thus, the cross connectivity of the flower model increases when the variety of the underlying event log does. Since $C_{\text{var}}(L_1) \leq C_{\text{var}}(L_2)$, we can therefore deduce that $C_{\text{CC}}(M_1) \leq C_{\text{CC}}(M_2)$.

- **Control Flow Complexity** C_{CFC} : The only connector in the flower model of an event log L is the place labeled p in Fig. 4. This place has $C_{\text{var}}(L) + 1$ outgoing edges, so we get

$$C_{\text{CFC}}(M_1) = C_{\text{var}}(L_1) + 1 \stackrel{C_{\text{var}}(L_1) \leq C_{\text{var}}(L_2)}{\leq} C_{\text{var}}(L_2) + 1 = C_{\text{CFC}}(M_2).$$

- **Separability** C_{sep} : The flower model M for an event log L has exactly three cut-vertices, labeled p , t_1 , and t_2 in Fig. 4. Since the flower model features $5 + C_{\text{var}}(L)$ nodes in total, we have

$$C_{\text{sep}}(M_1) = \frac{C_{\text{var}}(L_1)}{C_{\text{var}}(L_1) + 3} \stackrel{C_{\text{var}}(L_1) \leq C_{\text{var}}(L_2)}{\leq} \frac{C_{\text{var}}(L_2)}{C_{\text{var}}(L_2) + 3} = C_{\text{sep}}(M_2)$$

since, in general, $\frac{x}{y} \leq \frac{x+a}{y+a}$ for any $x, y, a \in \mathbb{R}^+$ with $x \leq y$.

- **Average Connector Degree** C_{acd} : The only connector in the flower model M for an event log L is the place labeled p in Fig. 4. This connector has $C_{\text{var}}(L) + 1$ incoming and $C_{\text{var}}(L) + 1$ outgoing edges, so

$$C_{\text{acd}}(M_1) = 2C_{\text{var}}(L_1) + 2 \stackrel{C_{\text{var}}(L_1) \leq C_{\text{var}}(L_2)}{\leq} 2C_{\text{var}}(L_2) + 2 = C_{\text{acd}}(M_2).$$

- **Maximum Connector Degree** C_{mcd} : The only connector in the flower model M for an event log L is the place labeled p in Fig. 4. This connector has $C_{\text{var}}(L) + 1$ incoming and $C_{\text{var}}(L) + 1$ outgoing edges, so

$$C_{\text{mcd}}(M_1) = 2C_{\text{var}}(L_1) + 2 \stackrel{C_{\text{var}}(L_1) \leq C_{\text{var}}(L_2)}{\leq} 2C_{\text{var}}(L_2) + 2 = C_{\text{mcd}}(M_2).$$

- **Sequentiality** C_{seq} : There are exactly 2 edges in the flower model between non-connector nodes: (p_i, t_1) and (t_2, p_o) . In total, the flower model contains $2 \cdot C_{\text{var}}(L) + 4$ edges, so

$$C_{\text{seq}}(M_1) = \frac{2 \cdot C_{\text{var}}(L_1) + 2}{2 \cdot C_{\text{var}}(L_1) + 4} \stackrel{C_{\text{var}}(L_1) \leq C_{\text{var}}(L_2)}{\leq} \frac{2 \cdot C_{\text{var}}(L_2) + 2}{2 \cdot C_{\text{var}}(L_2) + 4} = C_{\text{seq}}(M_2).$$

since, in general, $\frac{x}{y} \leq \frac{x+a}{y+a}$ for any $x, y, a \in \mathbb{R}^+$ with $x \leq y$.

- **Cyclicity** C_{cyc} : In the flower model M for an event log L , exactly $C_{\text{var}}(L) + 1$ nodes lie on a cycle. Since there are $5 + C_{\text{var}}(L)$ nodes in total, we have

$$C_{\text{cyc}}(M_1) = \frac{C_{\text{var}}(L_1) + 1}{C_{\text{var}}(L_1) + 3} \stackrel{C_{\text{var}}(L_1) \leq C_{\text{var}}(L_2)}{\leq} \frac{C_{\text{var}}(L_2) + 1}{C_{\text{var}}(L_2) + 3} = C_{\text{cyc}}(M_2)$$

since, in general, $\frac{x}{y} \leq \frac{x+a}{y+a}$ for any $x, y, a \in \mathbb{R}^+$ with $x \leq y$.

- **Coefficient of Network Connectivity** C_{CNC} : The flower model for an event log L has $2C_{\text{var}}(L) + 4$ edges and $5 + C_{\text{var}}(L)$ nodes. Therefore

$$C_{\text{CNC}}(M_1) = \frac{2C_{\text{var}}(L_1) + 4}{C_{\text{var}}(L_1) + 5} \stackrel{C_{\text{var}}(L_1) \leq C_{\text{var}}(L_2)}{\leq} \frac{2C_{\text{var}}(L_2) + 4}{C_{\text{var}}(L_2) + 5}$$

since, in general, $\frac{x}{y} \leq \frac{x+2a}{y+a}$ for any $x, y, a \in \mathbb{R}^+$ with $x \leq 2y$, which is true for $x = 2C_{\text{var}}(L_1) + 4$ and $y = 5 + C_{\text{var}}(L_1)$.

Thus, we showed that $\mathcal{C}^M(M_1) \leq \mathcal{C}^M(M_2)$ for any model complexity measure $\mathcal{C}^M \in \{C_{\text{size}}, C_{\text{CC}}, C_{\text{CFC}}, C_{\text{sep}}, C_{\text{acd}}, C_{\text{mcd}}, C_{\text{seq}}, C_{\text{cyc}}, C_{\text{CNC}}\}$. \square

Next to these monotonic increasing model complexity measures, there are also measures that always return the same complexity score for a flower model.

Lemma 3. *Let L_1, L_2 be event logs and M_1, M_2 be the flower models for L_1 and L_2 . Then, we have $\mathcal{C}^M(M_1) = \mathcal{C}^M(M_2)$ for any model complexity measure $\mathcal{C}^M \in \{C_{\text{MM}}, C_{\text{CH}}, C_{\text{ts}}, C_{\text{depth}}, C_{\text{diam}}, C_{\text{dens}}, C_{\text{dup}}, C_{\emptyset}\}$.*

Proof. Let L_1, L_2, M_1, M_2 and \mathcal{C}^M be defined as stated by the lemma. We prove $\mathcal{C}^M(M_1) = \mathcal{C}^M(M_2)$ for each of the model complexity measures separately.

- **Connector Mismatch** C_{MM} : The flower model M for an event log L has no connector mismatches: The place labeled p in Fig. 4 is the only connector in the flower model, and has $C_{\text{var}}(L) + 1$ incoming and outgoing edges. Therefore, we have $C_{\text{MM}}(M) = |(C_{\text{var}}(L) + 1) - (C_{\text{var}}(L) + 1)| = 0$ and thus $C_{\text{MM}}(M_1) = 0 = C_{\text{MM}}(M_2)$.
- **Connector Heterogeneity** C_{CH} : The flower model M for an event log L has only one connector, which is the place labeled p in Fig. 4. Thus, every flower model has only one type of connector, leading to the complexity score $C_{\text{CH}}(M) = 1 \cdot \log_2(1) + 0 \cdot \log_2(0) = 0$. Therefore, $C_{\text{CH}}(M_1) = 0 = C_{\text{CH}}(M_2)$.
- **Token Split** C_{ts} : All transitions in the flower model M for an event log have exactly one outgoing edge, so $C_{\text{ts}}(M) = 0$, and thus $C_{\text{ts}}(M_1) = 0 = C_{\text{ts}}(M_2)$.

- **Depth** C_{depth} : In the flower model M for an event log L , all nodes have depth 1 since a path from p_i or to p_o must always contain the connector p , which is a split node and a join node. Thus, $C_{\text{depth}}(M) = 1$ for any flower model M , so $C_{\text{depth}}(M_1) = 1 = C_{\text{depth}}(M_2)$.
- **Diameter** C_{diam} : The only simple path in the flower model M for an event log is (p_i, t_1, p, t_2, p_o) . Therefore, the longest simple path in M is always $C_{\text{depth}}(M) = 5$. In turn, we have $C_{\text{depth}}(M_1) = 5 = C_{\text{depth}}(M_2)$.
- **Density** C_{dens} : The flower model M for an event log L always has exactly $2C_{\text{var}}(L) + 4$ edges, 3 places, and $C_{\text{var}}(L) + 2$ transitions. Thus, its density score is $C_{\text{dens}}(M) = \frac{2(C_{\text{var}}(L)+2)}{2 \cdot (C_{\text{var}}(L)+2) \cdot (3-1)} = \frac{1}{2}$, so $C_{\text{dens}}(M_1) = \frac{1}{2} = C_{\text{dens}}(M_2)$.
- **Number of Duplicate Tasks** C_{dup} : The flower model M for an event log contains one transition for each activity in the event log, as well as two τ -transitions. Therefore, the only duplicate label in M is the second τ -label, leading to $C_{\text{dup}}(M) = 1$. In turn, $C_{\text{dup}}(M_1) = 1 = C_{\text{dup}}(M_2)$.
- **Number of Empty Sequence Flows** C_{\emptyset} : Since the flower model M for an event log contains no parallel splits or joins, there cannot be any empty sequence flows in the flower model. Therefore, $C_{\emptyset}(M) = 0$ for any flower model M , and thus $C_{\emptyset}(M_1) = 0 = C_{\emptyset}(M_2)$.

Thus, we showed that $\mathcal{C}^M(M_1) = \mathcal{C}^M(M_2)$ for any model complexity measure $\mathcal{C}^M \in \{C_{\text{MM}}, C_{\text{CH}}, C_{\text{ts}}, C_{\text{depth}}, C_{\text{diam}}, C_{\text{dens}}, C_{\text{dup}}, C_{\emptyset}\}$. \square

With these observations, we can now analyze the relations between log and model complexity for the flower model miner. We start by showing the results in Table 3 and prove the relations shown in the table afterwards. For quick

Table 3. The relations between the complexity scores of two flower-models M_1 and M_2 that were found for the event logs L_1 and L_2 respectively, where $L_1 \sqsubset L_2$ and the complexity of L_1 is lower than the complexity of L_2 .

	C_{size}	C_{MM}	C_{CH}	C_{CC}	C_{ts}	C_{CFC}	C_{sep}	C_{acd}	C_{mcd}	C_{seq}	C_{depth}	C_{diam}	C_{cyc}	C_{CNC}	C_{dens}	C_{dup}	C_{\emptyset}
C_{mag}	\leq	$=$	$=$	\leq	$=$	\leq	\leq	\leq	\leq	\leq	$=$	$=$	\leq	\leq	$=$	$=$	$=$
C_{var}	$<$	$=$	$=$	$<$	$=$	$<$	$<$	$<$	$<$	$<$	$=$	$=$	$<$	$<$	$=$	$=$	$=$
C_{len}	\leq	$=$	$=$	\leq	$=$	\leq	\leq	\leq	\leq	\leq	$=$	$=$	\leq	\leq	$=$	$=$	$=$
$C_{\text{TL-avg}}$	\leq	$=$	$=$	\leq	$=$	\leq	\leq	\leq	\leq	\leq	$=$	$=$	\leq	\leq	$=$	$=$	$=$
$C_{\text{TL-max}}$	\leq	$=$	$=$	\leq	$=$	\leq	\leq	\leq	\leq	\leq	$=$	$=$	\leq	\leq	$=$	$=$	$=$
C_{LOD}	\leq	$=$	$=$	\leq	$=$	\leq	\leq	\leq	\leq	\leq	$=$	$=$	\leq	\leq	$=$	$=$	$=$
$C_{\text{t-comp}}$	\leq	$=$	$=$	\leq	$=$	\leq	\leq	\leq	\leq	\leq	$=$	$=$	\leq	\leq	$=$	$=$	$=$
C_{LZ}	\leq	$=$	$=$	\leq	$=$	\leq	\leq	\leq	\leq	\leq	$=$	$=$	\leq	\leq	$=$	$=$	$=$
$C_{\text{DT-#}}$	\leq	$=$	$=$	\leq	$=$	\leq	\leq	\leq	\leq	\leq	$=$	$=$	\leq	\leq	$=$	$=$	$=$
$C_{\text{DT-}}$	\leq	$=$	$=$	\leq	$=$	\leq	\leq	\leq	\leq	\leq	$=$	$=$	\leq	\leq	$=$	$=$	$=$
C_{struct}	\leq	$=$	$=$	\leq	$=$	\leq	\leq	\leq	\leq	\leq	$=$	$=$	\leq	\leq	$=$	$=$	$=$
C_{affinity}	\leq	$=$	$=$	\leq	$=$	\leq	\leq	\leq	\leq	\leq	$=$	$=$	\leq	\leq	$=$	$=$	$=$
$C_{\text{dev-R}}$	\leq	$=$	$=$	\leq	$=$	\leq	\leq	\leq	\leq	\leq	$=$	$=$	\leq	\leq	$=$	$=$	$=$
$C_{\text{avg-dist}}$	\leq	$=$	$=$	\leq	$=$	\leq	\leq	\leq	\leq	\leq	$=$	$=$	\leq	\leq	$=$	$=$	$=$
$C_{\text{var-e}}$	\leq	$=$	$=$	\leq	$=$	\leq	\leq	\leq	\leq	\leq	$=$	$=$	\leq	\leq	$=$	$=$	$=$
$C_{\text{nvar-e}}$	\leq	$=$	$=$	\leq	$=$	\leq	\leq	\leq	\leq	\leq	$=$	$=$	\leq	\leq	$=$	$=$	$=$
$C_{\text{seq-e}}$	\leq	$=$	$=$	\leq	$=$	\leq	\leq	\leq	\leq	\leq	$=$	$=$	\leq	\leq	$=$	$=$	$=$
$C_{\text{nseq-e}}$	\leq	$=$	$=$	\leq	$=$	\leq	\leq	\leq	\leq	\leq	$=$	$=$	\leq	\leq	$=$	$=$	$=$

reference, the PDF-version of this paper allows to click on an entry to directly jump to its proof.

Theorem 1. *Let $\mathcal{C}^L \in (\text{LoC} \setminus \{C_{\text{var}}\})$ be any log complexity measure and let $\mathcal{C}^M \in \{C_{\text{size}}, C_{\text{CC}}, C_{\text{CFC}}, C_{\text{sep}}, C_{\text{acd}}, C_{\text{mcd}}, C_{\text{seq}}, C_{\text{cyc}}, C_{\text{CNC}}\}$ be a model complexity measure. Then, $(\mathcal{C}^L, \mathcal{C}^M) \in \leq$.*

Proof. By definition of \leq , we need to show that for all logs $L_1 \sqsubset L_2$ and their flower models M_1, M_2 , where $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$, we have $\mathcal{C}^M(M_1) < \mathcal{C}^M(M_2)$ or $\mathcal{C}^M(M_1) = \mathcal{C}^M(M_2)$, and that there are examples for both cases. By Lemma 2, we already know that $\mathcal{C}^M(M_1) \leq \mathcal{C}^M(M_2)$ because $L_1 \sqsubset L_2$. Furthermore, by Lemma 1, we know that there are cases where $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$, but with $C_{\text{var}}(L_1) = C_{\text{var}}(L_2)$ and therefore $\mathcal{C}^M(M_1) = \mathcal{C}^M(M_2)$, since M_1 and M_2 are the same model. To see that $\mathcal{C}^M(M_1) < \mathcal{C}^M(M_2)$ is also possible, consider the following event logs:

$$\begin{aligned} L_1 &= [\langle a \rangle^2, \langle a, b, c, d \rangle^3] \\ L_2 &= L_1 + [\langle e, a, b, c, d \rangle^2] \end{aligned}$$

These two event logs have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-}}$
L_1	14	4	5	2.8	4	2	3	8	2	0.4
L_2	24	5	7	3.4286	5	4	4	11	3	0.4286

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	2.8	0.4	0.4796	1.8	0	0	0	0
L_2	3.4286	0.4524	0.5169	1.9048	6.1827	0.3126	16.3006	0.2137

Thus, $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ for any log complexity measure $\mathcal{C}^L \in (\text{log} \setminus \{C_{\text{var}}\})$. The flower models for L_1 and L_2 are shown in Fig. 5. These models have the following

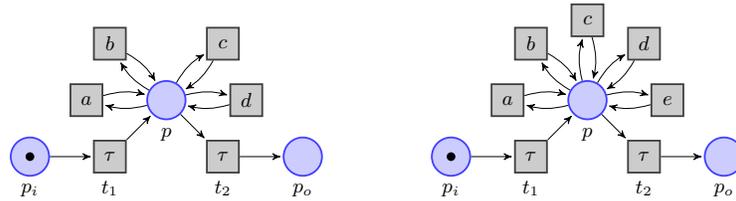


Fig. 5. The flower models for the logs L_1, L_2 of Theorem 1.

model complexity scores:

	C_{size}	C_{CC}	C_{CFC}	C_{sep}	C_{acd}	C_{mcd}	C_{seq}	C_{cyc}	C_{CNC}
L_1	9	0.9504	5	0.5714	10	10	0.8333	0.7143	1.3333
L_2	10	0.961	6	0.625	12	12	0.8571	0.75	1.4

Thus, $(\mathcal{C}^L, \mathcal{C}^M) \in \leq$ for any log complexity measure $\mathcal{C}^L \in (\text{LoC} \setminus \{C_{\text{var}}\})$ and a measure $\mathcal{C}^M \in \{C_{\text{size}}, C_{\text{CC}}, C_{\text{CFC}}, C_{\text{sep}}, C_{\text{acd}}, C_{\text{mcd}}, C_{\text{seq}}, C_{\text{cyc}}, C_{\text{CNC}}\}$ for model complexity, as stated in the theorem. \square

Theorem 2. *Let $\mathcal{C}^M \in \{C_{\text{size}}, C_{\text{CC}}, C_{\text{CFC}}, C_{\text{sep}}, C_{\text{acd}}, C_{\text{mcd}}, C_{\text{seq}}, C_{\text{cyc}}, C_{\text{CNC}}\}$ be a model complexity measure. Then, $(C_{\text{var}}, \mathcal{C}^M) \in <$.*

Proof. Let $L_1 \sqsubset L_2$ be event logs and M_1, M_2 be their flower models. Then, $C_{\text{var}}(L_1) < C_{\text{var}}(L_2)$ implies that there is a new activity name in L_2 that is not present in L_1 . In turn, M_2 contains a transition that does not exist in M_1 . Since, by Lemma 2, $\mathcal{C}^M(M_1) \leq \mathcal{C}^M(M_2)$, this means that $\mathcal{C}^M(M_1) < \mathcal{C}^M(M_2)$. \square

Theorem 3. *Let $\mathcal{C}^L \in \text{LoC}$ be any log complexity measure and let \mathcal{C}^M be a model complexity measure with $\mathcal{C}^M \in \{C_{\text{MM}}, C_{\text{CH}}, C_{\text{ts}}, C_{\text{depth}}, C_{\text{diam}}, C_{\text{dens}}, C_{\text{dup}}, C_{\emptyset}\}$. Then, $(\mathcal{C}^L, \mathcal{C}^M) \in =$.*

Proof. By Lemma 3, $\mathcal{C}^M(M_1) = \mathcal{C}^M(M_2)$ for any flower models M_1, M_2 . Therefore, the implication $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) \Rightarrow \mathcal{C}^M(M_1) = \mathcal{C}^M(M_2)$ is true for all event logs L_1, L_2 , where M_1, M_2 are the flower models for L_1, L_2 . \square

As Table 3 shows, the model complexity of the flower model is only dependent on the variety of the underlying event log. In the remainder of this subsection, we will go even further and characterize the model complexity scores of the flower model by using the variety of the event log. Note that some of the arguments we will show here already appeared in Lemma 2. In the following, let L be an event log over a set of activities A and M be the flower model for L .

- **Size C_{size} :** The flower model has exactly 3 places, labeled p_i, p_o and p in Fig. 4. Furthermore, it features two silent transitions, highlighted as t_1 and t_2 in the same figure. Every flower model has these 5 nodes, independent of the event log. Apart from them, it contains a transition for each activity name in the event log, so $C_{\text{size}}(M) = 5 + C_{\text{var}}(L)$.
- **Connector Mismatch C_{MM} :** The flower model has exactly one connector, labeled p in Fig. 4. This place has $|T| - 1$ incoming and $|T| - 1$ outgoing arcs, so $C_{\text{MM}}(M) = |(|T| - 1) - (|T| - 1)| = 0$.
- **Connector Heterogeneity C_{CH} :** The only connector of the flower model is the place labeled p in Fig. 4, which is an **xor**-connector. Since there are no other connectors in the flower model, there are also no **and**-connectors. Therefore, calculating the entropy of connector types in the flower model gives $C_{\text{CH}}(M) = -(1 \cdot \log_2(1) + 0 \cdot \log_2(0)) = 0$.
- **Cross Connectivity C_{CC} :** Let $n := C_{\text{var}}(L)$ be the variety of the event log L . Then, the place p receives weight $\frac{1}{2n+2}$, while all other nodes receive weight 1. After calculating the weights of the edges and paths between all nodes, we receive the values shown in Table 4. This table contains the entry 1 two times, the entry $\frac{1}{2n+2}$ exactly $2n + 4$ times, and the entry $\frac{1}{(2n+2)^2}$ a total of $n^2 + 4n + 5$ times. Thus, for the cross connectivity score, we get
$$C_{\text{CC}}(M) = 1 - \frac{2 + \frac{2n+4}{2n+2} + \frac{n^2+4n+5}{4n^2+8n+4}}{n^2+9n+20} = \frac{4n^4+44n^3+143n^2+164n+59}{4(n+1)^2(n+4)(n+5)}.$$

Table 4. The connection values of all node-pairs in a flower model.

	p_i	t_1	p	a_1	\dots	a_n	t_2	p_o
p_i	0	1	$\frac{1}{2n+2}$	$\frac{1}{(2n+2)^2}$	\dots	$\frac{1}{(2n+2)^2}$	$\frac{1}{(2n+2)^2}$	$\frac{1}{(2n+2)^2}$
t_1	0	0	$\frac{1}{2n+2}$	$\frac{1}{(2n+2)^2}$	\dots	$\frac{1}{(2n+2)^2}$	$\frac{1}{(2n+2)^2}$	$\frac{1}{(2n+2)^2}$
p	0	0	$\frac{1}{(2n+2)^2}$	$\frac{1}{2n+2}$	\dots	$\frac{1}{2n+2}$	$\frac{1}{2n+2}$	$\frac{1}{2n+2}$
a_1	0	0	$\frac{1}{2n+2}$	$\frac{1}{(2n+2)^2}$	\dots	$\frac{1}{(2n+2)^2}$	$\frac{1}{(2n+2)^2}$	$\frac{1}{(2n+2)^2}$
\vdots	\vdots	\vdots	\vdots	\vdots	\ddots	\vdots	\vdots	\vdots
a_n	0	0	$\frac{1}{2n+2}$	$\frac{1}{(2n+2)^2}$	\dots	$\frac{1}{(2n+2)^2}$	$\frac{1}{(2n+2)^2}$	$\frac{1}{(2n+2)^2}$
t_2	0	0	0	0	\dots	0	0	1
p_o	0	0	0	0	\dots	0	0	0

Table 5. The in- and out-depths of all nodes in the flower model.

Nodes	In-Depth	Out-Depth
p_i, t_1	0	1
p	0	0
a_1, \dots, a_n	1	1
p_o, t_2	1	0

- **Token Split C_{ts} :** By construction, every node in the flower model has exactly one incoming and one outgoing edge. Thus, there are no transitions with more than one outgoing edge and we get $C_{ts}(M) = 0$.
- **Control Flow Complexity C_{CFC} :** The place labeled p in Fig. 4 is the only connector node of the flower model. This place is an **xor**-connector with $|T| - 1$ outgoing edges. Since $|T| = C_{\text{var}}(L) + 2$, we get the control flow complexity score $C_{CFC}(M) = C_{\text{var}}(L) + 1$.
- **Separability C_{sep} :** The cut-vertices of the flower model are the nodes labeled t_1 , p , and t_2 in Fig. 4. Thus, we have exactly 3 cut-vertices in the flower model. Since there are $5 + C_{\text{var}}(L)$ nodes in total, we get the separability score $C_{\text{sep}}(M) = 1 - \frac{3}{5 + C_{\text{var}}(L) - 2} = \frac{C_{\text{var}}(L)}{3 + C_{\text{var}}(L)}$.
- **Average Connector Degree C_{acd} :** The place labeled p in Fig. 4 is the only connector of the flower model and has $|\bullet p| + |p \bullet| = |T| - 1 + |T| - 1 = 2|T| - 2$. Since $|T| = C_{\text{var}}(L) + 2$, we get $C_{\text{acd}}(M) = 2C_{\text{var}}(L) + 2$.
- **Maximum Connector Degree C_{mcd} :** The place labeled p in Fig. 4 is the only connector of the flower model and $|\bullet p| + |p \bullet| = |T| - 1 + |T| - 1 = 2|T| - 2$. Since $|T| = C_{\text{var}}(L) + 2$, we get $C_{\text{mcd}}(M) = 2C_{\text{var}}(L) + 2$.
- **Sequentiality C_{seq} :** In the flower model, only the edges $(p_i, t_1$ and (t_2, p_o) connect only non-connector nodes. In total, there are $2|T| = 2C_{\text{var}}(L) + 4$ edges, so we get $C_{\text{seq}}(M) = 1 - \frac{2}{2C_{\text{var}}(L) + 4} = \frac{2C_{\text{var}}(L) + 2}{2C_{\text{var}}(L) + 4} = \frac{C_{\text{var}}(L) + 1}{C_{\text{var}}(L) + 2}$.
- **Depth C_{depth} :** Let $A = \{a_1, \dots, a_n\}$ be the activity names that occur in L . Then, Table 5 shows the in- and out-depth of each node in the flower model. With this, we get $C_{\text{depth}}(M) = 1$.

- **Diameter** C_{diam} : The longest simple path through the flower model is the path (p_i, t_1, p, t_2, p_o) , so $C_{\text{diam}}(M) = 5$.
- **Cyclicity** C_{cyc} : With the labels shown in Fig. 4, only the nodes a_1, \dots, a_n , and p lie on a cycle in the flower model. Since the model has $5 + C_{\text{var}}(L)$ nodes in total, we get $C_{\text{cyc}}(M) = \frac{C_{\text{var}}(L)+1}{5+C_{\text{var}}(L)-2} = \frac{C_{\text{var}}(L)+1}{C_{\text{var}}(L)+3}$.
- **Coefficient of Network Connectivity** C_{CNC} : Since every transition in the flower model has exactly one incoming and one outgoing edge, it contains $2|T|$ edges in total. With $|T| = C_{\text{var}}(L) + 2$ and the fact that the flower model has $5 + C_{\text{var}}(L)$ nodes in total, we get $C_{\text{CNC}}(M) = \frac{2C_{\text{var}}(L)+4}{C_{\text{var}}(L)+5}$.
- **Density** C_{dens} : Since every transition in the flower model has exactly one incoming and one outgoing edge, it contains $2|T|$ edges in total. With $|P| = 3$ and $|T| = C_{\text{var}}(L) + 2$, we therefore get $C_{\text{dens}}(M) = \frac{2(C_{\text{var}}(L)+2)}{2 \cdot (C_{\text{var}}(L)+2) \cdot (3-1)} = \frac{1}{2}$.
- **Number of Duplicate Tasks** C_{dup} : The only label repetitions the flower model contains are the ones issued by the two silent transitions highlighted as t_1 and t_2 in Fig. 4. In turn, $C_{\text{dup}}(M) = 1$.
- **Number of Empty Sequence Flows** C_{\emptyset} : Since the flower model does not contain any and-connectors, $C_{\emptyset}(M) = 0$.

These findings conclude our analysis of the flower miner. Table 6 summarizes these findings for quick reference.

Table 6. The complexity scores of the flower model M for an event log L over A .

$C_{\text{size}}(M)$	$5 + C_{\text{var}}(L)$
$C_{\text{MM}}(M)$	0
$C_{\text{CH}}(M)$	0
$C_{\text{CC}}(M)$	$\frac{4C_{\text{var}}(L)^4 + 44C_{\text{var}}(L)^3 + 143C_{\text{var}}(L)^2 + 164C_{\text{var}}(L) + 59}{4(C_{\text{var}}(L)+1)^2(C_{\text{var}}(L)+4)(C_{\text{var}}(L)+5)}$
$C_{\text{ts}}(M)$	0
$C_{\text{CFC}}(M)$	$C_{\text{var}}(L) + 1$
$C_{\text{sep}}(M)$	$\frac{C_{\text{var}}(L)}{3+C_{\text{var}}(L)}$
$C_{\text{acd}}(M)$	$2C_{\text{var}}(L) + 2$
$C_{\text{mcd}}(M)$	$2C_{\text{var}}(L) + 2$
$C_{\text{seq}}(M)$	$\frac{C_{\text{var}}(L)+1}{C_{\text{var}}(L)+2}$
$C_{\text{depth}}(M)$	1
$C_{\text{diam}}(M)$	5
$C_{\text{cyc}}(M)$	$\frac{C_{\text{var}}(L)+1}{C_{\text{var}}(L)+3}$
$C_{\text{CNC}}(M)$	$\frac{2C_{\text{var}}(L)+4}{C_{\text{var}}(L)+5}$
$C_{\text{dens}}(M)$	$\frac{1}{2}$
$C_{\text{dup}}(M)$	1
$C_{\emptyset}(M)$	0

4.2 Trace Net

For a second baseline mining algorithm, we investigate the trace-net miner. This miner takes an event log L as input and outputs the trace net, where every trace of L corresponds to a unique path from an initial place p_i to a final place p_o . Fig. 6 shows the trace net for an event log L with $\text{supp}(L) = \{\sigma_1, \sigma_2, \dots, \sigma_n\}$. In contrast to the flower model investigated in the previous subsection, the com-

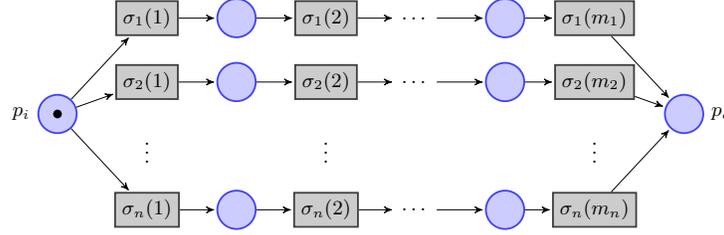


Fig. 6. The trace net for an event log L with $\text{supp}(L) = \{\sigma_1, \sigma_2, \dots, \sigma_n\}$, where $|\sigma_i| =: m_i$ for all $i \in \{1, \dots, n\}$.

plexity of the trace net does not depend on the variety C_{var} of the event log. Instead, the amount of distinct traces in the event log, $C_{\text{DT-}\#}$, plays an important role in most model complexity scores for the trace net. We will first observe that not all log complexity measures, an increase in log complexity means a change in the support of the event log. Furthermore, we assume that there are no empty traces in the event log.

Lemma 4. *Let \mathcal{C}^L be a log complexity measure with $\mathcal{C}^L \in \{C_{\text{mag}}, C_{\text{len}}, C_{\text{TL-avg}}, C_{\text{LZ}}, C_{\text{struct}}, C_{\text{affinity}}, C_{\text{dev-R}}, C_{\text{avg-dist}}, C_{\text{seq-e}}, C_{\text{nseq-e}}\}$. Then, there are event logs L_1, L_2 with $L_1 \sqsubset L_2$ and with $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$, but $\text{support}(L_1) = \text{support}(L_2)$.*

Proof. Consider the following event logs:

$$\begin{aligned} L_1 &= [\langle a, b, c \rangle, \langle a, b, c, d \rangle^2, \langle a, b, c, d, e \rangle^2, \langle d, e, a, b \rangle] \\ L_2 &= L_1 + [\langle a, b, c, d, e \rangle^3, \langle d, e, a, b \rangle^3] \end{aligned}$$

These two event logs have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-}\#}$	$C_{\text{DT-}\%}$
L_1	25	5	6	4.1667	5	8	5	11	4	0.6667
L_2	52	5	12	4.3333	5	8	5	20	4	0.3333

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	4.1667	0.5856	0.5517	2.0667	6.1827	0.3126	10.9917	0.1366
L_2	4.3333	0.5899	0.5743	2.5152	6.1827	0.3126	32.0966	0.1562

Thus, for all complexity measures \mathcal{C}^L allowed by this theorem, we have that $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$. Since, at the same time, $\text{support}(L_1) = \text{support}(L_2)$, these event logs prove the conjecture of this theorem. \square

The fact that the complexity of the trace net is not dependent on the variety C_{var} already shows that different mining algorithms require different log complexity measures to predict the complexity of their results. For our analysis of the trace net, we first observe that some of its model complexity scores must increase if more behavior is added to the underlying event log. To avoid edge cases or trace nets where some complexity measures are undefined, we require for this entire subsection that $|\text{supp}(L)| > 1$ for any event log L . We allow this restriction, as event logs with just a single trace rarely occur in practice.

Lemma 5. *Let L_1, L_2 be event logs with $L_1 \sqsubset L_2$ and $|\text{supp}(L_1)| > 1$. Let M_1, M_2 be the trace nets for L_1 and L_2 . Then, $\mathcal{C}^M(M_1) \leq \mathcal{C}^M(M_2)$ for any model complexity measure $\mathcal{C}^M \in \{C_{\text{size}}, C_{\text{CFC}}, C_{\text{acd}}, C_{\text{mcd}}, C_{\text{diam}}, C_{\text{dup}}\}$.*

Proof. Let L_1, L_2 be two event logs with $L_1 \sqsubset L_2$. With this, we then know that $\text{support}(L_1) \subseteq \text{support}(L_2)$, since every unique trace in L_1 must also be present in L_2 . We abbreviate this observation by (\star) , and prove $\mathcal{C}^M(M_1) \leq \mathcal{C}^M(M_2)$ for each of the model complexity measures separately.

- **Size C_{size} :** The trace net contains the places p_i and p_o , as well as a path of places and transitions for each trace of the event log. This means, in a trace net M for an event log L , there are $\sum_{\sigma \in L} |\sigma|$ transitions and $2 + \sum_{\sigma \in L} (|\sigma| - 1)$ places. Thus, $C_{\text{size}}(M) = 2 + \sum_{\sigma \in L} (2|\sigma| - 1)$. Since $\text{supp}(L_1) \subseteq \text{supp}(L_2)$, this means:

$$C_{\text{size}}(M_1) = 2 + \sum_{\sigma \in L_1} (2|\sigma| - 1) \stackrel{(\star)}{\leq} 2 + \sum_{\sigma \in L_2} (2|\sigma| - 1) = C_{\text{size}}(M_2).$$

- **Control Flow Complexity C_{CFC} :** The only connector nodes in the trace net are p_i and p_o . The node p_i is a **xor-split**, while p_o is a **xor-join**. In a trace net M for an event log L , p_i has $|\text{supp}(L)|$ outgoing edges, so we have $C_{\text{CFC}}(M) = |\text{supp}(L)|$, which means:

$$C_{\text{CFC}}(M_1) = |\text{supp}(L_1)| \stackrel{(\star)}{\leq} |\text{supp}(L_2)| = C_{\text{CFC}}(M_2).$$

- **Average Connector Degree C_{acd} :** The only connector nodes in the trace net are p_i and p_o . In a trace net M for an event log L , p_i and p_o both have degree $|\text{supp}(L)|$, so $C_{\text{acd}}(M) = \frac{1}{2} \cdot 2 \cdot |\text{supp}(L)| = |\text{supp}(L)|$, so we get:

$$C_{\text{acd}}(M_1) = |\text{supp}(L_1)| \stackrel{(\star)}{\leq} |\text{supp}(L_2)| = C_{\text{acd}}(M_2).$$

- **Maximum Connector Degree C_{mcd} :** The only connector nodes in the trace net are p_i and p_o . In a trace net M for an event log L , p_i and p_o both have degree $|\text{supp}(L)|$, so $C_{\text{mcd}}(M) = |\text{supp}(L)|$, leading to:

$$C_{\text{mcd}}(M_1) = |\text{supp}(L_1)| \stackrel{(\star)}{\leq} |\text{supp}(L_2)| = C_{\text{mcd}}(M_2).$$

- **Diameter** C_{diam} : In the trace net M for an event log L , every trace $\sigma \in L$ creates a unique path $(p_i, \sigma(1), \dots, \sigma(|\sigma|), p_o)$ of length $2 \cdot |\sigma| + 1$. Thus, the length of the longest path in M is $C_{\text{diam}}(M) = 2C_{\text{TL-max}}(L) + 1$. Since all traces in L_1 are also present in L_2 , this means:

$$C_{\text{diam}}(M_1) = 2C_{\text{TL-max}}(L_1) + 1 \stackrel{(*)}{\leq} 2C_{\text{TL-max}}(L_2) + 1 = C_{\text{diam}}(M_2).$$

- **Number of Duplicate Tasks** C_{dup} : The number of duplicate tasks in the trace net M for an event log L is exactly the amount of activity name repetitions in the support of the event log L . Since $\text{supp}(L_1) \subseteq \text{supp}(L_2)$, this amount of repetitions can only be higher in L_2 than in L_1 , so we get $C_{\text{dup}}(M_1) \leq C_{\text{dup}}(M_2)$.

Thus, we showed that $\mathcal{C}^M(M_1) \leq \mathcal{C}^M(M_2)$ for any model complexity measure $\mathcal{C}^M \in \{C_{\text{size}}, C_{\text{CFC}}, C_{\text{acc}}, C_{\text{mcd}}, C_{\text{diam}}, C_{\text{dup}}\}$. \square

Like for the flower model, there are some model complexity measures that always return the same value for a trace net. We will investigate these complexity measures in the next Lemma.

Lemma 6. *Let L_1, L_2 be event logs and M_1, M_2 be the trace nets for L_1 and L_2 . Then, $\mathcal{C}^M(M_1) = \mathcal{C}^M(M_2)$, where $\mathcal{C}^M \in \{C_{\text{MM}}, C_{\text{CH}}, C_{\text{ts}}, C_{\text{sep}}, C_{\text{depth}}, C_{\text{cyc}}, C_{\emptyset}\}$.*

Proof. Let L_1, L_2, M_1, M_2 and \mathcal{C}^M be defined as stated by the theorem. We prove $\mathcal{C}^M(M_1) = \mathcal{C}^M(M_2)$ for each of the model complexity measures separately:

- **Connector Mismatch** C_{MM} : The trace net M for an event log L contains exactly two connectors: p_i and p_o . p_i has exactly $|\text{supp}(L)|$ outgoing edges, and p_o has exactly $|\text{supp}(L)|$ incoming arcs, so its connector mismatch score is $C_{\text{MM}}(M) = ||\text{supp}(L)| - |\text{supp}(L)|| = 0$. Therefore, we have that $C_{\text{MM}}(M_1) = 0 = C_{\text{MM}}(M_2)$.
- **Connector Heterogeneity** C_{CH} : The trace net M for an event log L has only the connectors p_i and p_o . Both of these connectors are **xor**-connectors, so $C_{\text{CH}}(M) = -(1 \cdot \log_2(1) + 0 \cdot \log_2(0)) = 0$. In turn, we know that $C_{\text{CH}}(M_1) = 0 = C_{\text{CH}}(M_2)$.
- **Token Split** C_{ts} : Every transition in the trace net M for an event log L has exactly one incoming and one outgoing edge. Therefore, there are no transitions in M with more than one outgoing edge, leading to $C_{\text{ts}}(M) = 0$. Therefore, we get $C_{\text{ts}}(M_1) = 0 = C_{\text{ts}}(M_2)$.
- **Separability** C_{sep} : Since we require $|\text{supp}(L_1)| > 1$, we know that M_1 does not contain any cut-vertices. M_2 also does not contain any cut-vertices, as $|\text{supp}(L_2)| \geq |\text{supp}(L_1)| > 1$. Therefore, $C_{\text{sep}}(M_1) = 1 = C_{\text{sep}}(M_2)$.
- **Depth** C_{depth} : In the trace net M for an event log L , all nodes except p_i and p_o have in- and out-depth 1, since p_i and p_o are connectors. p_i and p_o themselves, on the other hand, both have in- and out-depth 0. Therefore, $C_{\text{depth}}(M) = 1$ and, consequently, $C_{\text{depth}}(M_1) = 1 = C_{\text{depth}}(M_2)$.
- **Cyclicity** C_{cyc} : The trace net M for an event log L does not contain any cycles, so $C_{\text{cyc}}(M) = 0$. In turn, $C_{\text{cyc}}(M_1) = 0 = C_{\text{cyc}}(M_2)$.

- **Number of Empty Sequence Flows C_\emptyset :** In the trace net M for an event log L , every transition has exactly one incoming and one outgoing edge. Therefore, there are no **and**-connectors in M , which means $C_\emptyset(M) = 0$. Consequently, $C_\emptyset(M_1) = 0 = C_\emptyset(M_2)$.

Thus, we showed that $\mathcal{C}^M(M_1) = \mathcal{C}^M(M_2)$ for any model complexity measure $\mathcal{C}^M \in \{C_{\text{MM}}, C_{\text{CH}}, C_{\text{ts}}, C_{\text{sep}}, C_{\text{depth}}, C_{\text{cyc}}, C_\emptyset\}$. \square

With these observations, we can now analyze the relations between log and model complexity for the trace net miner. We start by showing the results in Table 7 and prove the relations shown in the table afterwards. For quick navi-

Table 7. The relations between the complexity scores of two trace nets M_1 and M_2 that were found for the event logs L_1 and L_2 respectively, where $L_1 \sqsubset L_2$, $|supp(L_1)| > 1$, and the complexity of L_1 is lower than the complexity of L_2 .

	C_{size}	C_{MM}	C_{CH}	C_{CC}	C_{ts}	C_{CFC}	C_{sep}	C_{acd}	C_{mcd}	C_{seq}	C_{depth}	C_{diam}	C_{cyc}	C_{CNC}	C_{dens}	C_{dup}	C_\emptyset
C_{mag}	<	=	=	X*	=	<	=	<	<	X	=	<	=	X	>	<	=
C_{var}	<	=	=	X*	=	<	=	<	<	X	=	<	=	X	>	<	=
C_{len}	<	=	=	X*	=	<	=	<	<	X	=	<	=	X	>	<	=
$C_{\text{TL-avg}}$	<	=	=	X*	=	<	=	<	<	X	=	<	=	X	>	<	=
$C_{\text{TL-max}}$	<	=	=	X*	=	<	=	<	<	X	=	<	=	X	>	<	=
C_{LOD}	<	=	=	X*	=	<	=	<	<	X	=	<	=	X	>	<	=
$C_{\text{t-comp}}$	<	=	=	X*	=	<	=	<	<	X	=	<	=	X	>	<	=
C_{LZ}	<	=	=	X*	=	<	=	<	<	X	=	<	=	X	>	<	=
$C_{\text{DT-#}}$	<	=	=	X*	=	<	=	<	<	X	=	<	=	X	>	<	=
$C_{\text{DT-}}$	<	=	=	X*	=	<	=	<	<	X	=	<	=	X	>	<	=
C_{struct}	<	=	=	X*	=	<	=	<	<	X	=	<	=	X	>	<	=
C_{affinity}	<	=	=	X*	=	<	=	<	<	X	=	<	=	X	>	<	=
$C_{\text{dev-R}}$	<	=	=	X*	=	<	=	<	<	X	=	<	=	X	>	<	=
$C_{\text{avg-dist}}$	<	=	=	X*	=	<	=	<	<	X	=	<	=	X	>	<	=
$C_{\text{var-e}}$	<	=	=	X*	=	<	=	<	<	X	=	<	=	X	>	<	=
$C_{\text{nvar-e}}$	<	=	=	X*	=	<	=	<	<	X	=	<	=	X	>	<	=
$C_{\text{seq-e}}$	<	=	=	X*	=	<	=	<	<	X	=	<	=	X	>	<	=
$C_{\text{nseq-e}}$	<	=	=	X*	=	<	=	<	<	X	=	<	=	X	>	<	=

* We did not find examples showing that $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ and $C_{\text{CC}}(M_1) = C_{\text{CC}}(M_2)$ is possible.

gation, the PDF-version of this paper enables its readers to click on the entries of the table to jump to the proof of the respective property.

Theorem 4. $(\mathcal{C}^L, \mathcal{C}^M) \in \leq$ for any log complexity measure $\mathcal{C}^L \in \{C_{\text{mag}}, C_{\text{len}}, C_{\text{TL-avg}}, C_{\text{LZ}}, C_{\text{struct}}, C_{\text{affinity}}, C_{\text{dev-R}}, C_{\text{avg-dist}}, C_{\text{seq-e}}, C_{\text{nseq-e}}\}$ and a model complexity measure $\mathcal{C}^M \in \{C_{\text{size}}, C_{\text{CFC}}, C_{\text{acd}}, C_{\text{mcd}}\}$.

Proof. Let L_1, L_2 , be event logs with $L_1 \sqsubset L_2$ and $|supp(L_1)| > 1$, and M_1, M_2 be the trace nets for L_1 and L_2 . By Lemma 5, we know that $L_1 \sqsubset L_2$ and $|supp(L_1)| > 1$ implies $\mathcal{C}^M(M_1) \leq \mathcal{C}^M(M_2)$. We now need to show that both $\mathcal{C}^M(M_1) < \mathcal{C}^M(M_2)$ and $\mathcal{C}^M(M_1) = \mathcal{C}^M(M_2)$ are possible. For the former, take

the following event logs:

$$L_1 = [\langle a, b, c \rangle, \langle a, b, c, d \rangle^2, \langle a, b, c, d, e \rangle^2, \langle d, e, a, b \rangle]$$

$$L_2 = L_1 + [\langle a, b, c, d, e, f \rangle, \langle a, a, b, c, d, e, f \rangle, \langle a, b, c, d, e, a, b \rangle]$$

These two event logs have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-\%}}$
L_1	25	5	6	4.1667	5	8	5	11	4	0.6667
L_2	45	6	9	5	7	10	6	18	7	0.7778

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	4.1667	0.5856	0.5517	2.0667	6.1827	0.3126	10.9917	0.1366
L_2	4.6667	0.5872	0.5861	2.5556	23.5941	0.4535	38.233	0.2232

Thus, $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ for any of the log complexity measures allowed by this theorem. The trace nets for L_1 and L_2 are shown in Fig. 7. These models have

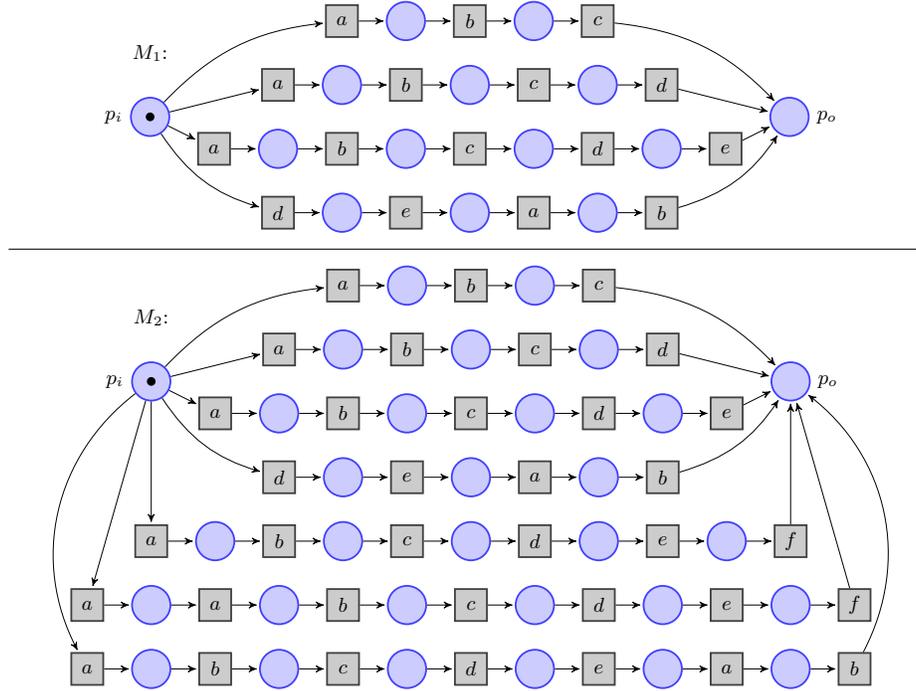


Fig. 7. The trace nets M_1, M_2 for the event logs L_1, L_2 of Theorem 4.

the following model complexity scores:

	C_{size}	C_{CFC}	C_{acd}	C_{mcd}
L_1	30	4	4	4
L_2	67	7	7	7

Thus, $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ and $\mathcal{C}^M(M_1) < \mathcal{C}^M(M_2)$. To see that $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ and $\mathcal{C}^M(M_1) = \mathcal{C}^M(M_2)$ are also possible, consider the example used in the proof of Lemma 4. Since both event logs have the same support, they have the same trace net, labeled M_1 in Fig. 7. Thus, the model complexity of the trace nets stay the same, even though the log complexity score increased from the first to the second event log. \square

Theorem 5. *Let $\mathcal{C}^M \in \{C_{size}, C_{CFC}, C_{acd}, C_{mcd}\}$ be a model complexity measure and let $\mathcal{C}^L \in \{C_{var}, C_{TL-max}, C_{LOD}, C_{t-comp}, C_{DT-\#}, C_{DT-\%}, C_{var-e}, C_{nvar-e}\}$ and be a log complexity measure. Then, $(\mathcal{C}^L, \mathcal{C}^M) \in <$.*

Proof. Let \mathcal{C}^L be a log complexity measure and \mathcal{C}^M a model complexity measure allowed by this theorem. Furthermore, let $L_1 \sqsubset L_2$ be event logs and M_1, M_2 their respective trace nets. In this proof, we first show that $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ implies $supp(L_1) \subsetneq supp(L_2)$ for all allowed log complexity measures.

- **Variety C_{var} :** Suppose $C_{var}(L_1) < C_{var}(L_2)$. Since $L_1 \sqsubset L_2$, we know that $supp(L_1) \subseteq supp(L_2)$. What remains to be shown is $supp(L_1) \neq supp(L_2)$. By definition of C_{var} , and since $C_{var}(L_1) < C_{var}(L_2)$, there must be an activity name a that occurs in L_2 , but not in L_1 . This is only possible if there is a trace σ , such that there is a $i \in \{1, \dots, |\sigma|\}$ with $\sigma(i) = a$, and such that $\sigma \in supp(L_2) \setminus supp(L_1)$. Thus, $supp(L_2) \setminus supp(L_1) \neq \emptyset$, and we get $supp(L_1) \neq supp(L_2)$.
- **Maximum Trace Length C_{TL-max} :** Suppose $C_{TL-max}(L_1) < C_{TL-max}(L_2)$. Since $L_1 \sqsubset L_2$, we know that $supp(L_1) \subseteq supp(L_2)$. What remains to be shown is $supp(L_1) \neq supp(L_2)$. Since the length of the longest trace in L_2 is longer than the length of the longest trace in L_1 , there must be a trace $\sigma \in supp(L_2) \setminus supp(L_1)$ with $|\sigma| > |\rho|$ for all $\rho \in L_1$. Thus, we know that $supp(L_2) \setminus supp(L_1) \neq \emptyset$, and therefore $supp(L_1) \neq supp(L_2)$.
- **Level of Detail C_{LOD} :** Suppose $C_{LOD}(L_1) < C_{LOD}(L_2)$. Since $L_1 \sqsubset L_2$, we know that $supp(L_1) \subseteq supp(L_2)$ is true. What remains to be shown is $supp(L_1) \neq supp(L_2)$. By definition of C_{LOD} , since $C_{LOD}(L_1) < C_{LOD}(L_2)$, the DFG of L_2 contains at least one path that is not present in the DFG of L_1 . But this is only possible if there is at least one edge (a, b) in the DFG of L_2 that is not part of the DFG of L_1 . By construction of the directly follows graph, this means $a >_{L_2} b$, but $a \not>_{L_1} b$. Thus, a $\sigma \in supp(L_2) \setminus supp(L_1)$ must exist with $\sigma(i) = a$ and $\sigma(i+1) = b$ for some $i \in \{1, \dots, |\sigma| - 1\}$. Therefore, $supp(L_2) \setminus supp(L_1) \neq \emptyset$, and we get that $supp(L_1) \neq supp(L_2)$.
- **Number of Ties C_{t-comp} :** Suppose that $C_{t-comp}(L_1) < C_{t-comp}(L_2)$. Since $L_1 \sqsubset L_2$, we know $supp(L_1) \subseteq supp(L_2)$. What remains to be shown is $supp(L_1) \neq supp(L_2)$. Since $C_{t-comp}(L_1) < C_{t-comp}(L_2)$, there are activity names a, b with $a >_{L_2} b$ but $a \not>_{L_1} b$ or $b >_{L_1} a$. Since adding behavior to an event log cannot remove any direct neighborhoods of activities, we know that $a \not>_{L_1}$ is true. Then, there must be a trace $\sigma \in supp(L_2) \setminus supp(L_1)$ with $\sigma(i) = a$ and $\sigma(i+1) = b$ for some $i \in \{1, \dots, |\sigma| - 1\}$. Therefore, $supp(L_2) \setminus supp(L_1) \neq \emptyset$, and we get $supp(L_1) \neq supp(L_2)$.

- **Number of Distinct Traces $C_{\text{DT-}\#}$:** Suppose $C_{\text{DT-}\#}(L_1) < C_{\text{DT-}\#}(L_2)$. Since $L_1 \sqsubset L_2$, we know $\text{supp}(L_1) \subseteq \text{supp}(L_2)$. What remains to be shown is $\text{supp}(L_1) \neq \text{supp}(L_2)$. Since $C_{\text{DT-}\#}(L_1) < C_{\text{DT-}\#}(L_2)$, we know by definition that $|\text{supp}(L_1)| < |\text{supp}(L_2)|$. Thus, $\text{supp}(L_1) \neq \text{supp}(L_2)$ must be true.
- **Percentage of Distinct Traces $C_{\text{DT-}\%}$:** Let $C_{\text{DT-}\%}(L_1) < C_{\text{DT-}\%}(L_2)$. Since $L_1 \sqsubset L_2$, we know $\text{supp}(L_1) \subseteq \text{supp}(L_2)$. What remains to be shown is $\text{supp}(L_1) \neq \text{supp}(L_2)$. Since $C_{\text{DT-}\%}(L_1) < C_{\text{DT-}\%}(L_2)$, we know by definition that $\frac{|\text{supp}(L_1)|}{\sum_{\sigma \in L_1} L_1(\sigma)} < \frac{|\text{supp}(L_2)|}{\sum_{\sigma \in L_2} L_2(\sigma)}$. But since $L_1 \sqsubset L_2$, we know that the inequality $\sum_{\sigma \in L_1} L_1(\sigma) < \sum_{\sigma \in L_2} L_2(\sigma)$ is true. Thus, the previous inequality can only be true if $|\text{supp}(L_1)| < |\text{supp}(L_2)|$, so $\text{supp}(L_1) \neq \text{supp}(L_2)$.
- **Variation Entropy $C_{\text{var-e}}$:** Suppose $C_{\text{var-e}}(L_1) < C_{\text{var-e}}(L_2)$. Since $L_1 \sqsubset L_2$, we know that $\text{supp}(L_1) \subseteq \text{supp}(L_2)$. What remains to be shown is that $\text{supp}(L_1) \neq \text{supp}(L_2)$. Since $C_{\text{var-e}}(L_1) < C_{\text{var-e}}(L_2)$, we know by definition that there must be a node in the prefix automaton of L_2 that is not present in the prefix automaton of L_1 . In turn, a trace $\sigma \in \text{supp}(L_2) \setminus \text{supp}(L_1)$ must exist that deviates from all traces in L_1 after a (possibly empty) common prefix. Since $\text{supp}(L_2) \setminus \text{supp}(L_1) \neq \emptyset$, $\text{supp}(L_1) \neq \text{supp}(L_2)$.
- **Normalized Variation Entropy $C_{\text{nvar-e}}$:** Since $|S| \cdot \ln(|S|)$ can only increase for larger event logs, $C_{\text{nvar-e}}(L_1) < C_{\text{nvar-e}}(L_2)$ directly implies that $C_{\text{var-e}}(L_1) < C_{\text{var-e}}(L_2)$. But as we have already seen, the latter implies $\text{supp}(L_1) \neq \text{supp}(L_2)$.

Since the trace net M for an event log L includes a unique path for each trace in $\text{supp}(L)$, we can quickly verify that $\mathcal{C}^M(M_1) < \mathcal{C}^M(M_2)$ if $\text{supp}(L_1) \neq \text{supp}(L_2)$, where $\mathcal{C}^M \in \{C_{\text{size}}, C_{\text{CFC}}, C_{\text{acd}}, C_{\text{mcd}}\}$. \square

Theorem 6. *Let $\mathcal{C}^L \in \text{LoC}$ be any log complexity measure and \mathcal{C}^M be a model complexity measure with $\mathcal{C}^M \in \{C_{\text{MM}}, C_{\text{CH}}, C_{\text{ts}}, C_{\text{sep}}, C_{\text{depth}}, C_{\text{cyc}}, C_{\emptyset}\}$. Then, we have $(\mathcal{C}^L, \mathcal{C}^M) \in =$.*

Proof. By Lemma 6, $\mathcal{C}^M(M_1) = \mathcal{C}^M(M_2)$ for any trace nets M_1, M_2 . Therefore, the implication $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) \Rightarrow \mathcal{C}^M(M_1) = \mathcal{C}^M(M_2)$ is true for all event logs L_1, L_2 , where M_1, M_2 are the trace nets for L_1, L_2 . \square

Theorem 7. *Let $\mathcal{C}^L \in \text{LoC}$ be a log complexity measure. Then, $(\mathcal{C}^L, C_{\text{CC}}) \in X$.*

Proof. Consider the following event logs:

$$\begin{aligned} L_1 &= [\langle a, b, c, d \rangle^2, \langle a, c, c, e \rangle^2, \langle a, a, a, a \rangle^2] \\ L_2 &= L_1 + [\langle a, a, b, c, c, d, e, f \rangle] \\ L_3 &= L_2 + [\langle g, a, a, b, c, c, d, e, f, a, a, b, c, c, d, e, f \rangle] \end{aligned}$$

Then, the trace nets M_1, M_2, M_3 for the event logs L_1, L_2, L_3 fulfill:

- $C_{\text{CC}}(M_1) \approx 0.8476$,
- $C_{\text{CC}}(M_2) \approx 0.8677$,
- $C_{\text{CC}}(M_3) \approx 0.8544$,

and therefore, $C_{CC}(M_1) < C_{CC}(M_2)$ and $C_{CC}(M_2) > C_{CC}(M_3)$. But the following table shows $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) < \mathcal{C}^L(L_3)$ for any $\mathcal{C}^L \in (LoC \setminus \{C_{nvar-e}\})$:

	C_{mag}	C_{var}	C_{len}	C_{TL-avg}	C_{TL-max}	C_{LOD}	C_{t-comp}	C_{LZ}	$C_{DT-#}$	$C_{DT-\%}$
L_1	24	5	6	4	4	5	5	12	3	0.5
L_2	32	6	7	4.5714	8	11	7	16	4	0.5714
L_3	49	7	8	6.125	17	22	9	23	5	0.625

	C_{struct}	$C_{affinity}$	C_{dev-R}	$C_{avg-dist}$	C_{var-e}	C_{nvar-e}	C_{seq-e}	C_{nseq-e}
L_1	2.6	0.2	0.619	4.2667	10.889	0.4729	24.9533	0.3272
L_2	3.1429	0.2079	0.6475	4.5714	21.474	0.4841	42.4367	0.3826
L_3	3.625	0.2219	0.6776	6.5357	44.3327	0.3842	74.0677	0.3884

For $\mathcal{C}^L = C_{nvar-e}$, we take the following event logs:

$$\begin{aligned} L_1 &= [\langle a \rangle, \langle a, b, c \rangle] \\ L_2 &= L_1 + [\langle a, b, c, d, e \rangle, \langle x, y, z \rangle] \\ L_3 &= L_2 + [\langle f, g, h, i, j, k, l, m, n, o, p \rangle] \end{aligned}$$

Then, the trace nets M_1, M_2, M_3 for the event logs L_1, L_2, L_3 fulfill:

- $C_{CC}(M_1) \approx 0.7098$,
- $C_{CC}(M_2) \approx 0.857$,
- $C_{CC}(M_3) \approx 0.8436$

and therefore, $C_{CC}(M_1) < C_{CC}(M_2)$ and $C_{CC}(M_2) > C_{CC}(M_3)$, even though

- $C_{nvar-e}(L_1) = 0$,
- $C_{nvar-e}(L_2) \approx 0.3181$,
- $C_{nvar-e}(L_3) \approx 0.3258$,

and therefore $C_{nvar-e}(L_1) < C_{nvar-e}(L_2) < C_{nvar-e}(L_3)$ is true. \square

Theorem 8. *Let $\mathcal{C}^L \in LoC$ be a log complexity measure. Then, $(\mathcal{C}^L, C_{seq}) \in \mathbf{X}$.*

Proof. Consider the following event logs:

$$\begin{aligned} L_1 &= [\langle a, b, c, d, e \rangle^3, \langle e, d, c, a, b \rangle^3] \\ L_2 &= L_1 + [\langle a, f, e, d, c, b \rangle^2] \\ L_3 &= L_2 + [\langle g, a, c, d, e, b, f \rangle^2, \langle a, b \rangle] \end{aligned}$$

Then, the trace nets M_1, M_2, M_3 for the event logs L_1, L_2, L_3 fulfill:

- $C_{seq}(M_1) = 0.2$,
- $C_{seq}(M_2) \approx 0.1875$,
- $C_{seq}(M_3) = 0.2$,

and so, $C_{seq}(M_1) > C_{seq}(M_2)$, $C_{seq}(M_2) < C_{seq}(M_3)$, and $C_{seq}(M_1) = C_{seq}(M_3)$. But the next table shows $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) < \mathcal{C}^L(L_3)$ for $\mathcal{C}^L \in (LoC \setminus \{C_{affinity}\})$:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-\%}}$
L_1	30	5	6	5	5	4	3	16	2	0.3333
L_2	42	6	8	5.25	6	7	4	21	3	0.375
L_3	58	7	11	5.2727	7	37	6	28	5	0.4545

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	5	0.4857	0.659	3.6	6.9315	0.301	20.7944	0.2038
L_2	5.25	0.3571	0.7031	4.0714	16.4792	0.4057	45.1709	0.2877
L_3	5.2727	0.2545	0.7395	4.5455	30.24	0.4447	78.9679	0.3353

For $\mathcal{C}^L = C_{\text{affinity}}$, we take the following event logs:

$$\begin{aligned} L_1 &= [\langle a, b, c, d, e \rangle^3, \langle e, d, c, a, b \rangle^3] \\ L_2 &= L_1 + [\langle f, e, d, c, a, b \rangle^2] \\ L_3 &= L_2 + [\langle g, f, e, d, c, a, b \rangle^5, \langle a, b \rangle] \end{aligned}$$

Then, the trace nets M_1, M_2, M_3 for the event logs L_1, L_2, L_3 fulfill:

- $C_{\text{seq}}(M_1) = 0.2$,
- $C_{\text{seq}}(M_2) \approx 0.1875$,
- $C_{\text{seq}}(M_3) = 0.2$,

and so, $C_{\text{seq}}(M_1) > C_{\text{seq}}(M_2)$, $C_{\text{seq}}(M_2) < C_{\text{seq}}(M_3)$, and $C_{\text{seq}}(M_1) = C_{\text{seq}}(M_3)$, even though the affinity scores strictly increase:

- $C_{\text{affinity}}(L_1) \approx 0.4857$,
- $C_{\text{affinity}}(L_2) \approx 0.4941$,
- $C_{\text{affinity}}(L_3) \approx 0.5117$,

and therefore $C_{\text{affinity}}(L_1) < C_{\text{affinity}}(L_2) < C_{\text{affinity}}(L_3)$ is true. \square

Theorem 9. Let $\mathcal{C}^L \in (\text{LoC} \setminus \{C_{\text{TL-max}}\})$ be a log complexity measure. Then, $(\mathcal{C}^L, C_{\text{diam}}) \in \leq$.

Proof. Let L_1, L_2 be event logs with $L_1 \sqsubset L_2$ and $|\text{supp}(L_1)| > 1$, and M_1, M_2 be the trace nets for L_1 and L_2 . By Lemma 5, we know that $L_1 \sqsubset L_2$ and $|\text{supp}(L_1)| > 1$ implies $C_{\text{diam}}(M_1) \leq C_{\text{diam}}(M_2)$. We now show that both $C_{\text{diam}}(M_1) = C_{\text{diam}}(M_2)$ and $C_{\text{diam}}(M_1) < C_{\text{diam}}(M_2)$ are possible. For the former, take the following event logs:

$$\begin{aligned} L_1 &= [\langle a, b, c, d \rangle^2, \langle a, b, c, d, e \rangle^2, \langle d, e, a, b \rangle^2] \\ L_2 &= L_1 + [\langle a, b, c, d, e \rangle^2, \langle d, e, a, b, c \rangle, \langle c, d, e, a, b \rangle, \langle f, c, d, a, b \rangle] \end{aligned}$$

These two event logs have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-\%}}$
L_1	26	5	6	4.3333	5	6	5	13	3	0.5
L_2	51	6	11	4.6364	5	20	7	21	6	0.5455

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	4.3333	0.56	0.5757	2.6667	6.1827	0.3126	16.0483	0.1894
L_2	4.6364	0.5626	0.5880	2.9818	27.7259	0.4628	57.7827	0.2882

Thus, $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ for any of the log complexity measures allowed by this theorem. But the trace nets M_1, M_2 for the event logs L_1, L_2 fulfill the property $C_{\text{diam}}(L_1) = 11 = C_{\text{diam}}(L_2)$.

To see that the diameter can also increase, take the following event logs:

$$\begin{aligned} L_1 &= [\langle a, b, c, d \rangle^2, \langle a, b, c, d, e \rangle^2, \langle d, e, a, b \rangle^2] \\ L_2 &= L_1 + [\langle a, b, c, d, e \rangle^2, \langle d, e, a, b, c \rangle, \langle c, d, e, a, b \rangle, \langle f, c, d, a, b, c \rangle] \end{aligned}$$

Note that L_1 did not change in contrast to the previous log with the same name, while in L_2 , the trace $\langle f, c, d, a, b \rangle$ became $\langle f, c, d, a, b, c \rangle$. These two event logs have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-}}$
L_1	26	5	6	4.3333	5	6	5	13	3	0.5
L_2	52	6	11	4.7273	6	20	7	21	6	0.5455

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	4.3333	0.56	0.5757	2.6667	6.1827	0.3126	16.0483	0.1894
L_2	4.6364	0.5829	0.5887	2.9091	29.0428	0.4543	60.0209	0.2921

Thus, $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ for any of the log complexity measures allowed by this theorem. But the trace nets M_1, M_2 for the event logs L_1, L_2 fulfill the property $C_{\text{diam}}(M_1) = 11 < 13 = C_{\text{diam}}(M_2)$. \square

Theorem 10. $(C_{\text{TL-max}}, C_{\text{dens}}) \in <$.

Proof. Let L_1, L_2 be event logs with $L_1 \sqsubset L_2$. Further, let M_1, M_2 be the trace nets for L_1, L_2 . Suppose $C_{\text{TL-max}}(L_1) < C_{\text{TL-max}}(L_2)$. Since the trace net contains a unique path from the start node to the end node for each trace, and no other paths from the start to the end node exist, all lengths of paths are dependent on the lengths of the traces they enable. Because we know that $C_{\text{TL-max}}(L_1) < C_{\text{TL-max}}(L_2)$, there is a trace $\sigma \in L_2$ with $|\sigma| > |\rho|$ for all $\rho \in L_1$. Thus, the length of the path for σ in M_2 is longer than any path in M_1 , which means $C_{\text{diam}}(M_1) < C_{\text{diam}}(M_2)$. \square

Theorem 11. $(\mathcal{C}^L, C_{\text{CNC}}) \in \mathbf{X}$ for any log complexity measure $\mathcal{C}^L \in \text{LoC}$.

Proof. Consider the following event logs:

$$\begin{aligned} L_1 &= [\langle a, b, c, d \rangle^2, \langle a, c, c, e \rangle^2, \langle a, a, a, a \rangle^2] \\ L_2 &= L_1 + [\langle a, a, b, c, c, d, e, f \rangle] \\ L_3 &= L_2 + [\langle g, a, a, b, c, c, d, e, f, a, a, b, c, c, d, f \rangle] \end{aligned}$$

Then, the trace nets M_1, M_2, M_3 for the event logs L_1, L_2, L_3 fulfill:

- $C_{\text{CNC}}(M_1) \approx 1.0435$,
- $C_{\text{CNC}}(M_2) \approx 1.0526$,
- $C_{\text{CNC}}(M_3) \approx 1.0435$,

so we can see that $C_{\text{CNC}}(M_1) < C_{\text{CNC}}(M_2)$, $C_{\text{CNC}}(M_2) > C_{\text{CNC}}(M_3)$, and $C_{\text{CNC}}(M_1) = C_{\text{CNC}}(M_3)$. But the next table shows $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) < \mathcal{C}^L(L_3)$ for any $\mathcal{C}^L \in (\text{LoC} \setminus \{C_{\text{nvar-e}}\})$:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-\%}}$
L_1	24	5	6	4	4	5	5	12	3	0.5
L_2	32	6	7	4.5714	8	11	7	16	4	0.5714
L_3	48	7	8	6	16	26	10	23	5	0.625

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	2.6667	0.2	0.619	4.2667	10.889	0.4729	24.9533	0.3272
L_2	3.1429	0.2079	0.6475	4.5714	21.474	0.4841	42.4367	0.3826
L_3	3.625	0.2154	0.6766	6.2857	43.6547	0.3936	72.9894	0.3928

For $\mathcal{C}^L = C_{\text{nvar-e}}$, we take the following event logs:

$$\begin{aligned} L_1 &= [\langle a, b \rangle, \langle a, b, c, d \rangle, \langle a, b, c, e \rangle] \\ L_2 &= L_1 + [\langle s, t, u, v, w, x, y, z \rangle] \\ L_3 &= L_2 + [\langle b, c, d, e, f, g, h, i, j, k, l, m \rangle] \end{aligned}$$

Then, the trace nets M_1, M_2, M_3 for the event logs L_1, L_2, L_3 fulfill:

- $C_{\text{CNC}}(M_1) \approx 1.0526$,
- $C_{\text{CNC}}(M_2) \approx 1.0588$,
- $C_{\text{CNC}}(M_3) \approx 1.0526$,

and therefore, we have that $C_{\text{CNC}}(M_1) < C_{\text{CNC}}(M_2)$, $C_{\text{CNC}}(M_2) > C_{\text{CNC}}(M_3)$, and $C_{\text{CNC}}(M_1) = C_{\text{CNC}}(M_3)$, even though

- $C_{\text{nvar-e}}(L_1) \approx 0.3109$,
- $C_{\text{nvar-e}}(L_2) \approx 0.3348$,
- $C_{\text{nvar-e}}(L_3) \approx 0.3538$,

and therefore $C_{\text{nvar-e}}(L_1) < C_{\text{nvar-e}}(L_2) < C_{\text{nvar-e}}(L_3)$ is true. \square

Theorem 12. Let $\mathcal{C}^L \in (\text{LoC} \setminus \{C_{\text{TL-max}}, C_{\text{t-comp}}\})$ be a log complexity measure. Then, $(\mathcal{C}^L, C_{\text{dens}}) \in \geq$.

Proof. Let L be an event log and M be its trace net. Since every transition in M has exactly one incoming and one outgoing edge by definition, we have $C_{\text{dens}}(M) = \frac{2|T|}{2|T|(|P|-1)} = \frac{1}{|P|-1}$. Because M contains $2 + \sum_{\sigma \in L} (|\sigma| - 1)$ places, we get, for two trace nets M_1, M_2 of event logs L_1, L_2 with $L_1 \sqsubset L_2$:

$$C_{\text{dens}}(M_1) = \frac{1}{1 + \sum_{\sigma \in L_1} (|\sigma| - 1)} \stackrel{L_1 \sqsubset L_2}{\geq} \frac{1}{1 + \sum_{\sigma \in L_2} (|\sigma| - 1)} = C_{\text{dens}}(M_2).$$

What remains to be shown is that both $C_{\text{dens}}(M_1) > C_{\text{dens}}(M_2)$ and $C_{\text{dens}}(M_1) = C_{\text{dens}}(M_2)$ are possible. For the former, take the following logs:

$$\begin{aligned} L_1 &= [\langle a, b, c, d \rangle^2, \langle a, b, c, d, e \rangle^2, \langle d, e, a, b \rangle^2] \\ L_2 &= L_1 + [\langle a, b, c, d, e \rangle^2, \langle d, e, a, b, c \rangle, \langle c, d, e, a, b \rangle, \langle f, c, d, a, b, c \rangle] \end{aligned}$$

These two event logs have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-\%}}$
L_1	26	5	6	4.3333	5	6	5	13	3	0.5
L_2	52	6	11	4.7273	6	20	7	21	6	0.5455

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	4.3333	0.56	0.5757	2.6667	6.1827	0.3126	16.0483	0.1894
L_2	4.6364	0.5829	0.5887	2.9091	29.0428	0.4543	60.0209	0.2921

Thus, $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ for any of the log complexity measures allowed by this theorem. But the trace nets M_1, M_2 for the event logs L_1, L_2 fulfill the property $C_{\text{dens}}(M_1) \approx 0.0909 > 0.0417 \approx C_{\text{dens}}(M_2)$.

To see that $C_{\text{dens}}(M_1) = C_{\text{dens}}(M_2)$ is possible, take the following event logs:

$$L_1 = [\langle a, e \rangle^4, \langle a, b, c, d, e \rangle]$$

$$L_2 = L_1 + [\langle a, b, c, d, e \rangle, \langle f \rangle]$$

These two event logs have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-\%}}$
L_1	13	5	5	2.6	5	2	5	8	2	0.4
L_2	19	6	7	2.7143	5	3	5	11	3	0.4286

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	2.6	0.6	0.478	1.2	3.8191	0.3552	8.0241	0.2406
L_2	2.7143	0.3333	0.559	2.2857	6.6899	0.4911	16.283	0.2911

Thus, $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ for any allowed log complexity measure except affinity C_{affinity} . But the trace nets M_1, M_2 for the event logs L_1, L_2 fulfill the property $C_{\text{dens}}(M_1) = 0.1\bar{6} = C_{\text{dens}}(M_2)$. For $\mathcal{C}^L = C_{\text{affinity}}$, we take the following logs:

$$L_1 = [\langle a, e \rangle, \langle a, b, c, d, e \rangle]$$

$$L_2 = L_1 + [\langle a, b, c, d, e \rangle, \langle f \rangle]$$

Compared to the previous event logs, only the frequencies of traces changed, so for the trace nets M_1, M_2 for L_1, L_2 we still have $C_{\text{dens}}(M_1) = 0.1\bar{6} = C_{\text{dens}}(M_2)$. But now, $C_{\text{affinity}}(L_1) = 0 < 0.1667 \approx C_{\text{affinity}}(L_2)$, showing that equal density is also possible when affinity increases. \square

Theorem 13. *Let $\mathcal{C}^L \in \{C_{\text{TL-max}}, C_{\text{t-comp}}\}$ be a log complexity measure. Then, $(\mathcal{C}^L, C_{\text{dens}}) \in >$.*

Proof. As argued in the proof of Theorem 12, the density of a trace net M for an event log L is $C_{\text{dens}}(M) = \frac{1}{1 + \sum_{\sigma \in L} (|\sigma| - 1)}$. Thus, the density of M lowers if $1 + \sum_{\sigma \in L} (|\sigma| - 1)$ increases.

- **Maximum Trace Length $C_{\text{TL-max}}$:** Let L_1, L_2 be two event logs with $L_1 \sqsubset L_2$ and $C_{\text{TL-max}}(L_1) < C_{\text{TL-max}}(L_2)$. Then, there must be a trace $\sigma \in \text{supp}(L_2) \setminus \text{supp}(L_1)$ with $|\sigma| > 2$, since all traces in L_1 have length at least 1. But then, $|\sigma| - 1 \geq 1$ and therefore

$$1 + \sum_{\sigma \in L_1} (|\sigma| - 1) < 1 + \sum_{\sigma \in L_2} (|\sigma| - 1).$$

- **Number of Ties $C_{\text{t-comp}}$:** Let L_1, L_2 be two event logs with $L_1 \sqsubset L_2$ and $C_{\text{t-comp}}(L_1) < C_{\text{t-comp}}(L_2)$. Then, there must be two activity names a, b with $a >_{L_2} b$ and $b \not>_{L_2} a$, but with $a \not>_{L_1} b$ or $b >_{L_1} a$. Since $L_1 \sqsubset L_2$ and $b \not>_{L_2} a$, out of the latter two, only $a \not>_{L_1} b$ can be true. In turn, there must be a trace $\sigma \in \text{supp}(L_2) \setminus \text{supp}(L_1)$ with $\sigma(i) = a$ and $\sigma(i+1) = b$ for some $i \in \{1, \dots, |\sigma| - 1\}$. But then, $|\sigma| \geq 2$ and therefore $|\sigma| - 1 \geq 1$, so

$$1 + \sum_{\sigma \in L_1} (|\sigma| - 1) < 1 + \sum_{\sigma \in L_2} (|\sigma| - 1).$$

Thus, for any event logs L_1, L_2 and their trace nets M_1, M_2 , we have shown that $C_{\text{TL-max}}(L_1) < C_{\text{TL-max}}(L_2) \Rightarrow C_{\text{dens}}(M_1) > C_{\text{dens}}(M_2)$ and, similarly, $C_{\text{t-comp}}(L_1) < C_{\text{t-comp}}(L_2) \Rightarrow C_{\text{dens}}(M_1) > C_{\text{dens}}(M_2)$. \square

Theorem 14. $(\mathcal{C}^L, C_{\text{dup}}) \in \leq$ for any log complexity measure $\mathcal{C}^L \in \text{LoC}$

Proof. By Lemma 5, we know that $C_{\text{dup}}(M_1) < C_{\text{dup}}(M_2)$ for trace nets M_1, M_2 of event logs L_1, L_2 with $L_1 \sqsubset L_2$. What remains to be shown is that both $C_{\text{dup}}(M_1) = C_{\text{dup}}(M_2)$ and $C_{\text{dup}}(M_1) < C_{\text{dup}}(M_2)$ are possible. For the former, take the following event logs:

$$\begin{aligned} L_1 &= [\langle a \rangle, \langle a, b, c, d \rangle] \\ L_2 &= L_1 + [\langle u, v, w, x, y, z \rangle^2] \end{aligned}$$

These two event logs have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-}\%}$
L_1	5	4	2	2.5	4	2	3	4	2	1
L_2	17	10	4	4.25	6	3	8	13	3	0.75

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	2.5	0	0.4796	3	0	0	0	0
L_2	4.25	0.1667	0.6449	6.1667	6.7301	0.2923	10.2986	0.2138

Thus, $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ for any log complexity measure except the percentage of distinct traces $C_{\text{DT-}\%}$. However, the number of duplicate tasks in the trace nets M_1, M_2 for the logs L_1, L_2 are the same: $C_{\text{dup}}(M_1) = 1 = C_{\text{dup}}(M_2)$. To see that there is also such an example for the percentage of distinct traces $C_{\text{DT-}\%}$, we take the event logs above and change their frequencies:

$$\begin{aligned} L_1 &= [\langle a \rangle^4, \langle a, b, c, d \rangle] \\ L_2 &= L_1 + [\langle u, v, w, x, y, z \rangle^2] \end{aligned}$$

Then, $C_{\text{DT-}\%}(L_1) = 0.4 < 0.4286 \approx C_{\text{DT-}\%}(L_2)$, but $C_{\text{dup}}(M_1) = 1 = C_{\text{dup}}(M_2)$.

To see that C_{dup} can also increase, take the following event logs:

$$\begin{aligned} L_1 &= [\langle a \rangle^2, \langle a, b, c, d \rangle^3] \\ L_2 &= L_1 + [\langle e, a, b, c, d \rangle^2] \end{aligned}$$

These two event logs have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-\%}}$
L_1	14	4	5	2.8	4	2	3	8	2	0.4
L_2	24	5	7	3.4286	5	4	4	11	3	0.4286

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	2.8	0.4	0.4796	1.8	0	0	0	0
L_2	3.4286	0.4524	0.5169	1.9048	6.1827	0.3126	16.3006	0.2137

Thus, $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ for every log complexity measure $\mathcal{C}^L \in \text{LoC}$. But the trace nets M_1, M_2 for the logs L_1, L_2 fulfill $C_{\text{dup}}(M_1) = 1 < 5 = C_{\text{dup}}(M_2)$. \square

For the remainder of this subsection, we will analyze the model complexity of the trace net in more depth and characterize the model complexity scores of the trace net by using log complexity measures. Since many complexity scores for the trace net are dependent of the amount of places in the trace net, we define

$$\mathcal{N}(L) := \sum_{\sigma \in L} (|\sigma| - 1)$$

for an event log L as the total number of neighborhoods in distinct traces of L . Since two transitions in the trace net are connected via a place, the total amount of places in the trace net is $2 + \mathcal{N}(L)$. We need to increase $\mathcal{N}(L)$ by two for the initial place p_i and the final place p_o . With this notion, we can now analyze the model complexity scores of the trace net M for an event log L over a set of activities A .

- **Size C_{size} :** As argued before, the trace net contains $2 + \mathcal{N}(L)$ places. Furthermore, it contains $\sum_{\sigma \in L} |\sigma|$ transitions. Thus, we have:

$$\begin{aligned} C_{\text{size}}(M) &= 2 + \sum_{\sigma \in L} (2|\sigma| + 1) = 2 + \left(\sum_{\sigma \in L} 2(|\sigma| - 1) \right) + |supp(L)| \\ &= 2 + 2\mathcal{N}(L) + C_{\text{DT-#}}(L) \end{aligned}$$

- **Connector Mismatch C_{MM} :** If $|supp(L)| = 1$, there are no connectors in M and $C_{\text{MM}}(M) = 0$. Otherwise, the only connectors in M are p_i and p_o . The place p_i has $|supp(L)|$ outgoing, while the place p_o has $|supp(L)|$ incoming edges. Thus, we get $C_{\text{MM}}(M) = ||supp(L)| - |supp(L)|| = 0$.
- **Connector Heterogeneity C_{CH} :** If $|supp(L)| = 1$, there are no connectors in M and C_{CH} is undefined. Otherwise, the only connectors in M are p_i and p_o . Both of these connectors are **xor**-connectors, so we get the connector heterogeneity score $C_{\text{CH}}(M) = -(1 \cdot \log_2(1) + 0 \cdot \log_2(0)) = 0$.
- **Cross Connectivity C_{CC} :** For readability, let $n := |supp(L)|$. There are only two nodes in M that have a weight $\neq 1$: p_i and p_o . This results in only the edges leaving p_i and the edges entering p_o having weight $\frac{1}{n}$, while all other edges in M have weight 1. Thus, or the connection values in the trace net M , we get:
 - $V(p_i, x) = \frac{1}{n}$ for all nodes x of M with $x \neq p_i$ and $x \neq p_o$,

- $V(p_i, p_o) = \frac{1}{n^2}$,
- Let $\sigma \in L$ be a trace and $i \in \{1, \dots, |\sigma|\}$. Then, the transition for $\sigma(i)$ has $|\sigma| - i$ times the value 1 with succeeding transitions, $|\sigma| - 1$ times value 1 with succeeding places except p_o , and value $\frac{1}{n}$ with the place p_o .
- Let $\sigma \in L$ be a trace and $i \in \{1, \dots, |\sigma|\}$. Then, the place $p_{\sigma(i)}$ in the postset of the transition for $\sigma(i)$ has $|\sigma| - i$ times the value 1 with succeeding transitions, $|\sigma| - i - 1$ times the value 1 with succeeding places except p_o , and value $\frac{1}{n}$ with the place p_o .

Since all other connections have value 0, we get, for the sum of these values:

$$\begin{aligned}
& \frac{1}{n^2} + \sum_{\sigma \in L} \left(\sum_{i=1}^{|\sigma|} \left(2(|\sigma| - i) + \frac{2}{n} \right) + \sum_{j=1}^{|\sigma|-1} \left(2(|\sigma| - j) - 1 + \frac{2}{n} \right) \right) \\
&= \frac{1}{n^2} + \sum_{\sigma \in L} \frac{(2|\sigma| - 1) \cdot (n(|\sigma| - 1) + 2)}{n} \\
&= \frac{1}{n} \cdot \left(\frac{1}{n} + \sum_{\sigma \in L} (2|\sigma| - 1) \cdot (n(|\sigma| - 1) + 2) \right) \\
&= \frac{1}{n} \cdot \left(\frac{1}{n} + n \cdot \sum_{\sigma \in L} (2|\sigma| - 1) \cdot \left(|\sigma| - 1 + \frac{2}{n} \right) \right)
\end{aligned}$$

In turn, the cross connectivity of the trace net is:

$$C_{\text{CC}}(M) = 1 - \frac{\frac{1}{n^2} + \sum_{\sigma \in L} (2|\sigma| - 1) \cdot \left(|\sigma| - 1 + \frac{2}{n} \right)}{(2 + 2\mathcal{N}(L) + C_{\text{DT-}\#}(L)) \cdot (1 + 2\mathcal{N}(L) + C_{\text{DT-}\#}(L))}$$

- **Token Split** C_{ts} : Since every transition in M has exactly one incoming and one outgoing edge, it contains no **and**-splits. Therefore, $C_{\text{ts}}(M) = 0$.
- **Control Flow Complexity** C_{CFC} : If $|\text{supp}(L)| = 1$, the trace net M does not contain any connectors, and thus $C_{\text{CFC}}(M) = 0$. Otherwise, the only connector nodes in M are p_i and p_o . p_i is an **xor**-split and p_o an **xor**-join, so $C_{\text{CFC}}(M) = |p_i^\bullet| = |\text{supp}(L)| = C_{\text{DT-}\#}(L)$.
- **Separability** C_{sep} : If $|\text{supp}(L)| = 1$, every node in M except p_i and p_o is a cut-vertex, so $C_{\text{sep}}(M) = 0$. Otherwise, M does not contain any cut-vertices, so $C_{\text{sep}}(M) = 1$.
- **Average Connector Degree** C_{acd} : If $|\text{supp}(L)| = 1$, the trace net contains no connectors and thus, the average connector degree is undefined. Otherwise, only the places p_i and p_o are connectors in M . Both places have degree $|\text{supp}(L)|$, so the average connector degree of the trace net is $C_{\text{acd}}(M) = \frac{|\text{supp}(L)| + |\text{supp}(L)|}{2} = |\text{supp}(L)| = C_{\text{DT-}\#}(L)$.
- **Maximum Connector Degree** C_{mcd} : If $|\text{supp}(L)| = 1$, the trace net M contains no connectors and thus, the maximum connector degree is undefined. Otherwise, only the places p_i and p_o are connectors in M . Both places have degree $|\text{supp}(L)|$, so the maximum connector degree of the trace net is $C_{\text{mcd}}(M) = |\text{supp}(L)| = C_{\text{DT-}\#}(L)$.

- **Sequentiality** C_{seq} : If $|supp(L)| = 1$, the trace net M contains no connectors and thus, every edge in M connects two non-connector nodes, leading to $C_{\text{seq}}(M) = 0$. Otherwise, only the edges leaving p_i or entering p_o have a connector node at their head or tail. Since M contains $2|T|$ edges in total, we get $C_{\text{seq}}(M) = 1 - \frac{2|T|-2|supp(L)|}{2|T|} = \frac{2|supp(L)|}{2|T|} = \frac{C_{\text{DT-}\#}(L)}{\mathcal{N}(L)+C_{\text{DT-}\#}(L)}$.
- **Depth** C_{depth} : If $|supp(L)| = 1$, there trace net M does not contain any connectors, and thus, the in- and out-depth of every node in M is 0, leading to $C_{\text{depth}}(M) = 0$. Otherwise, every node except p_i and p_o have in- and out-depth 1, while p_i and p_o have in- and out-depth 0. Thus, $C_{\text{depth}}(M) = \max\{0, 1\} = 1$.
- **Diameter** C_{diam} : The diameter of the trace net M is dependent on the length of the longest trace in L . Let $\sigma \in L$ be a trace with maximum length in L . Then, one of the paths through the trace net M with maximal length is the path $(p_i, \sigma(1), p_{\sigma(1)}, \sigma(2), \dots, p_{|\sigma|-1}, \sigma(|\sigma|), p_o)$, where $p_{\sigma(i)}$ is the place in the postset of the transition for $\sigma(i)$ for any $i \in \{1, \dots, |\sigma|\}$. The length of this path is $C_{\text{diam}}(M) = 1 + 2 \max\{|\sigma| \mid \sigma \in L\} = 1 + 2 \cdot C_{\text{TL-max}}(L)$.
- **Cyclicity** C_{cyc} : The trace net M does not introduce any cycles, so it has no nodes that lie on such cycles. Therefore, $C_{\text{cyc}}(M) = 0$.
- **Coefficient of Network Connectivity** C_{CNC} : Since by construction, every transition in M has exactly one incoming and one outgoing edge, M contains $2|T|$ edges in total. Thus, $C_{\text{CNC}}(M) = \frac{2|T|}{|P|+|T|} = \frac{2(\mathcal{N}(L)+C_{\text{DT-}\#}(L))}{2+2\mathcal{N}(L)+C_{\text{DT-}\#}(L)}$.
- **Density** C_{dens} : Since by construction, every transition in M has exactly one incoming and one outgoing edge, M contains $2|T|$ edges in total. Thus, $C_{\text{dens}}(M) = \frac{2|T|}{2|T|(|P|-1)} = \frac{1}{|P|-1} = \frac{1}{1+\mathcal{N}(L)}$.
- **Number of Duplicate Tasks** C_{dup} : The number of duplicate tasks in the trace net M is exactly the amount of event name repetitions in the support of the event log L . Thus, $C_{\text{dup}}(M) = \sum_{a \in A} (|\{(i, j) \mid \sigma_i \in L : \sigma_i(j) = a\}| - 1)$.
- **Number of Empty Sequence Flows** C_{\emptyset} : Since the trace net M does not contain any **and**-connectors, the number of empty sequence flows in M is $C_{\emptyset}(M) = 0$ by definition.

These findings conclude our analysis of the trace net miner. Table 8 summarizes these findings for quick reference.

Table 8. The complexity scores of the trace net M for an event log L over A .

$C_{\text{size}}(M)$	$2 + 2\mathcal{N}(L) + C_{\text{DT-}\#}(L)$
$C_{\text{MM}}(M)$	0
$C_{\text{CH}}(M)$	0
$C_{\text{CC}}(M)$	$1 - \frac{\frac{1}{C_{\text{DT-}\#}(L)^2} + \sum_{\sigma \in L} (2^{ \sigma -1}) \cdot \left(\sigma -1 + \frac{2}{C_{\text{DT-}\#}(L)} \right)}{(2+2\mathcal{N}(L)+C_{\text{DT-}\#}(L)) \cdot (1+2\mathcal{N}(L)+C_{\text{DT-}\#}(L))}$
$C_{\text{ts}}(M)$	0
$C_{\text{CFC}}(M)$	$\begin{cases} 0 & \text{if } C_{\text{DT-}\#}(L) = 1 \\ C_{\text{DT-}\#}(L) & \text{otherwise} \end{cases}$
$C_{\text{sep}}(M)$	$\begin{cases} 0 & \text{if } C_{\text{DT-}\#}(L) = 1 \\ 1 & \text{otherwise} \end{cases}$
$C_{\text{acd}}(M)$	$C_{\text{DT-}\#}(L)$
$C_{\text{mcd}}(M)$	$C_{\text{DT-}\#}(L)$
$C_{\text{seq}}(M)$	$\begin{cases} 0 & \text{if } C_{\text{DT-}\#}(L) = 1 \\ \frac{C_{\text{DT-}\#}(L)}{\mathcal{N}(L)+C_{\text{DT-}\#}(L)} & \text{otherwise} \end{cases}$
$C_{\text{depth}}(M)$	$\begin{cases} 0 & \text{if } C_{\text{DT-}\#}(L) = 1 \\ 1 & \text{otherwise} \end{cases}$
$C_{\text{diam}}(M)$	$1 + 2 \cdot C_{\text{TL-max}}(L)$
$C_{\text{cyc}}(M)$	0
$C_{\text{CNC}}(M)$	$\frac{2(\mathcal{N}(L)+C_{\text{DT-}\#}(L))}{2+2\mathcal{N}(L)+C_{\text{DT-}\#}(L)}$
$C_{\text{dens}}(M)$	$\frac{1}{1+\mathcal{N}(L)}$
$C_{\text{dup}}(M)$	$\sum_{a \in A} (\{(i, j) \mid \sigma_i \in L : \sigma_i(j) = a\} - 1)$
$C_{\emptyset}(M)$	0

4.3 Alpha Miner

The alpha miner [13] is one of the first algorithms introduced for process discovery. It calculates a Petri net for an event log by first constructing the causal footprint of the log and then analyzing which activities should directly follow each other. As a first example, take the following event log:

$$L_1 = [\langle a, b, c, d, e \rangle, \langle a, b, d, c, e \rangle, \langle a, u, v, x, y, z \rangle]$$

The set of activities occurring in L_1 is $A_{L_1} = \{a, b, c, d, e, u, v, x, y, z\}$. For each of these activities, we create a row and a cell in a matrix we call the causal footprint, and use it as a table to show the relation between two activities.

	a	b	c	d	e	u	v	x	y	z
a	#	→	#	#	#	→	#	#	#	#
b	←	#	→	→	#	#	#	#	#	#
c	#	←	#		→	#	#	#	#	#
d	#	←		#	→	#	#	#	#	#
e	#	#	←	←	#	#	#	#	#	#
u	←	#	#	#	#	#	→	#	#	#
v	#	#	#	#	#	←	#	→	#	#
x	#	#	#	#	#	#	←	#	→	#
y	#	#	#	#	#	#	#	←	#	→
z	#	#	#	#	#	#	#	#	←	#

The general idea is to create transitions a for every $a \in A_{L_1}$ and connect two transitions a, b via a place if $a \rightarrow b$. To do this, first define

$$X_L = \{(B, C) \mid B \subseteq A_L \wedge B \neq \emptyset \wedge C \subseteq A_L \wedge C \neq \emptyset \wedge \\ \forall b \in B, c \in C : b \rightarrow c \wedge \forall b_1, b_2 \in B : b_1 \# b_2 \wedge \forall c_1, c_2 \in C : c_1 \# c_2\}$$

for any event log L over a set of activities A_L . Intuitively, X_L contains all pairs of activity-name-sets where all activities of the first set are in directly follows relation (\rightarrow) to all activities of the second set. In order to model concurrency correctly, all elements of one set must be incomparable ($\#$) to each other. In the example above, $(\{b\}, \{c\}), (\{b\}, \{d\}) \in X_{L_1}$, but $(\{b\}, \{c, d\}) \notin X_{L_1}$, because c and d are parallel to each other, and therefore do not fulfill $c \# d$. Using this set to define the places of the output net would result in many implicit places, so the alpha miner instead uses the most expressive tuples of X_L :

$$Y_L = \{(B, C) \in X_L \mid \forall (B', C') \in X_L : (B \subseteq B' \wedge C \subseteq C') \Rightarrow (B, C) = (B', C')\}$$

Thus, we only keep tuples that are maximal in the sense that the sets of no other tuple contain the sets of the maximal tuple. In the example above, this means that, even though $(\{a\}, \{b\}), (\{a\}, \{u\}) \in X_{L_1}$, both of these tuples are not included in Y_{L_1} , because $(\{a\}, \{b, u\}) \in X_{L_1}$ and we have that $\{a\} \subseteq \{a\}$ and $\{b\}, \{u\} \subseteq \{b, u\}$. As mentioned earlier, each of the tuples in Y_L correspond to a place in the resulting Petri net. On top of that, we have two special places p_i and

p_o , where p_i is the initially marked input place and p_o is the place that defines the final marking of the net. The alpha miner creates edges from p_i to all transitions whose label occurs first in any trace, i.e., $p_i^\bullet = A_I = \{a \mid \exists \sigma \in L : \sigma(1) = a\}$. Furthermore, it creates edges to p_o from all transitions whose label occurs last in any trace, i.e., ${}^\bullet p_o = A_O = \{a \mid \exists \sigma \in L : \sigma(|\sigma|) = a\}$. Fig. 8 shows the Petri net found by the alpha miner for the input event log L_1 .

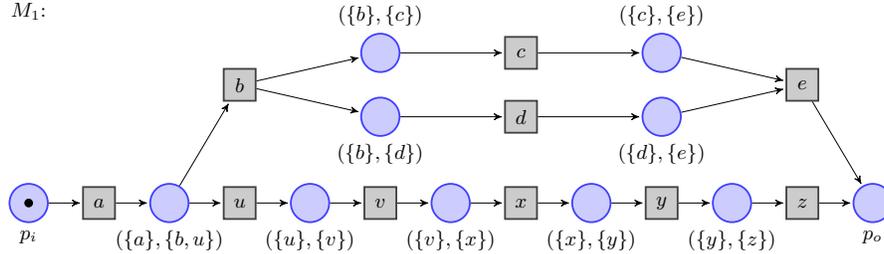


Fig. 8. The output of the alpha algorithm for the input event log L_1 .

The result of the alpha algorithm is not always sound, which we will use to our advantage during the analyses of this section. For example, take the following event log L_2 , which is a proper superset of the event log L_1 :

$$L_2 = [\langle a, b, c, d, e \rangle, \langle a, b, d, c, e \rangle, \langle a, u, v, x, y, z \rangle, \langle a, b, c, d, e, f, g, h \rangle]$$

The only change to the event log L_1 is that the trace $\langle a, b, c, d, e \rangle$ can be extended by the events f, g , and h in that order. The result of the alpha miner for this event log is shown in Fig. 9. In this Petri net, the final place p_o can contain 2

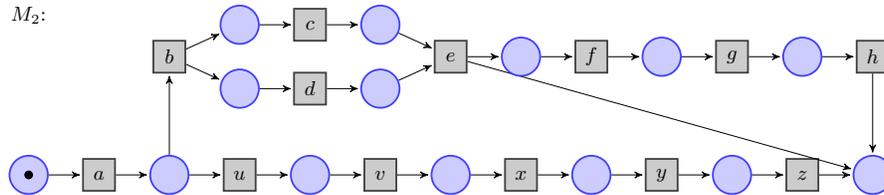


Fig. 9. The output of the alpha algorithm for the input event log L_2 .

tokens at once, when the transitions a, b, c, d, e, f, g, h fire in that sequence. We can use this property to increase the token split or connector mismatch score without changing much of the behavior. Sometimes, the output of the alpha miner is not a workflow net, as it can contain isolated nodes. For example:

$$L_3 = L_2 + [\langle d \rangle, \langle g \rangle, \langle c, e \rangle, \langle a, b, c, d, e \rangle^2, \langle b, b, c, d, d, e, f, f, g, g, h, h \rangle]$$

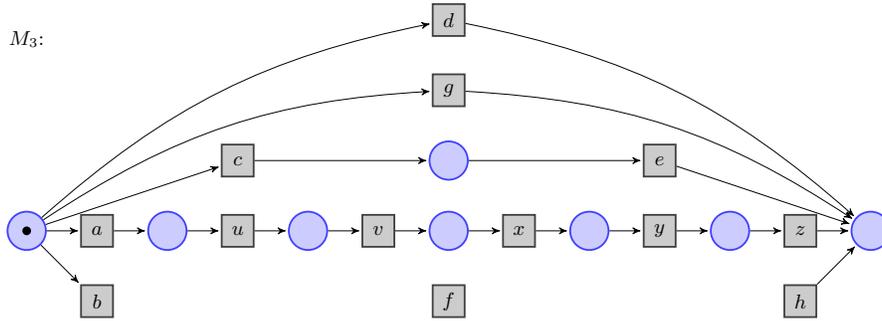


Fig. 10. The output of the alpha algorithm for the input event log L_3 .

Fig. 10 shows the result of the alpha miner for the event log L_3 , containing isolated nodes. Due to this behavior of the alpha algorithm, we can find counter-examples showing that none of the log complexity measures can predict the model complexity of the alpha algorithm’s output. The only exception is the number of duplicate tasks C_{dup} , which is always 0, since we create exactly one transition for each distinct activity in the event log. Table 9 shows our findings.

Table 9. The relations between the complexity scores of two nets M_1 and M_2 found by the alpha miner for the event logs L_1 and L_2 as input respectively, where $L_1 \sqsubset L_2$ and the complexity of L_1 is lower than the complexity of L_2 .

	C_{size}	C_{MM}	C_{CH}	C_{CC}	C_{ts}	C_{CFG}	C_{sep}	C_{acd}	C_{mcd}	C_{seq}	C_{depth}	C_{diam}	C_{cyc}	C_{CNC}	C_{dens}	C_{dup}	C_0
C_{mag}	X	X	X	X*	X	X	X	X	X	X	X	X	X	X	X	=	X
C_{var}	X	X	X	X*	X	X	X	X	X	X	X	X	X	X	X	=	X
C_{len}	X	X	X	X*	X	X	X	X	X	X	X	X	X	X	X	=	X
C_{TL-avg}	X	X	X	X*	X	X	X	X	X	X	X	X	X	X	X	=	X
C_{TL-max}	X	X	X	X*	X	X	X	X	X	X	X	X	X	X	X	=	X
C_{LOD}	X	X	X	X*	X	X	X	X	X	X	X	X	X	X	X	=	X
C_{t-comp}	X	X	X	X*	X	X	X	X	X	X	X	X	X	X	X	=	X
C_{LZ}	X	X	X	X*	X	X	X	X	X	X	X	X	X	X	X	=	X
$C_{DT-#}$	X	X	X	X*	X	X	X	X	X	X	X	X	X	X	X	=	X
$C_{DT-}\%$	X	X	X	X*	X	X	X	X	X	X	X	X	X	X	X	=	X
C_{struct}	X	X	X	X*	X	X	X	X	X	X	X	X	X	X	X	=	X
$C_{affinity}$	X	X	X	X*	X	X	X	X	X	X	X	X	X	X	X	=	X
C_{dev-R}	X	X	X	X*	X	X	X	X	X	X	X	X	X	X	X	=	X
$C_{avg-dist}$	X	X	X	X*	X	X	X	X	X	X	X	X	X	X	X	=	X
C_{var-e}	X	X	X	X*	X	X	X	X	X	X	X	X	X	X	X	=	X
C_{nvar-e}	X	X	X	X*	X	X	X	X	X	X	X	X	X	X	X	=	X
C_{seq-e}	X	X	X	X*	X	X	X	X	X	X	X	X	X	X	X	=	X
C_{nseq-e}	X	X	X	X*	X	X	X	X	X	X	X	X	X	X	X	=	X

*We did not find examples showing that $C^L(L_1) < C^L(L_2)$ and $C_{CC}(M_1) = C_{CC}(M_2)$ is possible.

Theorem 15. Let $\mathcal{C}^L \in \text{LoC}$ be any log complexity measure and let \mathcal{C}^M be a model complexity measure with $\mathcal{C}^M \in \{C_{\text{size}}, C_{\text{ts}}, C_{\text{CFC}}, C_{\text{acd}}, C_{\text{mcd}}, C_{\text{cyc}}, C_{\emptyset}\}$. Then, $(\mathcal{C}^L, \mathcal{C}^M) \in \mathbf{X}$.

Proof. Consider the following event logs:

$$\begin{aligned} L_1 &= [\langle a, b, c, d, e \rangle^3, \langle e \rangle^2] \\ L_2 &= L_1 + [\langle a, b, c, d, b, c, d, e, f \rangle^2] \\ L_3 &= L_2 + [\langle a, b, c, d, b, c, d, b, c, d, e \rangle^2, \langle a, b, c, d, e \rangle, \\ &\quad \langle a, a, b, b, c, c, d, d, e, e, f, f, g, g, h, h, i, i \rangle] \end{aligned}$$

Fig. 11 shows the models M_1, M_2, M_3 found by the alpha miner for L_1, L_2, L_3 . These models have the following complexity scores:

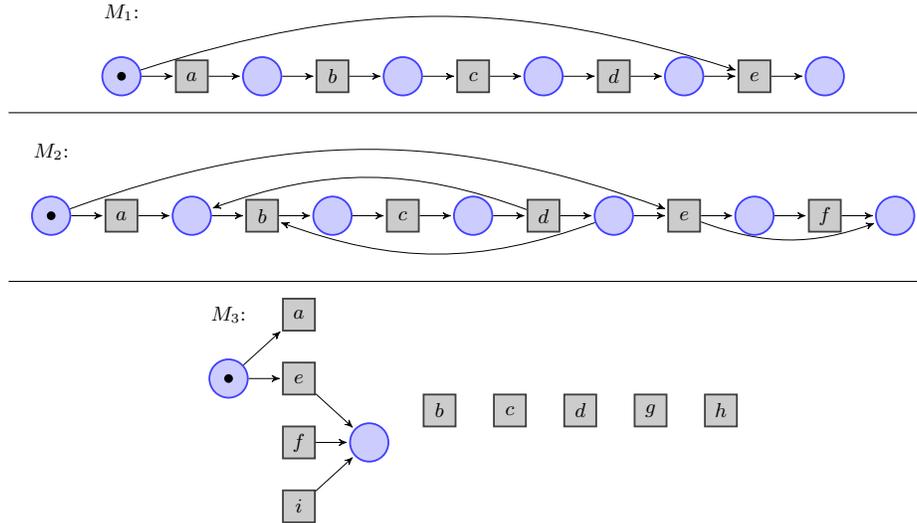


Fig. 11. The results of the alpha algorithm for the input logs L_1, L_2, L_3 from the example in Theorem 15. M_1 is the model mined from the log L_1 , M_2 the model mined from the log L_2 , and M_3 the model mined from the log L_3 .

	C_{size}	C_{ts}	C_{CFC}	C_{acd}	C_{mcd}	C_{cyc}	C_{\emptyset}
M_1	11	0	2	2.5	3	0	0
M_2	13	2	6	2.8571	4	0.6364	1
M_3	11	0	2	2.5	3	0	0

Thus, $\mathcal{C}^M(M_1) < \mathcal{C}^M(M_2)$, $\mathcal{C}^M(M_2) > \mathcal{C}^M(M_3)$, and $\mathcal{C}^M(M_1) = \mathcal{C}^M(M_3)$ for all $\mathcal{C}^M \in \{C_{\text{size}}, C_{\text{ts}}, C_{\text{CFC}}, C_{\text{acd}}, C_{\text{mcd}}, C_{\text{cyc}}, C_{\emptyset}\}$. But the event logs L_1, L_2, L_3 have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	C_{TL-avg}	C_{TL-max}	C_{LOD}	C_{t-comp}	C_{LZ}	$C_{DT-#}$	$C_{DT-\%}$
L_1	17	5	5	3.4	5	2	4	11	2	0.4
L_2	35	6	7	5	9	4	6	18	3	0.4286
L_3	90	9	11	8.1818	18	6	9	37	6	0.5455

	C_{struct}	$C_{affinity}$	C_{dev-R}	$C_{avg-dist}$	C_{var-e}	C_{nvar-e}	C_{seq-e}	C_{nseq-e}
L_1	3.4	0.4	0.5417	2.4	2.7034	0.2515	6.1576	0.1278
L_2	4.1429	0.4286	0.5862	3.8095	10.2825	0.3898	27.9087	0.2243
L_3	4.8182	0.4584	0.6336	7.2727	55.7526	0.4173	136.0569	0.3360

Since $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) < \mathcal{C}^L(L_3)$ for any log complexity measure $\mathcal{C}^L \in LoC$, we have thus shown that $(\mathcal{C}^L, \mathcal{C}^M) \in \mathbf{X}$ for any model complexity measure $\mathcal{C}^M \in \{C_{size}, C_{ts}, C_{CFC}, C_{acd}, C_{mcd}, C_{cyc}, C_{\emptyset}\}$. \square

Theorem 16. Let $\mathcal{C}^L \in LoC$ be any log complexity measure and let \mathcal{C}^M be a model complexity measure with $\mathcal{C}^M \in \{C_{MM}, C_{CH}, C_{depth}\}$. Then, $(\mathcal{C}^L, \mathcal{C}^M) \in \mathbf{X}$.

Proof. Consider the following event logs:

$$\begin{aligned}
 L_1 &= [\langle a, b, c, d \rangle^3, \langle e \rangle^2] \\
 L_2 &= L_1 + [\langle a, b, c, d \rangle^3, \langle a, c, b, d \rangle, \langle a, b, c, b, c, d \rangle, \langle b, c, b, c, b, c, d \rangle, \\
 &\quad \langle a, b, c, f, e, f, e \rangle] \\
 L_3 &= L_2 + [\langle a, b, c, b, c, b, c, b, c, d \rangle^3, \langle a, b, c, b, c, b, c, b, c, b, c, d \rangle, \\
 &\quad \langle a, a, b, b, c, c, d, d \rangle, \langle e, e, f, f, g, g \rangle]
 \end{aligned}$$

Fig. 12 shows the models M_1, M_2, M_3 found by the alpha miner for L_1, L_2, L_3 . These models have the following complexity scores:

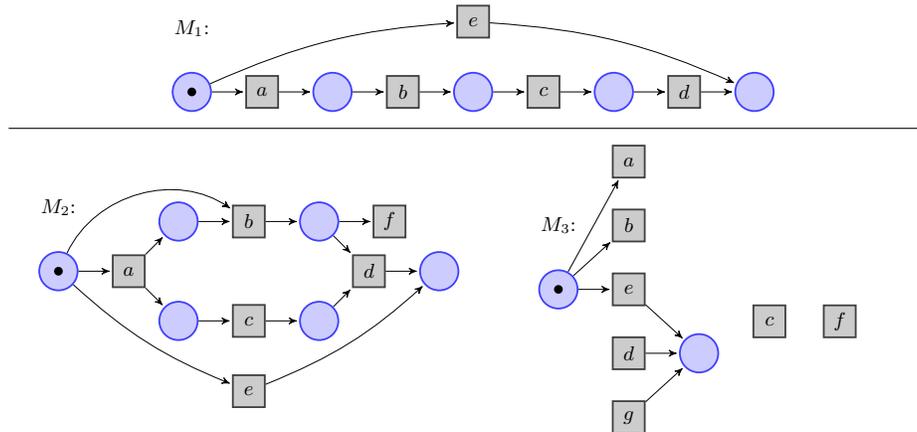


Fig. 12. The results of the alpha algorithm for the input logs L_1, L_2, L_3 from the example in Theorem 16. M_1 is the model mined from the log L_1 , M_2 the model mined from the log L_2 , and M_3 the model mined from the log L_3 .

	C_{MM}	C_{CH}	C_{depth}
M_1	0	0	1
M_2	5	1	2
M_3	0	0	1

Thus, $\mathcal{C}^M(M_1) < \mathcal{C}^M(M_2)$, $\mathcal{C}^M(M_2) > \mathcal{C}^M(M_3)$, and $\mathcal{C}^M(M_1) = \mathcal{C}^M(M_3)$ for all $\mathcal{C}^M \in \{C_{MM}, C_{CH}, C_{depth}\}$. But the event logs L_1, L_2, L_3 have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	C_{TL-avg}	C_{TL-max}	C_{LOD}	C_{t-comp}	C_{LZ}	$C_{DT-#}$	$C_{DT-\%}$
L_1	14	5	5	2.8	4	2	3	9	2	0.4
L_2	62	6	14	4.4286	7	10	5	25	6	0.4286
L_3	118	7	20	5.9	12	14	6	43	10	0.5

	C_{struct}	$C_{affinity}$	C_{dev-R}	$C_{avg-dist}$	C_{var-e}	C_{nvar-e}	C_{seq-e}	C_{nseq-e}
L_1	2.8	0.4	0.4584	3	2.502	0.3109	5.7416	0.1554
L_2	3.5714	0.4555	0.565	3.3626	36.6995	0.5397	78.6547	0.3074
L_3	3.65	0.4632	0.5683	5.3579	89.9638	0.5731	207.215	0.3681

Since $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) < \mathcal{C}^L(L_3)$ for any log complexity measure $\mathcal{C}^L \in LoC$, we have thus shown that $(\mathcal{C}^L, \mathcal{C}^M) \in \mathbf{X}$ for any model complexity measure $\mathcal{C}^M \in \{C_{MM}, C_{CH}, C_{depth}\}$. \square

Theorem 17. *Let $\mathcal{C}^L \in LoC$ be any log complexity measure and let \mathcal{C}^M be a model complexity measure with $\mathcal{C}^M \in \{C_{CC}, C_{seq}\}$. Then, $(\mathcal{C}^L, \mathcal{C}^M) \in \mathbf{X}$.*

Proof. Consider the following event logs:

$$\begin{aligned}
L_1 &= [\langle a, b, d \rangle^2, \langle a, c, d \rangle^2, \langle e \rangle] \\
L_2 &= L_1 + [\langle a, b, d, e \rangle, \langle a, c, d, e \rangle, \langle a, b, c, d \rangle, \langle a, b, c, b, d, e, f \rangle, \\
&\quad \langle a, b, c, b, c, b, d, e, f \rangle] \\
L_3 &= L_2 + [\langle a, c, b, d \rangle, \langle a, c, b, c, b, d, e \rangle, \langle a, b, c, b, c, b, c, d \rangle, \langle a, b, c, b, c, b, c, b, c, d \rangle, \\
&\quad \langle a, a, b, b, c, c, d, d, e, e, f, f, g, g \rangle]
\end{aligned}$$

Fig. 13 shows the models M_1, M_2, M_3 found by the alpha miner for L_1, L_2, L_3 . These models have the following complexity scores:

	C_{CC}	C_{seq}
M_1	0.9237	1
M_2	0.631	0.7059
M_3	0.9705	1

Thus, we have $C_{CC}(M_1) > C_{CC}(M_2)$ and $C_{CC}(M_2) < C_{CC}(M_3)$, as well as $C_{seq}(M_1) > C_{seq}(M_2)$, $C_{seq}(M_2) < C_{seq}(M_3)$, and $C_{seq}(M_1) = C_{seq}(M_3)$. But the event logs L_1, L_2, L_3 have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	C_{TL-avg}	C_{TL-max}	C_{LOD}	C_{t-comp}	C_{LZ}	$C_{DT-#}$	$C_{DT-\%}$
L_1	13	5	5	2.6	3	3	4	8	3	0.6
L_2	41	6	10	4.1	9	14	6	18	8	0.8
L_3	84	7	15	5.6	14	19	7	35	13	0.8667

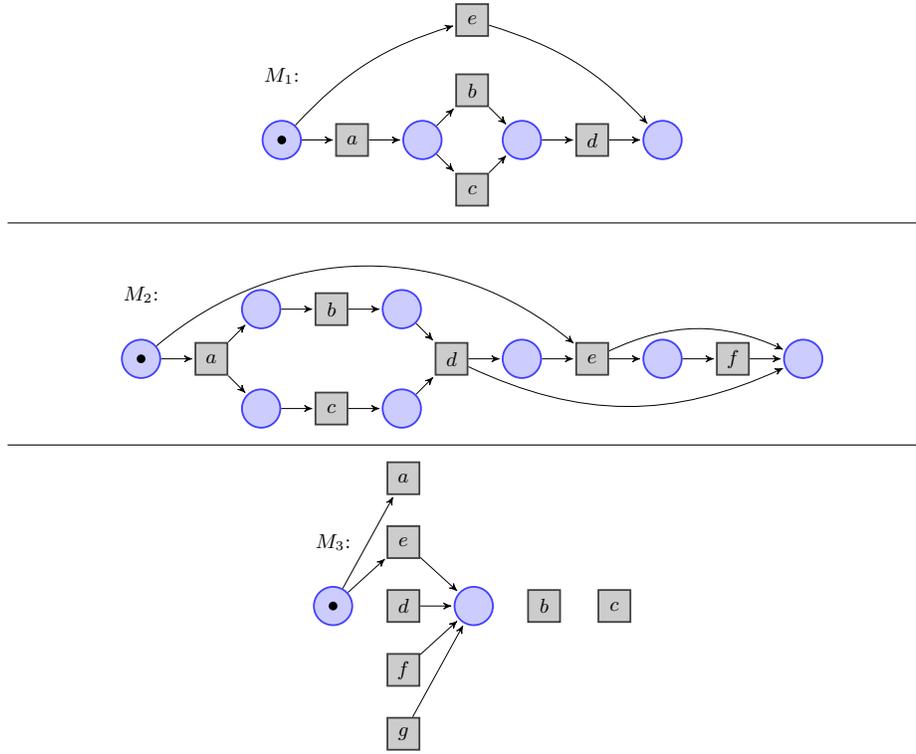


Fig. 13. The results of the alpha algorithm for the input logs L_1, L_2, L_3 from the example in Theorem 17. M_1 is the model mined from the log L_1 , M_2 the model mined from the log L_2 , and M_3 the model mined from the log L_3 .

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	2.6	0.2	0.5417	2.4	6.0684	0.5645	11.1636	0.3348
L_2	3.7	0.2316	0.6705	3.1333	32.1247	0.5742	61.0512	0.401
L_3	4.0667	0.237	0.6926	4.7429	92.954	0.5747	174.779	0.4696

Since $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) < \mathcal{C}^L(L_3)$ for any log complexity measure $\mathcal{C}^L \in \text{LoC}$, we have thus shown that $(\mathcal{C}^L, \mathcal{C}^M) \in \mathbf{X}$ for any model complexity measure $\mathcal{C}^M \in \{C_{\text{CC}}, C_{\text{seq}}\}$. \square

Theorem 18. $(\mathcal{C}^L, C_{\text{sep}}) \in \mathbf{X}$ for any log complexity measure $\mathcal{C}^L \in \text{LoC}$.

Proof. Consider the following event logs:

$$\begin{aligned}
 L_1 &= [\langle a, b, c, d, e \rangle^3, \langle e, d, c, a, b \rangle^3] \\
 L_2 &= L_1 + [\langle a, f, e, d, c, b \rangle^2] \\
 L_3 &= L_2 + [\langle g, b, c, d, e, f, c \rangle^2]
 \end{aligned}$$

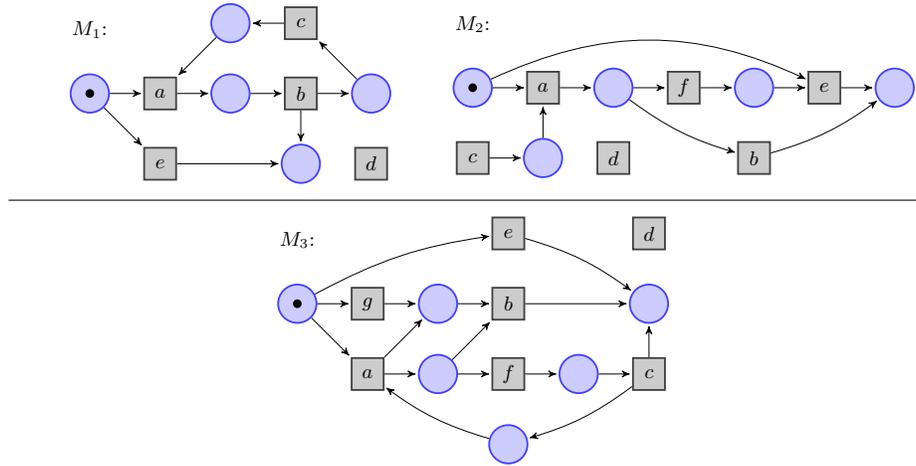


Fig. 14. The results of the alpha algorithm for the input logs L_1, L_2, L_3 from the example in Theorem 18. M_1 is the model mined from the log L_1 , M_2 the model mined from the log L_2 , and M_3 the model mined from the log L_3 .

Fig. 14 shows the models M_1, M_2, M_3 found by the alpha miner for L_1, L_2, L_3 . These models have the following separability scores:

- $C_{\text{sep}}(M_1) = 1$,
- $C_{\text{sep}}(M_2) \approx 0.7778$,
- $C_{\text{sep}}(M_3) = 1$,

so $C_{\text{sep}}(M_1) > C_{\text{sep}}(M_2)$, $C_{\text{sep}}(M_2) < C_{\text{sep}}(M_3)$, and $C_{\text{sep}}(M_1) = C_{\text{sep}}(M_3)$. But the event logs L_1, L_2, L_3 have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-%}}$
L_1	30	5	6	5	5	4	3	16	2	0.3333
L_2	42	6	8	5.25	6	7	4	21	3	0.375
L_3	56	7	10	5.6	7	20	5	27	4	0.4

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	5	0.4857	0.659	3.6	6.9315	0.301	20.7944	0.2038
L_2	5.25	0.3571	0.7031	4.0714	16.4792	0.4057	45.1709	0.2877
L_3	5.4	0.3016	0.733	4.9333	30.24	0.4447	76.6617	0.3401

Thus, $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) < \mathcal{C}^L(L_3)$ for all $\mathcal{C}^L \in (\text{LoC} \setminus \{C_{\text{affinity}}\})$. For affinity C_{affinity} , we can change the frequencies of the traces and get the event logs:

$$L_1 = [\langle a, b, c, d, e \rangle, \langle e, d, c, a, b \rangle]$$

$$L_2 = L_1 + [\langle a, f, e, d, c, b \rangle^2]$$

$$L_3 = L_2 + [\langle g, b, c, d, e, f, c \rangle^4]$$

For these event logs, we have:

- $C_{\text{affinity}}(L_1) \approx 0.1429$,
- $C_{\text{affinity}}(L_2) \approx 0.2857$, and
- $C_{\text{affinity}}(L_3) \approx 0.3367$,

but the same outputs M_1, M_2, M_3 of the alpha miner as with the previous event logs. Therefore, the separability scores from above are also valid for these logs. Thus, we showed that $(\mathcal{C}^L, C_{\text{sep}}) \in \mathbf{X}$ for all $\mathcal{C}^L \in \text{LoC}$. \square

Theorem 19. $(\mathcal{C}^L, C_{\text{diam}}) \in \mathbf{X}$ for any log complexity measure $\mathcal{C}^L \in \text{LoC}$.

Proof. Consider the following event logs:

$$\begin{aligned} L_1 &= [\langle a, b, c, d \rangle^3, \langle e \rangle^2] \\ L_2 &= L_1 + [\langle a, b, c, d \rangle^3, \langle a, b, c, b, c, d \rangle^3, \langle a, c, b, d \rangle, \langle b, c, b, c, b, c, d \rangle, \\ &\quad \langle a, b, c, f, e, f, e \rangle] \\ L_3 &= L_2 + [\langle a, b, c, b, c, b, c, b, c, d \rangle^3, \langle a, b, c, b, c, b, c, b, c, d \rangle, \\ &\quad \langle a, a, b, b, c, c, d, d \rangle, \langle e, e, f, f, g, g \rangle, \langle h, i, j, k \rangle] \end{aligned}$$

Fig. 15 shows the models M_1, M_2, M_3 found by the alpha miner for L_1, L_2, L_3 . These models have the following diameter scores:

- $C_{\text{diam}}(M_1) = 9$,
- $C_{\text{diam}}(M_2) = 7$,
- $C_{\text{diam}}(M_3) = 9$,

so these models fulfill $C_{\text{diam}}(M_1) > C_{\text{diam}}(M_2)$, $C_{\text{diam}}(M_2) < C_{\text{diam}}(M_3)$, and $C_{\text{diam}}(M_1) = C_{\text{diam}}(M_3)$. But the event logs L_1, L_2, L_3 have the following complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-}\%}$
L_1	14	5	5	2.8	4	2	3	9	2	0.4
L_2	62	6	14	4.4286	7	10	5	25	6	0.4286
L_3	122	11	21	5.8095	12	15	9	47	11	0.5238

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	2.8	0.4	0.4584	3	2.502	0.3109	5.7416	0.1554
L_2	3.5714	0.4555	0.565	3.3626	36.6995	0.5397	78.6547	0.3074
L_3	3.6667	0.4191	0.5679	5.7905	103.554	0.588	224.82	0.3836

Thus, $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) < \mathcal{C}^L(L_3)$ for all $\mathcal{C}^L \in (\text{LoC} \setminus \{C_{\text{affinity}}\})$. For affinity C_{affinity} , we can use the event logs L_1, L_2, L_3 from the introductory example of this subsection, whose models M_1, M_2, M_3 found by the alpha algorithm are shown in Fig. 8, Fig. 9, and Fig. 10. For these event logs, we have that $C_{\text{affinity}}(L_1) = 0.0476 < C_{\text{affinity}}(L_2) = 0.1357 < C_{\text{affinity}}(L_3) = 0.1498$, but $C_{\text{diam}}(M_1) = 13 < 15 = C_{\text{diam}}(M_2)$, $C_{\text{diam}}(M_2) = 15 > 13 = C_{\text{diam}}(M_3)$, and $C_{\text{diam}}(M_1) = 13 = C_{\text{diam}}(M_3)$. Thus, we showed $(\mathcal{C}^L, C_{\text{diam}}) \in \mathbf{X}$ for all log complexity measures $\mathcal{C}^L \in \text{LoC}$. \square

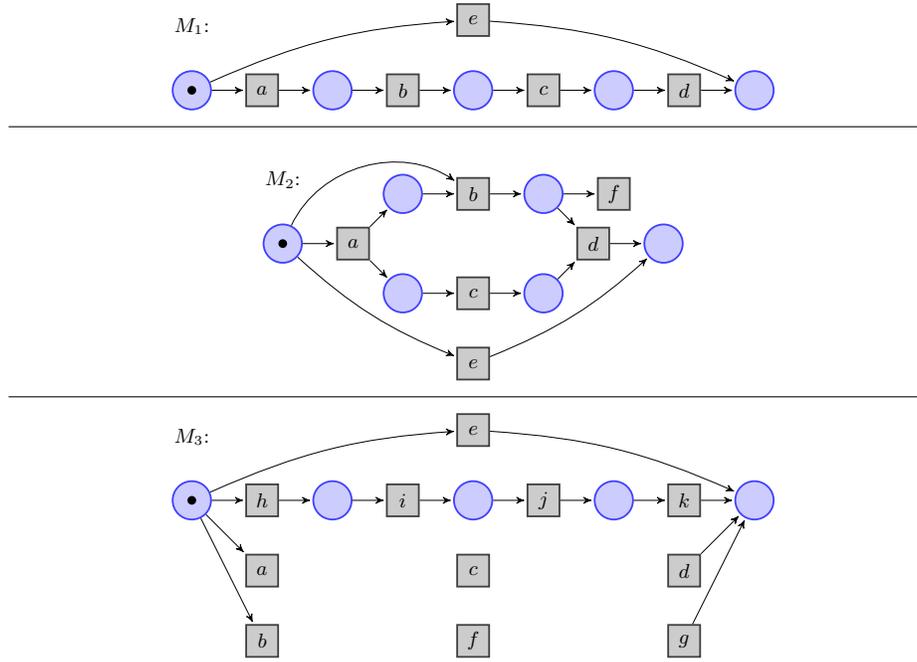


Fig. 15. The results of the alpha algorithm for the input logs L_1, L_2, L_3 from the example in Theorem 19. M_1 is the model mined from the log L_1 , M_2 the model mined from the log L_2 , and M_3 the model mined from the log L_3 .

Theorem 20. $(C^L, C_{CNC}) \in \mathbf{X}$ for any event log complexity measure $C^L \in \text{LoC}$.

Proof. Consider the following event logs:

$$L_1 = [\langle a, c, d \rangle^4, \langle b \rangle]$$

$$L_2 = L_1 + [\langle a, c, d, e \rangle, \langle b, c, d, e \rangle, \langle b, c, e, d \rangle]$$

$$L_3 = L_2 + [\langle a, c, d, e \rangle, \langle a, c, e, d \rangle, \langle a, b, c, d \rangle, \langle a, a, b, b, c, c, d, d, e, e, f, f \rangle, \langle c \rangle]$$

Fig. 16 shows the models M_1, M_2, M_3 found by the alpha miner for L_1, L_2, L_3 . These models have the following complexity scores:

- $C_{CNC}(M_1) = 1$,
- $C_{CNC}(M_2) = 1.2$,
- $C_{CNC}(M_3) = 1$,

so with this, we have $C_{CNC}(M_1) > C_{CNC}(M_2)$, $C_{CNC}(M_2) < C_{CNC}(M_3)$, and $C_{CNC}(M_1) = C_{CNC}(M_3)$. But the event logs L_1, L_2, L_3 have the following complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-}\#}$	$C_{\text{DT-}\%}$
L_1	13	4	5	2.6	3	2	2	8	2	0.4
L_2	25	5	8	3.125	4	9	4	12	5	0.625
L_3	50	6	13	3.8462	12	30	6	23	9	0.6923

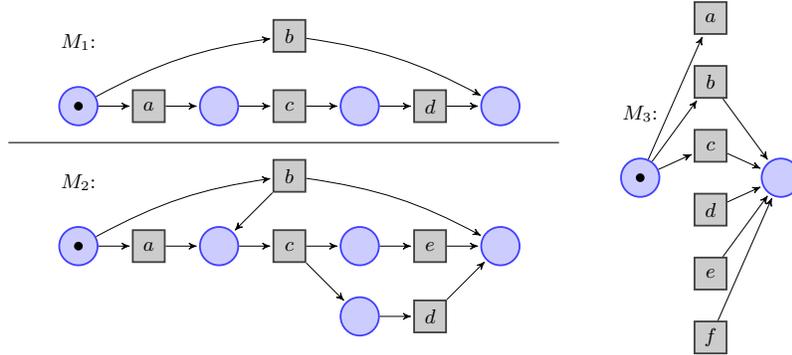


Fig. 16. The results of the alpha algorithm for the input logs L_1, L_2, L_3 from the example in Theorem 20. M_1 is the model mined from the log L_1 , M_2 the model mined from the log L_2 , and M_3 the model mined from the log L_3 .

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	2.6	0.6	0.3386	1.6	2.2493	0.4056	3.5255	0.1057
L_2	3.125	0.3702	0.5465	2.25	10.5492	0.4581	21.1028	0.2622
L_3	3.3846	0.2541	0.6768	3.2308	45.452	0.5108	73.2612	0.3745

Thus, $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) < \mathcal{C}^L(L_3)$ for all $\mathcal{C}^L \in (\text{LoC} \setminus \{C_{\text{affinity}}\})$. For affinity C_{affinity} , we can use the event logs L_1, L_2, L_3 from the introductory example of this subsection, whose models M_1, M_2, M_3 found by the alpha algorithm are shown in Fig. 8, Fig. 9, and Fig. 10. For these event logs, we have that $C_{\text{affinity}}(L_1) = 0.0476 < C_{\text{affinity}}(L_2) = 0.1357 < C_{\text{affinity}}(L_3) = 0.1498$, but at the same time we have $C_{\text{CNC}}(M_1) \approx 1.0476 < 1.0741 \approx C_{\text{CNC}}(M_2)$, $C_{\text{CNC}}(M_2) \approx 1.0741 > 1.0476 \approx C_{\text{CNC}}(M_3)$, and, furthermore, the property $C_{\text{CNC}}(M_1) \approx 1.0476 \approx C_{\text{CNC}}(M_3)$. Thus, we showed $(\mathcal{C}^L, C_{\text{CNC}}) \in \mathbf{X}$ for all log complexity measures $\mathcal{C}^L \in \text{LoC}$. \square

Theorem 21. $(\mathcal{C}^L, C_{\text{dens}}) \in \mathbf{X}$ for any log complexity measure $\mathcal{C}^L \in \text{LoC}$.

Proof. Consider the following event logs:

$$\begin{aligned}
 L_1 &= [\langle a, b, c, d \rangle^3, \langle e \rangle^2] \\
 L_2 &= L_1 + [\langle a, b, c, d \rangle^3, \langle a, c, b, d \rangle, \langle a, b, c, b, c, d \rangle^3, \langle b, c, b, c, b, c, d \rangle, \\
 &\quad \langle a, b, c, f, e, f, e \rangle] \\
 L_3 &= L_2 + [\langle a, b, c, d \rangle^3, \langle a, b, c, b, c, b, c, b, c, d \rangle^3, \langle a, b, c, b, c, b, c, b, c, b, c, d \rangle, \\
 &\quad \langle a, a, b, b, c, c, d, d \rangle, \langle e, e, f, f, g, g, e, e \rangle, \langle a, a, h, h, i, i, j, j, e, e \rangle]
 \end{aligned}$$

Fig. 17 shows the models M_1, M_2, M_3 found by the alpha miner for L_1, L_2, L_3 .

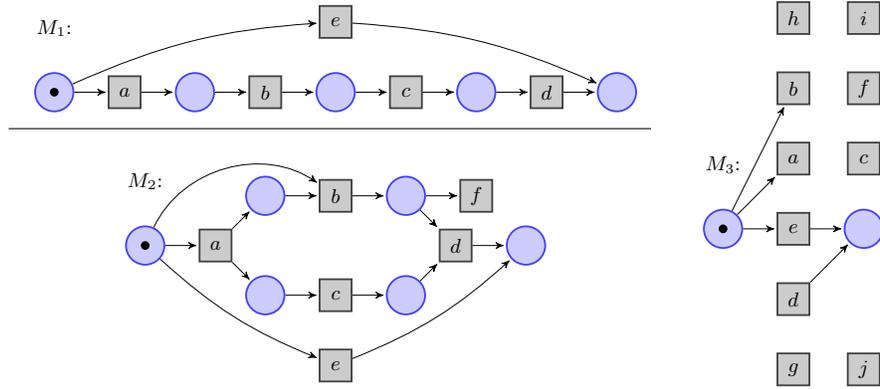


Fig. 17. The results of the alpha algorithm for the input logs L_1, L_2, L_3 from the example in Theorem 21. M_1 is the model mined from the log L_1 , M_2 the model mined from the log L_2 , and M_3 the model mined from the log L_3 .

These models have the following density scores:

- $C_{\text{dens}}(M_1) = 0.25$,
- $C_{\text{dens}}(M_2) \approx 0.2333$,
- $C_{\text{dens}}(M_3) = 0.25$,

so these models fulfill $C_{\text{dens}}(M_1) > C_{\text{dens}}(M_2)$, $C_{\text{dens}}(M_2) < C_{\text{dens}}(M_3)$, and $C_{\text{dens}}(M_1) = C_{\text{dens}}(M_3)$. But the event logs L_1, L_2, L_3 have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-}}$
L_1	14	5	5	2.8	4	2	3	9	2	0.4
L_2	62	6	14	4.4286	7	10	5	25	6	0.4286
L_3	142	10	24	5.9167	12	14	11	51	11	0.4583

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	2.8	0.4	0.4584	3	2.502	0.3109	5.7416	0.1554
L_2	3.5714	0.4555	0.565	3.3626	36.6995	0.5397	78.6547	0.3074
L_3	3.75	0.4662	0.5956	5.7029	115.926	0.5642	256.546	0.3646

Thus, $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) < \mathcal{C}^L(L_3)$ for all $\mathcal{C}^L \in \text{LoC}$, so we have just shown that $(\mathcal{C}^L, C_{\text{dens}}) \in \mathbf{X}$. \square

Theorem 22. $(\mathcal{C}^L, C_{\text{dup}}) \in =$ for any log complexity measure $\mathcal{C}^L \in \text{LoC}$.

Proof. The alpha miner constructs exactly one transition for each activity name in the event log. Since no other transitions are constructed by the algorithm, a model M found by the alpha algorithm always has $C_{\text{dup}}(M) = 0$. \square

Except for C_{dup} , none of the complexity scores of models found by the alpha miner can be described with current log complexity measures. This is because

the structure of these models highly depend on the set Y_L , which is not covered by current log complexity measures. In fact, a model M constructed by the alpha miner for an event log L has exactly $2 + |Y_L|$ places and $C_{\text{var}}(L)$ transitions. The edges present in M are also encoded in Y_L , as every element $(A, B) \in Y_L$ issues $|A| + |B|$ edges being constructed in M . Furthermore, M contains $|A_I|$ edges starting from p_i and $|A_O|$ edges ending in p_o . Regarding the connectors in the model M found by the alpha algorithm, we have:

$$\begin{aligned} S_{\text{xor}}^M &= \{(B, C) \in Y_L \mid 1 < |C|\} \cup \{(\emptyset, A_I) \mid 1 < |A_I|\} \\ J_{\text{xor}}^M &= \{(B, C) \in Y_L \mid 1 < |B|\} \cup \{(A_O, \emptyset) \mid 1 < |A_O|\} \\ S_{\text{and}}^M &= \{b \in A \mid 1 < |\{(B, C) \in Y_L \mid b \in B\}|\} \\ J_{\text{and}}^M &= \{c \in A \mid 1 < |\{(B, C) \in Y_L \mid c \in C\}|\} \end{aligned}$$

We will now describe the model complexity scores of a model M found by the alpha algorithm for an event log L over A .

- **Size** C_{size} : As argued before, M contains $2 + |Y_L|$ places and $C_{\text{var}}(L)$ transitions. Thus, $C_{\text{size}}(M) = 2 + |Y_L| + C_{\text{var}}(L)$.
- **Mismatch** C_{MM} : With the notions above, the amount of mismatches between **xor**-connectors is $MM_{\text{xor}} = \left| \sum_{(B,C) \in S_{\text{xor}}} |C| - |B| \right|$, while the amount of mismatches between **and**-connectors is

$$MM_{\text{and}} = \left| \sum_{a \in A} |\{(B, C) \in Y_L \mid a \in B\}| - |\{(B, C) \in Y_L \mid a \in C\}| \right|$$

With these notions, $C_{\text{MM}}(M) = MM_{\text{xor}} + MM_{\text{and}}$.

- **Connector Heterogeneity** C_{CH} : For the connector heterogeneity score, we take $r_{\text{xor}}^M = \frac{|S_{\text{xor}}^M \cup J_{\text{xor}}^M|}{|S_{\text{xor}}^M \cup J_{\text{xor}}^M \cup S_{\text{and}}^M \cup J_{\text{and}}^M|}$ and $r_{\text{and}}^M = \frac{|S_{\text{and}}^M \cup J_{\text{and}}^M|}{|S_{\text{xor}}^M \cup J_{\text{xor}}^M \cup S_{\text{and}}^M \cup J_{\text{and}}^M|}$ to calculate the connector heterogeneity $C_{\text{CH}}(M) = -(r_{\text{xor}}^M \cdot \log_2(r_{\text{xor}}^M) + r_{\text{and}}^M \cdot \log_2(r_{\text{and}}^M))$.
- **Cross Connectivity** C_{CC} : The cross connectivity metric depends not only on properties of single nodes, but instead on all paths through the net. While it would be possible to describe the scores of this measure with just Y_L and $C_{\text{var}}(L)$, we doubt that such a description would yield any value due to its complexity, and therefore skip this metric.
- **Token Split** C_{ts} : With the notions above, we can describe the score of the token split measure as $C_{\text{ts}}(M) = \sum_{a \in S_{\text{and}}^M} (|\{(B, C) \in Y_L \mid a \in B\}| - 1)$.
- **Control Flow Complexity** C_{CFC} : With the notions above, we describe M 's control flow complexity score by $C_{\text{CFC}}(M) = |S_{\text{and}}^M| + \sum_{(B,C) \in S_{\text{xor}}^M} |B|$.
- **Separability** C_{sep} : Like the cross connectivity metric, separability depends on the structure of the whole result, rather than properties of single nodes. A description for this measure would be highly complex and therefore of little value, so we skip this measure.
- **Average Connector Degree** C_{acd} : With the previous notions, we define $C_{\text{xor}}^M = S_{\text{xor}}^M \cup J_{\text{xor}}^M$ as the set of all **xor**-connectors, and $C_{\text{and}}^M = S_{\text{and}}^M \cup J_{\text{and}}^M$ as

the set of all **and**-connectors. The degree of an **xor**-connector (B, C) in M is $\deg((B, C)) = |B| + |C|$, while the degree of an **and**-connector a in M is $\deg(a) = |\{(B, C) \in Y_L \mid a \in B\}| + |\{(B, C) \in Y_L \mid a \in C\}|$. With this, we can describe the average connector degree of M as:

$$C_{\text{acd}}(M) = \frac{\sum_{(B,C) \in C_{\text{xor}}^M} \deg((B, C)) + \sum_{a \in C_{\text{and}}^M} \deg(a)}{|C_{\text{xor}}^M| + |C_{\text{and}}^M|}.$$

- **Maximum Connector Degree** C_{mcd} : With the same definitions for C_{xor}^M , C_{and}^M , $\deg((B, C))$ for some $(B, C) \in C_{\text{xor}}^M$, and $\deg(a)$ for some $a \in C_{\text{and}}^M$, we can describe the maximum connector degree as

$$C_{\text{mcd}}(M) = \max(\{\deg((B, C)) \mid (B, C) \in C_{\text{xor}}^M\} \cup \{\deg(a) \mid a \in C_{\text{and}}^M\}).$$

- **Sequentiality** C_{seq} : With $C_{\text{xor}}^M = S_{\text{xor}}^M \cup J_{\text{xor}}^M$ and $C_{\text{and}}^M = S_{\text{and}}^M \cup J_{\text{and}}^M$, we can describe the sequentiality score of the alpha miner result M as

$$C_{\text{seq}}(M) = \sum_{(B,C) \in (Y_L \setminus C_{\text{xor}}^M)} |\{b \in B \mid b \notin C_{\text{and}}^M\}| + |\{c \in C \mid c \notin C_{\text{and}}^M\}|.$$

- **Depth** C_{depth} : Since the depth of a node is dependent on the paths through M , we cannot describe the depth of M in simple terms. Therefore, we will skip this measure.
- **Diameter** C_{diam} : The diameter of the net is dependent on all paths through M , so we cannot describe it for M in simple terms. Therefore, we will skip this measure.
- **Cyclicity** C_{cyc} : Which nodes lie on cycles depends on the cyclic paths in the net M . We cannot describe this notion in simple terms, so we will skip this measure.
- **Coefficient of Network Connectivity** C_{CNC} : By the previous discussions, we know that M contains $2 + |Y_L| + C_{\text{var}}(L)$ nodes and $|A_I| + |A_O| + \sum_{(B,C) \in Y_L} |B| + |C|$ edges, so its coefficient of network connectivity is

$$C_{\text{CNC}}(M) = \frac{|A_I| + |A_O| + \sum_{(B,C) \in Y_L} |B| + |C|}{2 + |Y_L| + C_{\text{var}}(L)}.$$

- **Density** C_{dens} : By the previous discussions, we know that M contains exactly $2 + |Y_L|$ places, $C_{\text{var}}(L)$ transitions, and $|A_I| + |A_O| + \sum_{(B,C) \in Y_L} |B| + |C|$ edges. Thus, its density is

$$C_{\text{dens}}(M) = \frac{|A_I| + |A_O| + \sum_{(B,C) \in Y_L} |B| + |C|}{2 \cdot C_{\text{var}}(L) \cdot (1 + |Y_L|)}.$$

- **Number of Duplicate Tasks** C_{dup} : The alpha miner constructs exactly one transition for every activity name in the event log L , and no transitions beyond that. Therefore, in every model found by the alpha algorithm, each transition label occurs exactly once, giving us $C_{\text{dup}}(M) = 0$.
- **Number of Empty Sequence Flows** C_{\emptyset} : The number of empty sequence flows can be described as $C_{\emptyset}(M) = |\{(B, C) \in Y_L \mid B \subseteq S_{\text{and}}^M \wedge C \subseteq J_{\text{and}}^M\}|$.

These findings conclude our analysis of the alpha miner. Table 10 summarizes these findings for quick reference.

Table 10. The complexity scores of the alpha-model M for an event log L over A .

$C_{\text{size}}(M)$	$2 + Y_L + C_{\text{var}}(L)$
$C_{\text{MM}}(M)$	$MM_{\text{xor}} + MM_{\text{and}}$
$C_{\text{CH}}(M)$	$-(r_{\text{xor}}^M \cdot \log_2(r_{\text{xor}}^M) + r_{\text{and}}^M \cdot \log_2(r_{\text{and}}^M))$
$C_{\text{ts}}(M)$	$\sum_{a \in S_{\text{and}}^M} (\{(B, C) \in Y_L \mid a \in B\} - 1)$
$C_{\text{CFC}}(M)$	$ S_{\text{and}}^M + \sum_{(B, C) \in S_{\text{xor}}^M} B $
$C_{\text{acd}}(M)$	$\frac{\sum_{(B, C) \in C_{\text{xor}}^M} \deg((B, C)) + \sum_{a \in C_{\text{and}}^M} \deg(a)}{ C_{\text{xor}}^M + C_{\text{and}}^M }$
$C_{\text{mcd}}(M)$	$\max(\{\deg((B, C)) \mid (B, C) \in C_{\text{xor}}^M\} \cup \{\deg(a) \mid a \in C_{\text{and}}^M\})$
$C_{\text{seq}}(M)$	$\sum_{(B, C) \in (Y_L \setminus C_{\text{xor}}^M)} \{b \in B \mid b \notin C_{\text{and}}^M\} + \{c \in C \mid c \notin C_{\text{and}}^M\} $
$C_{\text{CNC}}(M)$	$\frac{ A_I + A_O + \sum_{(B, C) \in Y_L} B + C }{2 + Y_L + C_{\text{var}}(L)}$
$C_{\text{dens}}(M)$	$\frac{ A_I + A_O + \sum_{(B, C) \in Y_L} B + C }{2 \cdot C_{\text{var}}(L) \cdot (1 + Y_L)}$
$C_{\text{dup}}(M)$	0
$C_{\emptyset}(M)$	$ \{(B, C) \in Y_L \mid B \subseteq S_{\text{and}}^M \wedge C \subseteq J_{\text{and}}^M\} $

4.4 Directly Follows Graph

Often, organizations prefer the directly follows graph over Petri nets to model the behavior of their systems. This is due to the semantics of the directly follows graph (DFG) being easy to understand and requiring no further training for process analysts that have to work with the model. The graph contains one node for every activity name in the event log, alongside with a special start node \triangleright and a special end node \square . Two activity nodes a, b are connected by an edge (a, b) , if there is a trace σ in the event log, where for some $i \in \{1, \dots, |\sigma| - 1\}$, $\sigma(i) = a$ and $\sigma(i + 1) = b$. In other words, an edge (a, b) in the directly follows graph signals that a can be directly followed by b in the event log. Similarly, an edge (\triangleright, a) , for an activity name a , signals that there is a trace in the event log that starts with a . An edge (a, \square) , on the other hand, signals that there is a trace in the event log that ends with a . In this subsection, we will assume that $|supp(L)| \geq 1$ for all event logs L whose directly follows graph we compute, to avoid graphs consisting of just two nodes without any edges.

Directly follows graphs are not as expressive as Petri nets. By design, they can model exclusive choices, but not concurrency. Because this modelling language is frequently used in practice, we extend our analyses to it. To start, we first need to translate the model complexity measures to DFGs. Let $G = (V, E)$ be the directly follows graph for an event log L over a set of activities A . For a node $v \in V$, let $\text{indeg}(v) = |\{w \mid (v, w) \in E\}|$ and $\text{outdeg}(v) = |\{u \mid (u, v) \in E\}|$, as well as $\text{deg}(v) = \text{indeg}(v) + \text{outdeg}(v)$. For simplicity, we define the node sets

$$S_{\text{xor}}^G = \{v \in V \mid \text{outdeg}(v) > 1\}$$

$$J_{\text{xor}}^G = \{v \in V \mid \text{indeg}(v) > 1\}$$

as the set of **xor**-splits and **xor**-joins, as well as $C_{\text{xor}}^G = S_{\text{xor}}^G \cup J_{\text{xor}}^G$ as the set of all connector nodes in the DFG G .

- **Size** C_{size} : Similarly to a Petri net, we define the size of the DFG as the amount of its nodes, i.e., $C_{\text{size}}(G) = |V|$.
- **Connector Mismatch** C_{MM} : Since G does not contain any **and**-connectors, the amount of total connector mismatches is the amount of mismatches between **xor**-connectors. Thus, we define the connector mismatch of the directly follows graph G as $C_{\text{MM}}(G) = \left| \sum_{v \in S_{\text{xor}}^G} \text{outdeg}(v) - \sum_{v \in J_{\text{xor}}^G} \text{indeg}(v) \right|$.
- **Connector Heterogeneity** C_{CH} : Since G only contains **xor**-connectors, it does not make sense to analyze the entropy of connector types in G . We will therefore omit this complexity measure for our analyses of the directly follows graph.
- **Cross Connectivity** C_{CC} : Since the cross connectivity metric is independent of the modelling language, and thus works for any graph, we use its definition in Section 3.1 for the DFG G .
- **Token Split** C_{ts} : Since G does not contain any **and**-connectors, asking for the amount of edges introducing concurrency does not make sense for the DFG. We will thus omit this complexity measure in our analyses of the directly follows graph.

- **Control Flow Complexity** C_{CFC} : By ignoring the part of control flow complexity that evaluates the cognitive load needed for parallel splits, we get $C_{\text{CFC}}(G) = \sum_{v \in S_{\text{xor}}^G} \text{outdeg}(v)$.
- **Separability** C_{sep} : The separability measure is independent of the modeling type, as cut-vertices can occur in every graph. Thus, we use the definition of separability in Section 3.1 for the DFG G .
- **Average Connector Degree** C_{acd} : With our definition of connectors C_{xor}^G in the DFG G , we get $C_{\text{acd}}(G) = \frac{\sum_{v \in C_{\text{xor}}^M} \text{deg}(v)}{|C_{\text{xor}}^G|}$.
- **Maximum Connector Degree** C_{mcd} : With our definition of connectors C_{xor}^G in the DFG G , we get $C_{\text{mcd}}(G) = \max\{\text{deg}(v) \mid v \in C_{\text{xor}}^M\}$.
- **Sequentiality** C_{seq} : With the definition of C_{xor}^G , we can define the sequentiality of a DFG G as $C_{\text{seq}}(G) = 1 - \frac{1}{|E|} \cdot |\{(u, v) \in E \mid u, v \notin C_{\text{xor}}^G\}|$.
- **Depth** C_{depth} : We reuse the definition of depth shown in Section 3.1 by setting $S^G = S_{\text{xor}}^G$ and $\mathcal{J}^G = \mathcal{J}_{\text{xor}}^G$.
- **Diameter** C_{diam} : Since the length of the longest path through the net is independent of the modelling language, we can reuse the definition for C_{depth} from Section 3.1.
- **Cyclicity** C_{cyc} : The notion of cycles is independent of the modelling language and can be used on any graph. Since the special nodes \triangleright and \square of G can never lie on a cycle, we reuse the definition from Section 3.1 and define $C_{\text{cyc}}(G) = \frac{|\{v \in V \mid v \text{ lies on a cycle in } G\}|}{|V|-2}$.
- **Coefficient of Network Connectivity** C_{CNC} : Similar to the complexity measure for Petri nets, we define $C_{\text{CNC}}(G) = \frac{|E|}{|V|}$.
- **Density** C_{dens} : In contrast to Petri nets, the DFG can contain edges between all nodes, with two exceptions: The start node \triangleright can have only outgoing edges, so $(a, \triangleright) \notin E$ for all $a \in A \cup \{\square\}$. The end node \square can have only incoming edges, so $(\square, a) \notin E$ for all $a \in A \cup \{\triangleright\}$. Thus, we define $C_{\text{dens}}(G) = \frac{|E|}{|V| \cdot (|V|-1)}$.
- **Number of Duplicate Tasks** C_{dup} : By construction, G cannot contain duplicate labels in nodes, as $V = A \cup \{\triangleright, \square\}$. Therefore, it makes no sense to ask for the number of duplicate tasks in the DFG, and we omit this complexity measure for our analyses of the DFG.
- **Number of Empty Sequence Flows** C_0 : Since the directly follows graph does not contain any **and**-connectors, it makes no sense to ask for the number of empty sequence flows. Thus, we will omit this complexity measure for our analyses of the DFG.

With these complexity measures for the directly follows graph, we can start our analyses by first observing that the increase of some log complexity scores has no effect on the directly follows graph.

Lemma 7. *Let $\mathcal{C}^L \in (\text{LoC} \setminus \{C_{\text{var}}, C_{\text{LOD}}, C_{\text{t-comp}}\})$. Then, there are logs L_1, L_2 with $L_1 \sqsubset L_2$ and $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ such that the DFG for L_1 is the same as the one for L_2 .*

Proof. Consider the following event logs:

$$L_1 = [\langle a, b, c, c \rangle^2, \langle c, c, d, e \rangle]$$

$$L_2 = L_1 + [\langle a, b, c, d, e \rangle]$$

These event logs have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-\%}}$
L_1	12	5	3	4	4	4	4	8	2	0.6667
L_2	17	5	4	4.25	5	4	4	10	3	0.75

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	3	0.4667	0.5589	2.6667	5.5452	0.3333	7.6382	0.2562
L_2	3.5	0.4333	0.5912	2.8333	10.5492	0.4581	14.8563	0.3084

Thus, all log complexity scores except C_{affinity} increase. But the directly follows graphs for L_1 and L_2 are the same, shown in Fig. 18. For C_{affinity} , take the

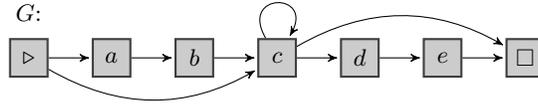


Fig. 18. The directly follows graph of event logs L_1 and L_2 in Lemma 7.

following event logs:

$$L_1 = [\langle a, b, c, c \rangle, \langle c, c, d, e \rangle]$$

$$L_2 = L_1 + [\langle a, b, c, d, e \rangle]$$

Then, $C_{\text{affinity}}(G_1) = 0.2 < 0.\bar{3} = C_{\text{affinity}}(G_2)$, but the directly follows graphs for L_1 and L_2 are the same, shown in Fig. 18.

Next, we find that some complexity measures are monotone increasing when behavior is added to the underlying event log. To make sure that all complexity scores are well-defined, we require $|\text{supp}(L)| > 1$ for all of our investigated event logs L , as logs containing only one trace seldom occur in practice and are thus not as interesting to investigate.

Lemma 8. *Let L_1, L_2 be event logs with $L_1 \sqsubset L_2$ and $|\text{supp}(L_1)| > 1$. Let G_1, G_2 be the directly follows graphs for L_1 and L_2 . Then, $\mathcal{C}^M(G_1) \leq \mathcal{C}^M(G_2)$ for any model complexity measure $\mathcal{C}^M \in \{C_{\text{size}}, C_{\text{CFC}}, C_{\text{mcd}}, C_{\text{diam}}\}$.*

Proof. We prove the conjecture for each of the complexity measures separately.

- **Size C_{size} :** Since $L_1 \sqsubset L_2$, every activity name in L_1 is also present in L_2 . Therefore, G_2 must contain all nodes from G_1 and we thus get that $C_{\text{size}}(G_1) \leq C_{\text{size}}(G_2)$.

- **Control Flow Complexity** C_{CFC} : Since $L_1 \sqsubset L_2$, every direct neighborhood in L_1 also occurs in L_2 . This means, if two activities a, b can occur directly after one another in L_1 , this is also true for L_2 , since the respective trace is contained in both event logs. Thus, if $G_1 = (V_1, E_1)$ and $G_2 = (V_2, E_2)$, we know that $V_1 \subseteq V_2$ and $E_1 \subseteq E_2$. Therefore, for all nodes $v_1 \in V_1$ and $v_2 \in V_2$, we have $\text{outdeg}(v_1) \leq \text{outdeg}(v_2)$. Therefore, every node classified as an **xor-split** in G_1 must also be classified as such in G_2 . This and the fact that these nodes have the same out-degree in G_1 and G_2 leads to $C_{\text{CFC}}(G_1) \leq C_{\text{CFC}}(G_2)$.
- **Maximum Connector Degree** C_{mcd} : Since $L_1 \sqsubset L_2$, every direct neighborhood in L_1 also occurs in L_2 . This means, if two activities a, b can occur directly after one another in L_1 , this is also true for L_2 , since the respective trace is contained in both event logs. Thus, if $G_1 = (V_1, E_1)$ and $G_2 = (V_2, E_2)$, we know that $V_1 \subseteq V_2$ and $E_1 \subseteq E_2$. Therefore, for all nodes $v_1 \in V_1$ and $v_2 \in V_2$, we have $\text{deg}(v_1) \leq \text{deg}(v_2)$. Since all nodes classified as an **xor-split** in G_1 must also be classified as such in G_2 , we get $C_{\text{mcd}}(G_1) \leq C_{\text{mcd}}(G_2)$.
- **Diameter** C_{diam} : Since $L_1 \sqsubset L_2$, every direct neighborhood in L_1 also occurs in L_2 . This means, if two activities a, b can occur directly after one another in L_1 , this is also true for L_2 , since the respective trace is contained in both event logs. Thus, if $G_1 = (V_1, E_1)$ and $G_2 = (V_2, E_2)$, we know that $V_1 \subseteq V_2$ and $E_1 \subseteq E_2$. In turn, every path in G_1 is also a path in G_2 , so the length of the longest path in G_2 is at least as long as the length of the longest path in G_1 , i.e., $C_{\text{diam}}(G_1) \leq C_{\text{diam}}(G_2)$.

Thus, we showed that $\mathcal{C}^M(G_1) \leq \mathcal{C}^M(G_2)$ for any model complexity measure $\mathcal{C}^M \in \{C_{\text{size}}, C_{\text{CFC}}, C_{\text{mcd}}, C_{\text{diam}}\}$. \square

In the directly follows graph, none of the investigated complexity measures always return the same value. Thus, we can now analyze the relations between log and model complexity for the directly follows graph. We start by showing the results in Table 11 and prove the relations in the table afterwards. For quick navigation, the PDF-version of this paper enables its readers to click on the entries of the table to jump to the proof of the respective property.

Table 11. The relations between the complexity scores of two directly follows graphs G_1 and G_2 for the event logs L_1 and L_2 , where $L_1 \sqsubset L_2$, $|supp(L_1)| > 1$, and the complexity of L_1 is lower than the complexity of L_2 .

	C_{size}	C_{MM}	C_{CC}	C_{CFC}	C_{sep}	C_{acd}	C_{mcd}	C_{seq}	C_{depth}	C_{diam}	C_{cyc}	C_{CNC}	C_{dens}
C_{mag}	\leq	X	X*	\leq	X	X	\leq	X	X	\leq	X	X	X
C_{var}	$<$	X	X*	$<$	X	X	\leq	X	X	\leq	X	X	X
C_{len}	\leq	X	X*	\leq	X	X	\leq	X	X	\leq	X	X	X
C_{TL-avg}	\leq	X	X*	\leq	X	X	\leq	X	X	\leq	X	X	X
C_{TL-max}	\leq	X	X*	\leq	X	X	\leq	X	X	\leq	X	X	X
C_{LOD}	\leq	X	X*	$<$	X	X	\leq	X	X	\leq	X	X	X
C_{t-comp}	\leq	X	X*	$<$	X	X	\leq	X	X	\leq	X	X	X
C_{LZ}	\leq	X	X*	\leq	X	X	\leq	X	X	\leq	X	X	X
$C_{DT-#}$	\leq	X	X*	\leq	X	X	\leq	X	X	\leq	X	X	X
$C_{DT-\%}$	\leq	X	X*	\leq	X	X	\leq	X	X	\leq	X	X	X
C_{struct}	\leq	X	X*	\leq	X	X	\leq	X	X	\leq	X	X	X
$C_{affinity}$	\leq	X	X*	\leq	X	X	\leq	X	X	\leq	X	X	X
C_{dev-R}	\leq	X	X*	\leq	X	X	\leq	X	X	\leq	X	X	X
$C_{avg-dist}$	\leq	X	X*	\leq	X	X	\leq	X	X	\leq	X	X	X
C_{var-e}	\leq	X	X*	\leq	X	X	\leq	X	X	\leq	X	X	X
C_{nvar-e}	\leq	X	X*	\leq	X	X	\leq	X	X	\leq	X	X	X
C_{seq-e}	\leq	X	X*	\leq	X	X	\leq	X	X	\leq	X	X	X
C_{nseq-e}	\leq	X	X*	\leq	X	X	\leq	X	X	\leq	X	X	X

*We did not find examples showing that $C^L(L_1) < C^L(L_2)$ and $C_{CC}(M_1) = C_{CC}(M_2)$ is possible.

Theorem 23. Let $C^L \in (LoC \setminus \{C_{var}\})$ be an event log complexity measure. Then, $(C^L, C_{size}) \in \leq$.

Proof. Let L_1, L_2 be event logs with $L_1 \sqsubset L_2$ and $|supp(L_1)| > 1$, and G_1, G_2 be their directly follows graphs. By Lemma 8, we know that $C_{size}(G_1) \leq C_{size}(G_2)$. What remains to be shown is that with the property $C^L(L_1) < C^L(L_2)$, both $C_{size}(G_1) = C_{size}(G_2)$ and $C_{size}(G_1) < C_{size}(G_2)$ are possible. For the former, take the following event logs:

$$L_1 = [\langle a, b, c, d \rangle^2, \langle a, b, c, d, e \rangle^2, \langle d, e, a, b \rangle^2]$$

$$L_2 = L_1 + [\langle a, b, c, d, e \rangle^2, \langle d, e, a, b, c \rangle, \langle c, d, e, a, b \rangle, \langle e, c, d, a, b, c \rangle]$$

These two event logs have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	C_{TL-avg}	C_{TL-max}	C_{LOD}	C_{t-comp}	C_{LZ}	$C_{DT-#}$	$C_{DT-\%}$
L_1	26	5	6	4.3333	5	6	5	13	3	0.5
L_2	52	5	11	4.7273	6	23	7	21	6	0.5455

	C_{struct}	$C_{affinity}$	C_{dev-R}	$C_{avg-dist}$	C_{var-e}	C_{nvar-e}	C_{seq-e}	C_{nseq-e}
L_1	4.3333	0.56	0.5757	2.6667	6.1827	0.3126	16.0483	0.1894
L_2	4.6364	0.5829	0.6039	2.9091	29.0428	0.4543	60.0209	0.2921

Thus, $C^L(L_1) < C^L(L_2)$ for any $C^L \in (LoC \setminus \{C_{var}\})$. Ignoring the node labeled f and its adjacent edges, Fig. 19 shows the directly follows graphs G_1 and G_2 for L_1 and L_2 . G_1 and G_2 fulfill $C_{size}(G_1) = 7 = C_{size}(G_2)$, so $C^L(L_1) < C^L(L_2)$

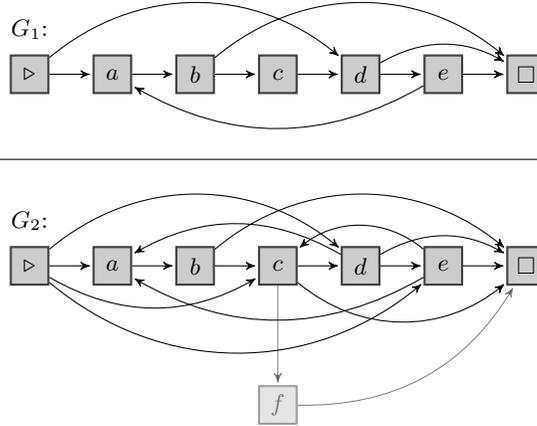


Fig. 19. The directly follows graphs for the logs L_1, L_2 from the example in Theorem 23. G_1 is the DFG for L_1 , and G_2 the one for L_2 .

and $C_{\text{size}}(G_1) = C_{\text{size}}(G_2)$ are possible. To see that $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ and at the same time $C_{\text{size}}(G_1) < C_{\text{size}}(G_2)$ is also possible, consider the following logs:

$$L_1 = [\langle a, b, c, d \rangle^2, \langle a, b, c, d, e \rangle^2, \langle d, e, a, b \rangle^2]$$

$$L_2 = L_1 + [\langle a, b, c, d, e \rangle^2, \langle d, e, a, b, c \rangle, \langle c, d, e, a, b \rangle, \langle e, c, d, a, b, c, f \rangle]$$

These two event logs have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-}}$
L_1	26	5	6	4.3333	5	6	5	13	3	0.5
L_2	53	6	11	4.8182	7	30	8	22	6	0.5455

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	4.3333	0.56	0.5757	2.6667	6.1827	0.3126	16.0483	0.1894
L_2	4.7273	0.5721	0.5995	3.0909	30.24	0.4447	62.1108	0.2952

Thus, $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ for any $\mathcal{C}^L \in (\text{LoC} \setminus \{C_{\text{var}}\})$. Fig. 19 shows the directly follows graphs G_1 and G_2 for L_1 and L_2 . As can easily be seen, these models fulfill $C_{\text{size}}(G_1) = 7 < 8 = C_{\text{size}}(G_2)$, so $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ and $C_{\text{size}}(G_1) < C_{\text{size}}(G_2)$ are also possible. \square

Theorem 24. $(C_{\text{var}}, C_{\text{size}}) \in <$.

Proof. Let L be an event log and G its directly follows graph. For each activity name occurring in L , there is exactly one node in G . Beside these nodes for activity names, there are only the nodes \triangleright and \square in the directly follows graph G . Thus, $C_{\text{size}}(G) = C_{\text{var}}(L) + 2$, so for two event logs L_1, L_2 with $L_1 \sqsubset L_2$, and their respective directly follows graphs, G_1 and G_2 , we get that the property $C_{\text{size}}(L_1) = C_{\text{var}}(L_1) + 2 < C_{\text{var}}(L_2) + 2 = C_{\text{size}}(L_2)$ always holds. \square

Theorem 25. $(\mathcal{C}^L, C_{MM}) \in \mathbf{X}$ for any log complexity measure $\mathcal{C}^L \in \text{LoC}$.

Proof. Consider the following event logs:

$$L_1 = [\langle a, b, d \rangle^2, \langle a, c, d \rangle^2, \langle e \rangle]$$

$$L_2 = L_1 + [\langle a, b, d, e \rangle, \langle a, c, d, e \rangle, \langle a, b, c, d \rangle, \langle a, b, c, b, d, e, f \rangle, \\ \langle a, b, c, b, c, b, d, e, f \rangle]$$

$$L_3 = L_2 + [\langle a, c, b, d \rangle, \langle a, c, b, c, b, d, e \rangle, \langle a, b, c, b, c, b, c, d \rangle, \langle a, b, c, b, c, b, c, b, c, d \rangle, \\ \langle a, a, b, b, c, c, d, d, e, e, f, f, g \rangle]$$

Fig. 20 shows the directly follows graphs G_1, G_2, G_3 for the event logs L_1, L_2, L_3 . These graphs have the following complexity scores:

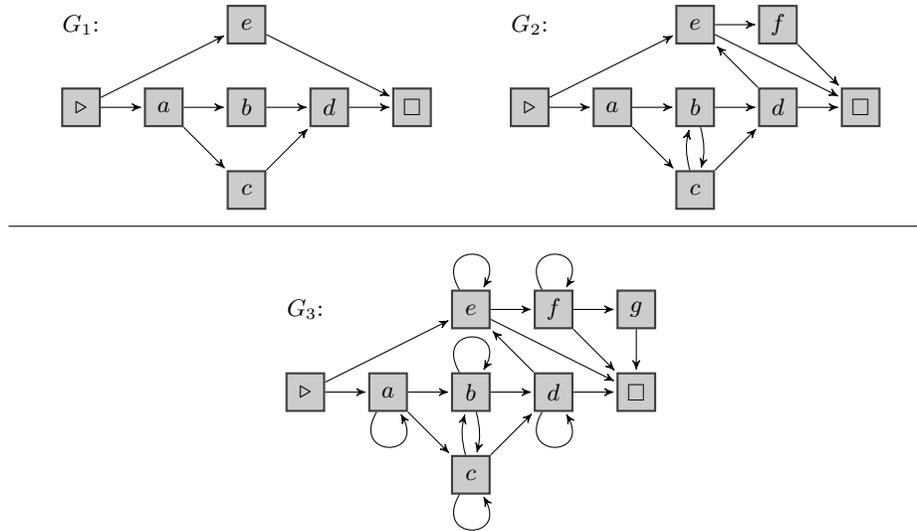


Fig. 20. The directly follows graphs for the logs L_1, L_2, L_3 from the example in Theorem 25. G_1 is the DFG for L_1 , G_2 the one for L_2 and G_3 the one for L_3 .

- $C_{MM}(G_1) = 0$,
- $C_{MM}(G_2) = 1$,
- $C_{MM}(G_3) = 0$,

so $C_{MM}(G_1) < C_{MM}(G_2)$, $C_{MM}(G_2) > C_{MM}(G_3)$, and $C_{MM}(G_1) = C_{MM}(G_3)$. But the event logs L_1, L_2, L_3 have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-}\%}$
L_1	13	5	5	2.6	3	3	4	8	3	0.6
L_2	41	6	10	4.1	9	14	6	18	8	0.8
L_3	83	7	15	5.5333	13	19	7	34	13	0.8667

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	2.6	0.2	0.5417	2.4	6.0684	0.5645	11.1636	0.3348
L_2	3.7	0.2316	0.6705	3.1333	32.1247	0.5742	61.0512	0.401
L_3	4.0667	0.2384	0.6875	4.6095	91.73	0.5843	172.88	0.4714

Since $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) < \mathcal{C}^L(L_3)$ for any log complexity measure $\mathcal{C}^L \in \text{LoC}$, we have thus shown that $(\mathcal{C}^L, C_{\text{MM}}) \in \mathbf{X}$. \square

Theorem 26. $(\mathcal{C}^L, C_{\text{CC}}) \in \mathbf{X}$ for any log complexity measure $\mathcal{C}^L \in \text{LoC}$.

Proof. Consider the following event logs:

$$\begin{aligned}
 L_1 &= [\langle a, b \rangle^5, \langle c, d \rangle, \langle e, f \rangle, \langle g \rangle] \\
 L_2 &= L_1 + [\langle a, b, c, d \rangle, \langle s, t, u, v, w, x, y, z \rangle] \\
 L_3 &= L_2 + [\langle h, i, j, k, l, m, n, o, p \rangle]
 \end{aligned}$$

Fig. 21 shows the directly follows graphs G_1, G_2, G_3 for the event logs L_1, L_2, L_3 .

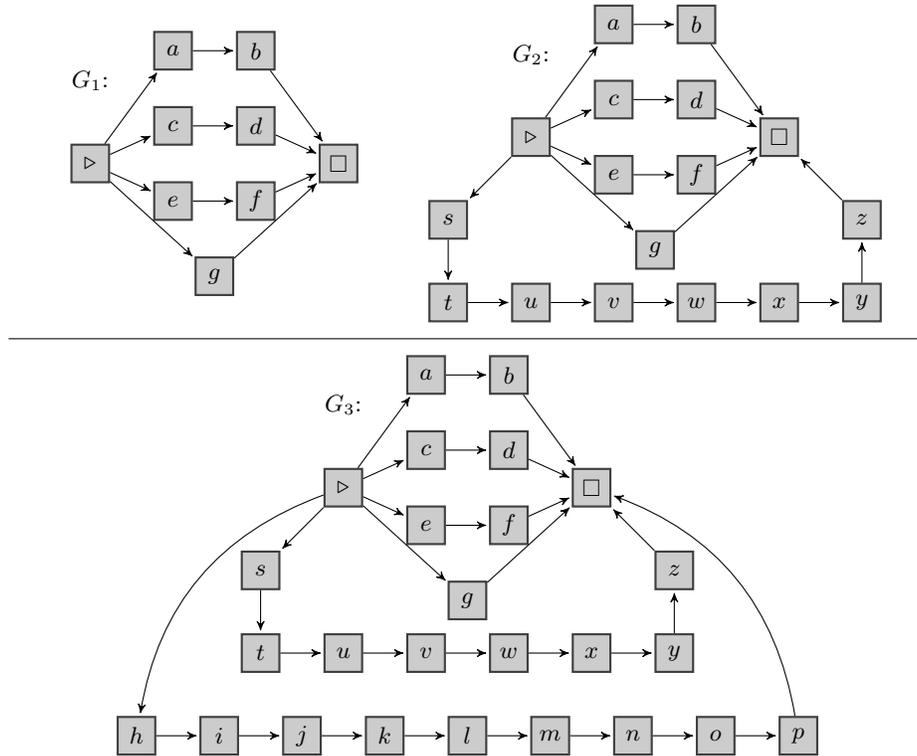


Fig. 21. The directly follows graphs for the logs L_1, L_2, L_3 from the example in Theorem 26. G_1 is the DFG for L_1 , G_2 the one for L_2 and G_3 the one for L_3 .

These graphs have the following complexity scores:

- $C_{CC}(M_1) \approx 0.8333$,
- $C_{CC}(M_2) \approx 0.8245$,
- $C_{CC}(M_3) \approx 0.8558$,

so $C_{CC}(M_1) > C_{CC}(M_2)$, and $C_{CC}(M_2) < C_{CC}(M_3)$. But the logs L_1, L_2, L_3 have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-\%}}$
L_1	15	7	8	1.875	2	4	3	10	4	0.5
L_2	27	15	10	2.7	8	6	11	19	6	0.6
L_3	36	24	11	3.2727	9	7	19	28	7	0.6364

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	1.875	0.3571	0.2716	2.3214	9.4625	0.6947	14.8223	0.3649
L_2	2.7	0.2667	0.5937	3.9778	23.2113	0.4819	32.6327	0.3667
L_3	3.2727	0.2182	0.7009	5.3818	39.9822	0.472	52.8767	0.4099

Therefore, $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) < \mathcal{C}^L(L_3)$ for any event log complexity measure $\mathcal{C}^L \in (\text{LoC} \setminus \{C_{\text{affinity}}, C_{\text{nvar-e}}\})$. For C_{affinity} and $C_{\text{nvar-e}}$, consider the following event logs:

$$\begin{aligned} L_1 &= [\langle a, b, c, d \rangle, \langle c, d, e, f \rangle, \langle e, f, g \rangle, \langle a, b \rangle, \langle c, d \rangle, \langle e, f \rangle, \langle g \rangle] \\ L_2 &= L_1 + [\langle a, b, c, d \rangle^2, \langle q, r, s, t \rangle, \langle u, v, w, x, y, z \rangle] \\ L_3 &= L_2 + [\langle a, b, c, d \rangle^3, \langle h \rangle, \langle i \rangle, \langle j \rangle] \end{aligned}$$

Fig. 22 shows the directly follows graphs G_1, G_2, G_3 for the event logs L_1, L_2, L_3 . These graphs have the following complexity scores:

- $C_{CC}(G_1) \approx 0.9086$,
- $C_{CC}(G_2) \approx 0.8867$,
- $C_{CC}(G_3) \approx 0.9108$,

so $C_{CC}(G_1) > C_{CC}(G_2)$, and $C_{CC}(G_2) < C_{CC}(G_3)$. But the event logs L_1, L_2, L_3 have the following complexity scores:

	C_{affinity}	$C_{\text{nvar-e}}$
L_1	0.1087	0.5175
L_2	0.1276	0.5488
L_3	0.1589	0.6187

Thus, in total, we were able to show $(\mathcal{C}^L, C_{CC}) \in \mathbf{X}$ for all $\mathcal{C}^L \in \text{LoC}$. \square

Theorem 27. *Let $\mathcal{C}^L \in (\text{LoC} \setminus \{C_{\text{var}}, C_{\text{LOD}}, C_{\text{t-comp}}\})$ be an event log complexity measure. Then, $(\mathcal{C}^L, C_{CFC}) \in \leq$.*

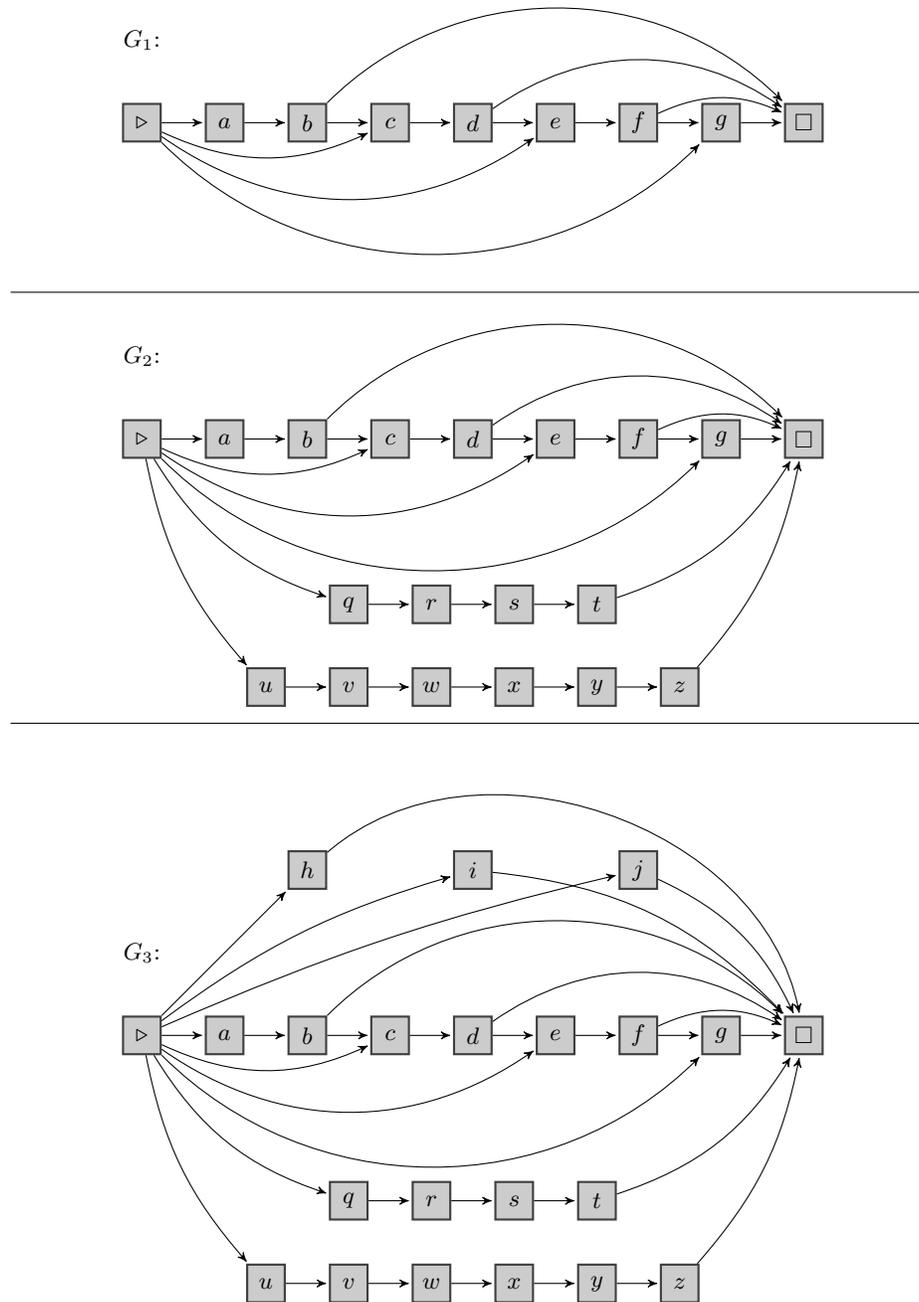


Fig. 22. The directly follows graphs for the logs L_1, L_2, L_3 from the example in Theorem 26. G_1 is the DFG for L_1 , G_2 the one for L_2 and G_3 the one for L_3 .

Proof. By Lemma 7, it is possible to increase the log complexity score for \mathcal{C}^L without changing the directly follows graph. Thus, we know that there are event logs L_1, L_2 with $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$, such that their directly follows graphs G_1, G_2 fulfill $C_{\text{CFC}}(G_1) = C_{\text{CFC}}(G_2)$. To see that $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ and, at the same time, $C_{\text{CFC}}(G_1) < C_{\text{CFC}}(G_2)$ is also possible, consider the following event logs:

$$\begin{aligned} L_1 &= [\langle a, b, c, d \rangle^2, \langle a, b, c, d, e \rangle^2, \langle d, e, a, b \rangle^2] \\ L_2 &= L_1 + [\langle a, b, c, d, e \rangle^2, \langle d, e, a, b, c \rangle, \langle c, d, e, a, b \rangle, \langle e, c, d, a, b, c, f \rangle] \end{aligned}$$

These two event logs have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-}}$
L_1	26	5	6	4.3333	5	6	5	13	3	0.5
L_2	53	6	11	4.8182	7	30	8	22	6	0.5455

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	4.3333	0.56	0.5757	2.6667	6.1827	0.3126	16.0483	0.1894
L_2	4.7273	0.5721	0.5995	3.0909	30.24	0.4447	62.1108	0.2952

Thus, $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ for any $\mathcal{C}^L \in (\text{LoC} \setminus \{C_{\text{var}}, C_{\text{LOD}}, C_{\text{t-comp}}\})$. Fig. 19 shows the directly follows graphs G_1 and G_2 for L_1 and L_2 . These models fulfill $C_{\text{CFC}}(G_1) = 8 < 15 = C_{\text{CFC}}(G_2)$, so $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ and, at the same time, $C_{\text{CFC}}(G_1) < C_{\text{CFC}}(G_2)$ is also possible. \square

Theorem 28. *Let $\mathcal{C}^L \in \{C_{\text{var}}, C_{\text{LOD}}, C_{\text{t-comp}}\}$ be an event log complexity measure. Then, $(\mathcal{C}^L, C_{\text{CFC}}) \in <$.*

Proof. The control flow complexity C_{CFC} is the number of arcs that leave split nodes in the directly follows graphs. We will now show that this amount increases when C_{var} , C_{LOD} , or $C_{\text{t-comp}}$ increase for the underlying event log. Let L_1, L_2 be event logs with $L_1 \sqsubset L_2$, and G_1, G_2 the directly follows graphs for L_1 and L_2 .

- **Variety C_{var} :** Suppose $C_{\text{var}}(L_1) < C_{\text{var}}(L_2)$. Then, there is a fresh trace $\sigma \in \text{supp}(L_2) \setminus \text{supp}(L_1)$, containing an activity a that does not occur in L_1 . By construction, all nodes in the directly follows graph lie on a path from \triangleright to \square , so there is a path $\triangleright, v_1, \dots, v_k, a$ for some nodes v_1, \dots, v_k in G_2 that does not exist in G_1 . But then, either \triangleright or a v_i for some $i \in \{1, \dots, k\}$ must have a new outgoing edge in G_2 that does not exist in G_1 . In turn, this node is a split node in G_2 and has one more outgoing edge than in G_1 . Since all edges of G_1 are also part of G_2 , this implies $C_{\text{CFC}}(G_1) < C_{\text{CFC}}(G_2)$.
- **Level of Detail C_{LOD} :** Suppose $C_{\text{LOD}}(L_1) < C_{\text{LOD}}(L_2)$. Then, there is a new path $\triangleright, v_1, \dots, v_k, \square$ in G_2 that does not exist in G_1 . In turn, there must be an edge (a, b) in G_2 that does not exist in G_1 . Because a lies on a path from \triangleright to \square in G_1 , and all edges of G_1 are also edges in G_2 , this means $\text{outdeg}(a) > 1$. Thus, a is a split node in G_2 with more than one outgoing edge than in G_1 . Since all edges of G_1 are also part of G_2 , this implies $C_{\text{CFC}}(G_1) < C_{\text{CFC}}(G_2)$.

- **Number of Ties $C_{t\text{-comp}}$:** Suppose $C_{t\text{-comp}}(L_1) < C_{t\text{-comp}}(L_2)$. Then, by definition, there must be a pair (a, b) with $a >_{L_2} b$ and $b \not>_{L_2} a$, but $a \not>_{L_1} b$ or $b >_{L_1} a$. Since $L_1 \sqsubset L_2$, of the latter, only $a \not>_{L_1} b$ can be true, so there is no connection between a and b in G_1 . But because $a >_{L_2} b$, we know that (a, b) is an edge in G_2 , so a has one more outgoing arc in G_2 than in G_1 . Because a must lie on a path from \triangleright to \square in G_1 , this means that a is a connector in G_2 with one more outgoing edge than in G_1 . Since all edges of G_1 are also part of G_2 , this implies $C_{\text{CFC}}(G_1) < C_{\text{CFC}}(G_2)$.

Thus, $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ implies $C_{\text{CFC}}(G_1) < C_{\text{CFC}}(G_2)$ for any event log complexity measure $\mathcal{C}^L \in \{C_{\text{var}}, C_{\text{LOD}}, C_{t\text{-comp}}\}$. \square

Theorem 29. $(\mathcal{C}^L, C_{\text{sep}}) \in \mathbf{X}$ for any log complexity measure $\mathcal{C}^L \in \text{LoC}$.

Proof. Consider the following event logs:

$$\begin{aligned} L_1 &= [\langle a \rangle, \langle a, b, c \rangle] \\ L_2 &= L_1 + [\langle a, b, c \rangle, \langle i, j, k, l, m \rangle] \\ L_3 &= L_2 + [\langle a, b, c \rangle^2, \langle a, c, d \rangle, \langle a, c, e \rangle, \langle i, j, x, j, k, y, k, l, z, l, m \rangle] \end{aligned}$$

Fig. 23 shows the directly follows graphs G_1, G_2, G_3 for the event logs L_1, L_2, L_3 . These graphs have the following complexity scores:

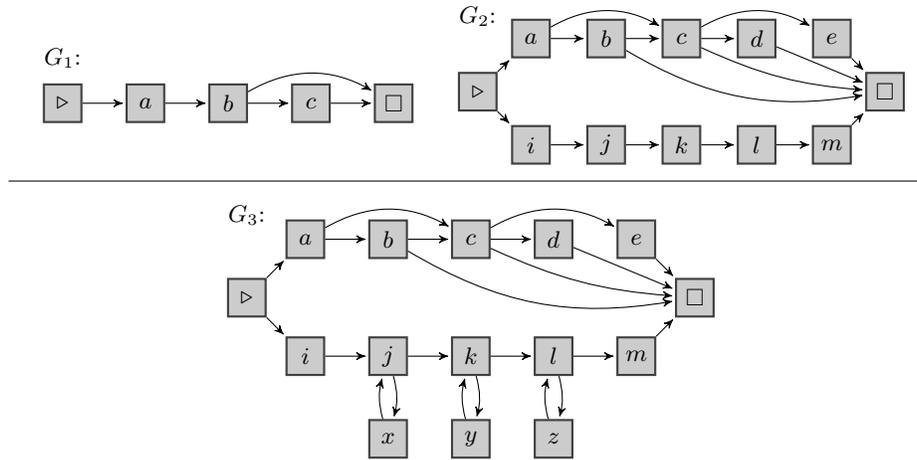


Fig. 23. The directly follows graphs for the logs L_1, L_2, L_3 from the example in Theorem 29. G_1 is the DFG for L_1 , G_2 the one for L_2 and G_3 the one for L_3 .

- $C_{\text{sep}}(G_1) = 2.8$,
- $C_{\text{sep}}(G_2) = 3$,
- $C_{\text{sep}}(G_3) = 2.8$,

so $C_{\text{sep}}(G_1) < C_{\text{sep}}(G_2)$, $C_{\text{sep}}(G_2) > C_{\text{sep}}(G_3)$, and $C_{\text{sep}}(G_1) = C_{\text{sep}}(G_3)$. But the logs L_1, L_2, L_3 have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-}\%}$
L_1	4	3	2	2	3	2	2	3	2	1
L_2	12	8	4	3	5	3	6	9	3	0.75
L_3	35	13	9	3.8889	11	8	9	22	6	0.6667

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	2	0	0.3764	2	0	0	0	0
L_2	3	0.1667	0.5854	4.3333	5.2925	0.3181	8.1503	0.2733
L_3	3.5556	0.187	0.7122	5.1667	27.4103	0.4575	47.1242	0.3787

Thus, we have $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) < \mathcal{C}^L(L_3)$ for any event log complexity measure $\mathcal{C}^L \in (\text{LoC} \setminus \{C_{\text{DT-}\%}\})$. For $C_{\text{DT-}\%}$, take the following event logs:

$$\begin{aligned} L_1 &= [\langle a \rangle, \langle a, b, c \rangle^3] \\ L_2 &= L_1 + [\langle i, j, k, l, m \rangle] \\ L_3 &= L_2 + [\langle a, c, d \rangle, \langle a, c, e \rangle, \langle i, j, x, j, k, y, k, l, z, l, m \rangle] \end{aligned}$$

In contrast to the previous ones, only the frequencies changed, so the directly follows graphs G_1, G_2, G_3 for these event logs are the same as in Fig. 23. But since $C_{\text{DT-}\%}(L_1) = 0.5 < C_{\text{DT-}\%}(L_2) = 0.6 < C_{\text{DT-}\%}(L_3) = 0.75$, we now know that $(\mathcal{C}^L, C_{\text{sep}}) \in \mathbf{X}$ for any event log complexity measure $\mathcal{C}^L \in \text{LoC}$. \square

Theorem 30. $(\mathcal{C}^L, C_{\text{acd}}) \in \mathbf{X}$ for any event log complexity measure $\mathcal{C}^L \in \text{LoC}$.

Proof. Consider the following event logs:

$$\begin{aligned} L_1 &= [\langle a, b \rangle^3, \langle c \rangle, \langle d \rangle, \langle e \rangle] \\ L_2 &= L_1 + [\langle a, g, b \rangle] \\ L_3 &= L_2 + [\langle h, i, j, k \rangle] \end{aligned}$$

Fig. 24 shows the directly follows graphs G_1, G_2, G_3 for the event logs L_1, L_2, L_3 . These graphs have the following complexity scores:

- $C_{\text{acd}}(G_1) = 4$,
- $C_{\text{acd}}(G_2) = 3.5$,
- $C_{\text{acd}}(G_3) = 4$,

so $C_{\text{acd}}(G_1) > C_{\text{acd}}(G_2)$, $C_{\text{acd}}(G_2) < C_{\text{acd}}(G_3)$, and $C_{\text{acd}}(G_1) = C_{\text{acd}}(G_3)$. But the logs L_1, L_2, L_3 have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-}\%}$
L_1	9	5	6	1.5	2	4	1	6	4	0.6667
L_2	12	6	7	1.7143	3	5	3	7	5	0.7143
L_3	16	10	8	2	4	6	6	11	6	0.75

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	1.5	0.2	0.0202	2.2	6.6609	0.8277	9.0245	0.4564
L_2	1.7143	0.1429	0.358	2.2857	10.8488	0.7965	14.8112	0.4967
L_3	2	0.1071	0.5431	3.1429	18.0591	0.6847	23.8086	0.5367

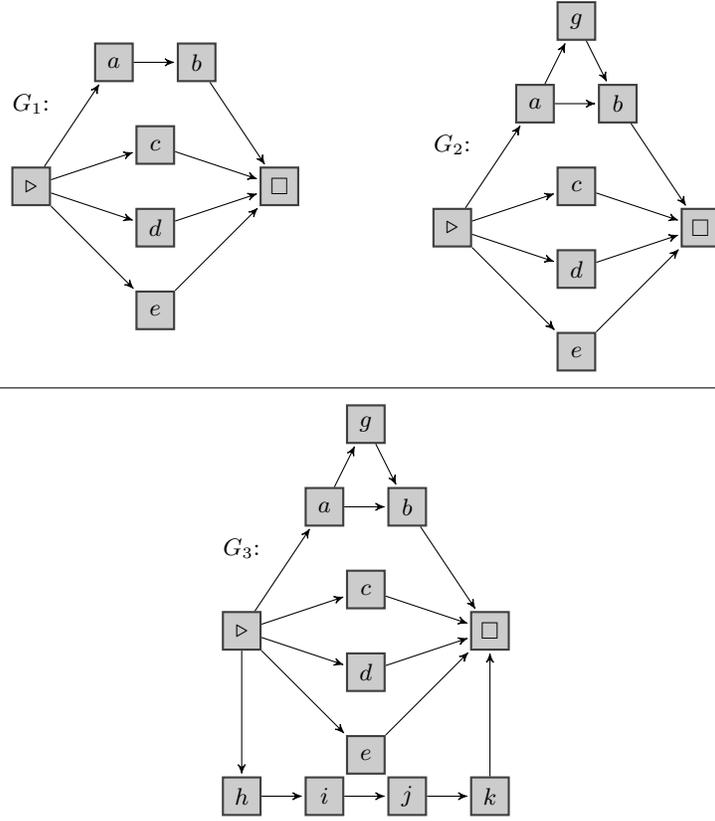


Fig. 24. The directly follows graphs for the logs L_1, L_2, L_3 from the example in Theorem 30. G_1 is the DFG for L_1 , G_2 the one for L_2 and G_3 the one for L_3 .

Thus, we have $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) < \mathcal{C}^L(L_3)$ for any event log complexity measure $\mathcal{C}^L \in (LoC \setminus \{C_{\text{affinity}}, C_{\text{nvar-e}}\})$. For C_{affinity} and $C_{\text{nvar-e}}$, take the following logs:

$$\begin{aligned} L_1 &= [\langle a, b \rangle, \langle c, x \rangle, \langle d, y \rangle, \langle e, z \rangle] \\ L_2 &= L_1 + [\langle a, b \rangle, \langle a, g, b \rangle] \\ L_3 &= L_2 + [\langle c, x \rangle, \langle h, i \rangle] \end{aligned}$$

Fig. 25 shows the directly follows graphs G_1, G_2, G_3 for these logs L_1, L_2, L_3 . These graphs have the following complexity scores:

- $C_{\text{acd}}(G_1) = 4$,
- $C_{\text{acd}}(G_2) = 3.5$,
- $C_{\text{acd}}(G_3) = 4$,

so $C_{\text{acd}}(G_1) > C_{\text{acd}}(G_2)$, $C_{\text{acd}}(G_2) < C_{\text{acd}}(G_3)$, and $C_{\text{acd}}(G_1) = C_{\text{acd}}(G_3)$. But $C_{\text{affinity}}(L_1) = 0 < C_{\text{affinity}}(L_2) \approx 0.0667 < C_{\text{affinity}}(L_3) \approx 0.0714$, and

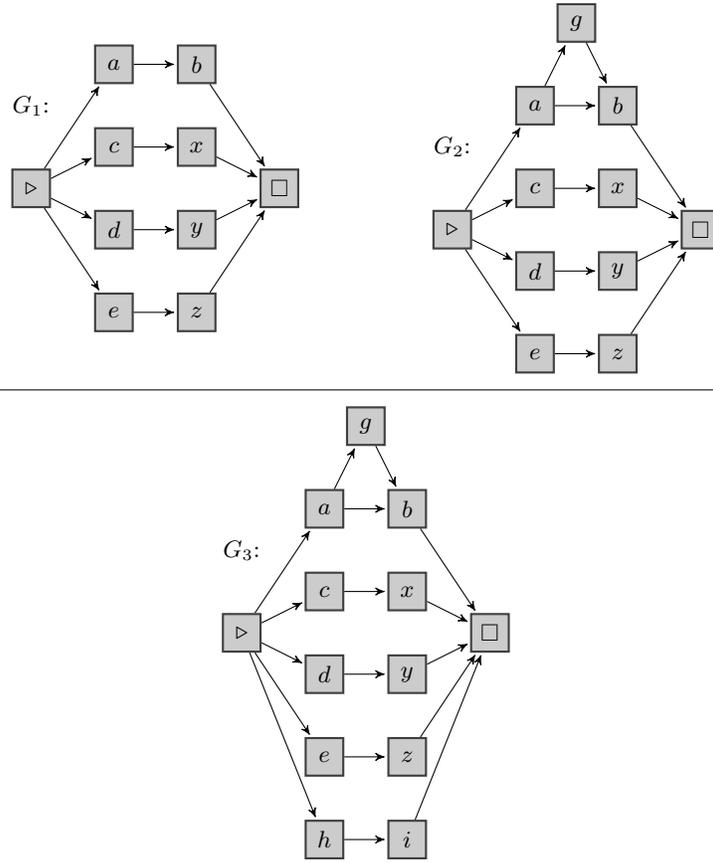


Fig. 25. The directly follows graphs for the logs L_1, L_2, L_3 from the example in Theorem 30. G_1 is the DFG for L_1 , G_2 the one for L_2 and G_3 the one for L_3 .

$C_{\text{nvar-e}}(L_1) \approx 0.6667 < C_{\text{nvar-e}}(L_2) \approx 0.699 < C_{\text{nvar-e}}(L_3) \approx 0.7211$. Thus, we have shown that $(\mathcal{C}^L, C_{\text{acd}}) \in \mathbf{X}$ for all log complexity measures $\mathcal{C}^L \in \text{LoC}$. \square

Theorem 31. Let $\mathcal{C}^L \in \text{LoC}$ be an arbitrary event log complexity measure and let $\mathcal{C}^M \in \{C_{\text{mcd}}, C_{\text{diam}}\}$ be a model complexity measure. Then, $(\mathcal{C}^L, \mathcal{C}^M) \in \leq$.

Proof. Let L_1, L_2 be event logs with $L_1 \sqsubset L_2$ and $|\text{supp}(L_1)| > 1$, and G_1, G_2 be their directly follows graphs. By Lemma 8, we know that $C_{\text{mcd}}(G_1) \leq C_{\text{mcd}}(G_2)$ and $C_{\text{diam}}(G_1) \leq C_{\text{diam}}(G_2)$. What remains to be shown is that with $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$, both $\mathcal{C}^M(G_1) = \mathcal{C}^M(G_2)$ and $\mathcal{C}^M(G_1) < \mathcal{C}^M(G_2)$ are possible. For the former, take the following event logs:

$$L_1 = [\langle a, b, c, c \rangle, \langle c \rangle^2, \langle c, c, d, e \rangle]$$

$$L_2 = L_1 + [\langle a, b, c, d, e \rangle, \langle a, b, f, f, d, e \rangle, \langle a, b, f, f, f, d, e \rangle, \langle a, b, f, f, f, f, d, e \rangle^2]$$

These two event logs have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-\%}}$
L_1	10	5	4	2.5	4	4	4	7	3	0.75
L_2	44	6	9	4.8889	8	5	6	21	7	0.7778

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	2	0.2	0.5731	2.6667	5.5452	0.3333	6.7301	0.2923
L_2	3.6667	0.2857	0.6353	4.9444	35.3011	0.5892	71.9231	0.432

Thus, $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ for any $\mathcal{C}^L \in \text{LoC}$. Fig. 26 shows the directly follows graphs G_1, G_2 for L_1 and L_2 . G_1 and G_2 fulfill $C_{\text{mcd}}(G_1) = 6 = C_{\text{mcd}}(G_2)$ and

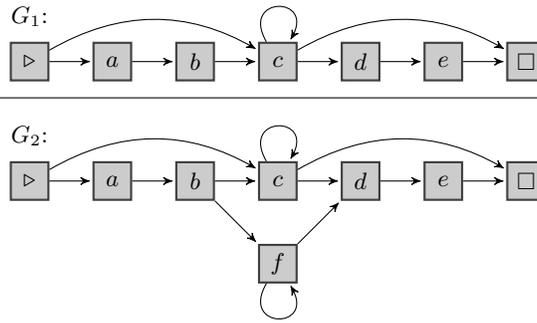


Fig. 26. The directly follows graph for the event logs L_1 and L_2 of Theorem 31.

$C_{\text{diam}}(G_1) = 7 = C_{\text{diam}}(G_2)$, so $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ and $\mathcal{C}^M(G_1) = \mathcal{C}^M(G_2)$ is possible for any $\mathcal{C}^M \in \{C_{\text{mcd}}, C_{\text{diam}}\}$. To see that $C_{\text{mcd}}(G_1) < C_{\text{mcd}}(G_2)$ and $C_{\text{diam}}(G_1) < C_{\text{diam}}(G_2)$ is also possible when $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$, consider the following event logs:

$$L_1 = [\langle a, b, c, c \rangle, \langle c \rangle^2, \langle c, c, d, e \rangle]$$

$$L_2 = L_1 + [\langle a, b, c, d, e \rangle, \langle a, b, f, f, d, e \rangle, \langle a, b, f, f, f, d, e \rangle, \langle a, b, f, f, f, f, d, e \rangle^2, \langle a, c, c, d, e, g \rangle]$$

These two event logs have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-\%}}$
L_1	10	5	4	2.5	4	4	4	7	3	0.75
L_2	50	7	10	5	8	11	8	24	8	0.8

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	2	0.2	0.5731	2.6667	5.5452	0.3333	6.7301	0.2923
L_2	3.8	0.2613	0.656	5.0222	47.8112	0.5941	89.2321	0.4562

Fig. 27 shows the directly follows graphs G_1, G_2 for L_1 and L_2 . These graphs fulfill $C_{\text{acd}}(G_1) = 6 < 7 = C_{\text{acd}}(G_2)$ and $C_{\text{diam}}(G_1) = 7 < 8 = C_{\text{diam}}(G_2)$, which shows that $\mathcal{C}^M(G_1) < \mathcal{C}^M(G_2)$ is also possible for $\mathcal{C}^M \in \{C_{\text{acd}}, C_{\text{diam}}\}$, when $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ for any $\mathcal{C}^L \in \text{LoC}$. \square

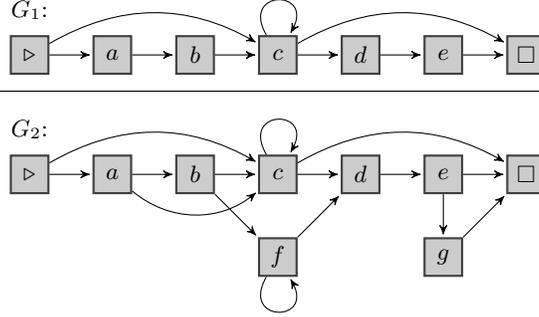


Fig. 27. The directly follows graph for the event logs L_1 and L_2 of Theorem 31.

Theorem 32. $(\mathcal{C}^L, C_{seq}) \in \mathbf{X}$ for any event log complexity measure $\mathcal{C}^L \in \text{LoC}$.

Proof. Consider the following event logs:

$$\begin{aligned} L_1 &= [\langle a, b, d, e \rangle^2, \langle a, c, d, e \rangle^2, \langle a, b, c, d, e \rangle, \langle e \rangle] \\ L_2 &= L_1 + [\langle a, b, d, a, c, d \rangle^2, \langle a, b, c, d, e, f, g \rangle] \\ L_3 &= L_2 + [\langle a, b, d, a, b, d, a, c, d \rangle, \langle a, b, c, d, e, f, h \rangle] \end{aligned}$$

Fig. 28 shows the directly follows graphs G_1, G_2, G_3 for the event logs L_1, L_2, L_3 . These graphs have the following complexity scores:

- $C_{seq}(G_1) = 1$,
- $C_{seq}(G_2) \approx 0.9286$,
- $C_{seq}(G_3) = 1$,

so $C_{seq}(G_1) > C_{seq}(G_2)$, $C_{seq}(G_2) < C_{seq}(G_3)$, and $C_{seq}(G_1) = C_{seq}(G_3)$. But the logs L_1, L_2, L_3 have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	C_{TL-avg}	C_{TL-max}	C_{LOD}	C_{t-comp}	C_{LZ}	$C_{DT-\#}$	$C_{DT-\%}$
L_1	22	5	6	3.6667	5	4	6	12	4	0.6667
L_2	41	7	9	4.5556	7	11	9	19	6	0.6667
L_3	57	8	11	5.1818	9	15	10	25	8	0.7273

	C_{struct}	$C_{affinity}$	C_{dev-R}	$C_{avg-dist}$	C_{var-e}	C_{nvar-e}	C_{seq-e}	C_{nseq-e}
L_1	3.6667	0.2933	0.5961	1.8667	14.24	0.5399	24.1377	0.355
L_2	4.1111	0.3026	0.6449	3.0556	24.1774	0.545	54.2052	0.356
L_3	4.3636	0.3259	0.6543	3.7818	39.7717	0.5849	87.744	0.3807

Therefore, $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) < \mathcal{C}^L(L_3)$ for any event log complexity measure $\mathcal{C}^L \in (\text{LoC} \setminus \{C_{DT-\%}\})$. For $C_{DT-\%}$, consider the following event logs:

$$\begin{aligned} L_1 &= [\langle a, b, d, e \rangle^3, \langle a, c, d, e \rangle^2, \langle a, b, c, d, e \rangle, \langle e \rangle] \\ L_2 &= L_1 + [\langle a, b, d, a, c, d \rangle^2, \langle a, b, c, d, e, f, g \rangle] \\ L_3 &= L_2 + [\langle a, b, d, a, b, d, a, c, d \rangle, \langle a, b, c, d, e, f, h \rangle] \end{aligned}$$

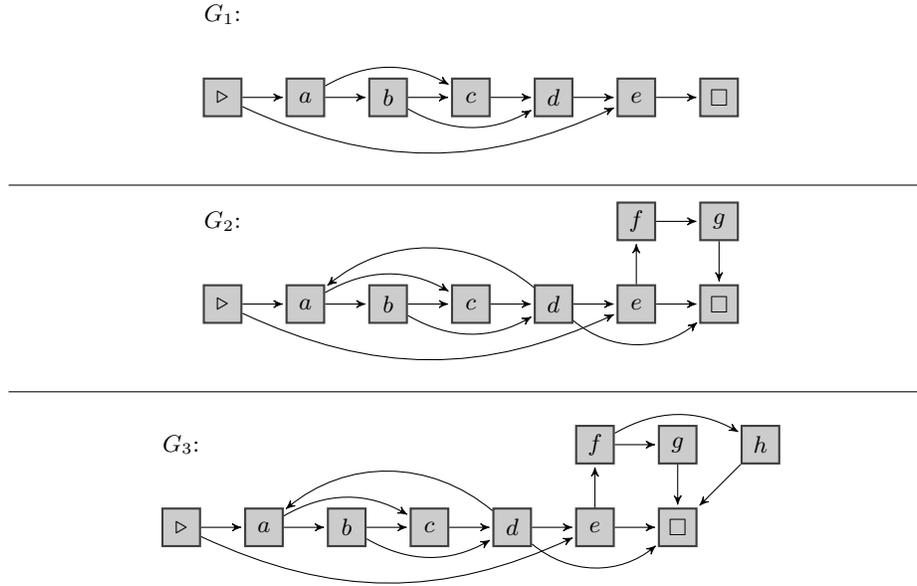


Fig. 28. The directly follows graphs for the logs L_1, L_2, L_3 from the example in Theorem 32. G_1 is the DFG for L_1 , G_2 the one for L_2 and G_3 the one for L_3 .

Note that only the frequency of the trace $\langle a, b, d, e \rangle$ changed compared to the previous event logs. Thus, the directly follows graphs G_1, G_2, G_3 for these new event logs L_1, L_2, L_3 are the same as the ones shown in Fig. 28. Since the percentage of unique traces in the event logs L_1, L_2, L_3 strictly increase, i.e., $C_{\text{DT-}\%}(G_1) \approx 0.5714 < C_{\text{DT-}\%}(G_2) = 0.6 < C_{\text{DT-}\%}(G_3) \approx 0.6667$, we have thus shown that $(\mathcal{C}^L, C_{\text{seq}}) \in \mathbf{X}$ for any log complexity measure $\mathcal{C}^L \in \text{LoC}$. \square

Theorem 33. $(\mathcal{C}^L, C_{\text{depth}}) \in \mathbf{X}$ for any log complexity measure $\mathcal{C}^L \in \text{LoC}$.

Proof. Consider the following event logs:

$$L_1 = [\langle a, b \rangle, \langle c, x \rangle, \langle d, y \rangle, \langle e, z \rangle]$$

$$L_2 = L_1 + [\langle a, b \rangle, \langle a, g, b \rangle]$$

$$L_3 = L_2 + [\langle a, b, c, x \rangle, \langle h, i \rangle]$$

Fig. 29 shows the directly follows graphs G_1, G_2, G_3 for the event logs L_1, L_2, L_3 . These graphs have the following complexity scores:

- $C_{\text{depth}}(G_1) = 1$,
- $C_{\text{depth}}(G_2) = 2$,
- $C_{\text{depth}}(G_3) = 1$,

so these graphs fulfill $C_{\text{depth}}(G_1) < C_{\text{depth}}(G_2)$, $C_{\text{depth}}(G_2) > C_{\text{depth}}(G_3)$, and $C_{\text{depth}}(G_1) = C_{\text{depth}}(G_3)$. But the event logs L_1, L_2, L_3 have the following log complexity scores:

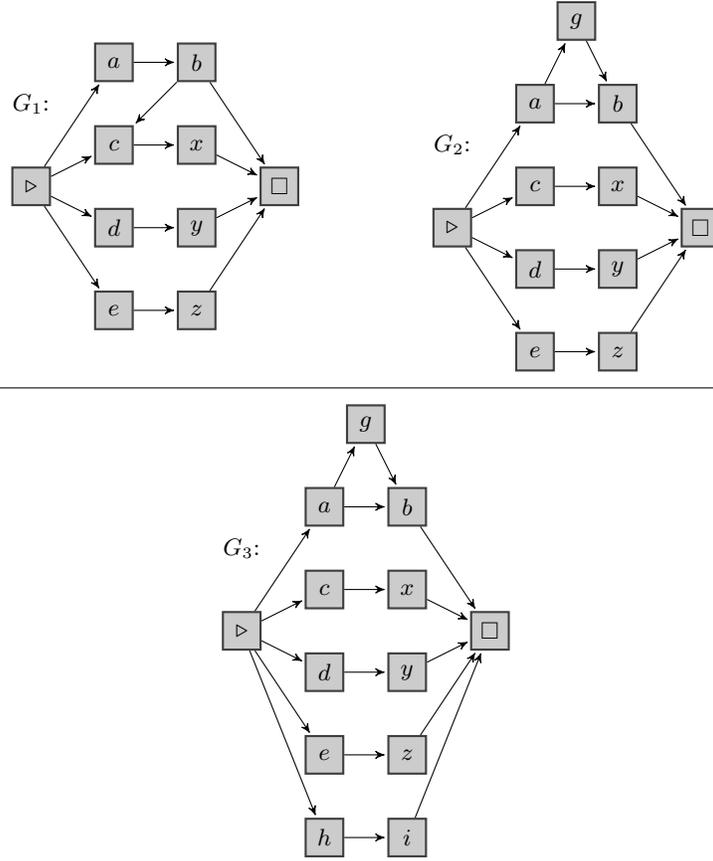


Fig. 29. The directly follows graphs for the logs L_1, L_2, L_3 from the example in Theorem 33. G_1 is the DFG for L_1 , G_2 the one for L_2 and G_3 the one for L_3 .

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-\%}}$
L_1	8	8	4	2	2	4	4	8	4	1
L_2	13	9	6	2.1667	3	5	6	10	5	0.8333
L_3	19	11	8	2.375	4	8	8	14	7	0.875

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	2	0	0.5159	4	11.0904	0.6667	11.0904	0.6667
L_2	2.1667	0.0667	0.5861	3.5333	16.0944	0.699	19.752	0.5924
L_3	2.375	0.0714	0.6143	3.75	24.4702	0.6623	29.2378	0.5226

Therefore, $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) < \mathcal{C}^L(L_3)$ for any event log complexity measure $\mathcal{C}^L \in (\text{LoC} \setminus \{C_{\text{DT-\%}}, C_{\text{avg-dist}}, C_{\text{nvar-e}}, C_{\text{nseq-e}}\})$. For $C_{\text{DT-\%}}$, $C_{\text{avg-dist}}$, $C_{\text{nvar-e}}$, and $C_{\text{nseq-e}}$, consider the following event logs that have the same directly follows

graphs as the ones shown in Fig. 29:

$$\begin{aligned} L_1 &= [\langle a, b \rangle^7, \langle c, x \rangle, \langle d, y \rangle, \langle e, z \rangle] \\ L_2 &= L_1 + [\langle a, g, b \rangle] \\ L_3 &= L_2 + [\langle b, c \rangle, \langle h, i \rangle] \end{aligned}$$

These event logs fulfill:

- $C_{\text{DT-}\%}(L_1) = 0.4 < C_{\text{DT-}\%}(L_2) \approx 0.4545 < C_{\text{DT-}\%}(L_3) \approx 0.5385$,
- $C_{\text{avg-dist}}(L_1) \approx 2.1333 < C_{\text{avg-dist}}(L_2) \approx 2.1455 < C_{\text{avg-dist}}(L_3) \approx 2.4872$,
- $C_{\text{nvar-e}}(L_1) \approx 0.6667 < C_{\text{nvar-e}}(L_2) \approx 0.699 < C_{\text{nvar-e}}(L_3) \approx 0.7374$, and
- $C_{\text{nseq-e}}(L_1) \approx 0.3139 < C_{\text{nseq-e}}(L_2) \approx 0.3598 < C_{\text{nseq-e}}(L_3) \approx 0.4501$.

Since the directly follows graphs are the same as in Fig. 29, their model complexity scores did not change. Thus, we were able to show that $(\mathcal{C}^L, C_{\text{depth}}) \in \mathbf{X}$ for any event log complexity measure $\mathcal{C}^L \in \text{LoC}$. \square

Theorem 34. $(\mathcal{C}^L, C_{\text{cyc}}) \in \mathbf{X}$ for any log complexity measure $\mathcal{C}^L \in \text{LoC}$.

Proof. Consider the following event logs:

$$\begin{aligned} L_1 &= [\langle a \rangle, \langle a, b, c, c, d \rangle, \langle a, b, b, c, d \rangle] \\ L_2 &= L_1 + [\langle a, a, b, b, c, c, d, d, e \rangle] \\ L_3 &= L_2 + [\langle a, b, b, c, c, d \rangle, \langle a, a, a, b, b, b, c, c, c, d, d, d \rangle, \langle v, w, x, x, y, z \rangle] \end{aligned}$$

Fig. 30 shows the directly follows graphs G_1, G_2, G_3 for the event logs L_1, L_2, L_3 . These graphs have the following complexity scores:

- $C_{\text{cyc}}(G_1) = 0.5$,
- $C_{\text{cyc}}(G_2) = 0.8$,
- $C_{\text{cyc}}(G_3) = 0.5$,

so $C_{\text{cyc}}(G_1) < C_{\text{cyc}}(G_2)$, $C_{\text{cyc}}(G_2) > C_{\text{cyc}}(G_3)$, and $C_{\text{cyc}}(G_1) = C_{\text{cyc}}(G_3)$. But the event logs L_1, L_2, L_3 have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-}\#}$	$C_{\text{DT-}\%}$
L_1	11	4	3	3.6667	5	2	3	5	3	1
L_2	20	5	4	5	9	3	4	9	4	1
L_3	44	10	7	6.2857	12	4	8	20	7	1

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	3	0.2	0.6047	3.3333	5.2925	0.3181	6.4455	0.2444
L_2	3.5	0.2667	0.6707	4.3333	16.3829	0.3693	20.2083	0.3373
L_3	3.8571	0.3122	0.6856	6.9524	56.755	0.4734	73.7006	0.4426

Therefore, $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) < \mathcal{C}^L(L_3)$ for any event log complexity measure $\mathcal{C}^L \in (\text{LoC} \setminus \{C_{\text{DT-}\%}\})$. For $C_{\text{DT-}\%}$, consider the following event logs.

$$\begin{aligned} L_1 &= [\langle a \rangle^2, \langle a, b, c, c, d \rangle, \langle a, b, b, c, d \rangle] \\ L_2 &= [\langle a, a, b, b, c, c, d, d, e \rangle] \\ L_3 &= [\langle a, b, b, c, c, d \rangle, \langle a, a, a, b, b, b, c, c, c, d, d, d \rangle, \langle v, w, x, x, y, z \rangle] \end{aligned}$$

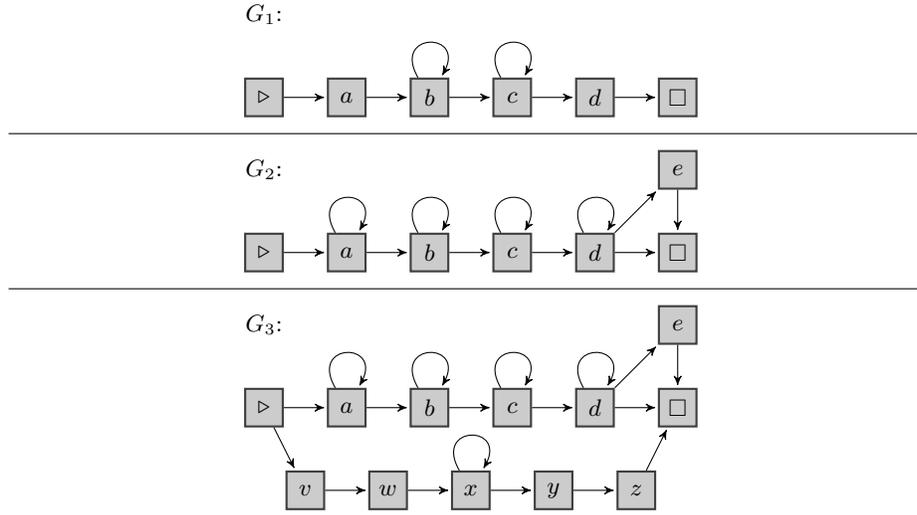


Fig. 30. The directly follows graphs for the logs L_1, L_2, L_3 from the example in Theorem 34. G_1 is the DFG for L_1 , G_2 the one for L_2 and G_3 the one for L_3 .

Since only the frequency of the trace $\langle a \rangle$ changed in contrast to the previous event logs, the directly follows graphs G_1, G_2, G_3 for the new event logs L_1, L_2, L_3 are the same as the ones shown in Fig. 30. But since the new event logs fulfill $C_{DT-\%}(L_1) = 0.75 < C_{DT-\%}(L_2) = 0.8 < C_{DT-\%}(L_3) = 0.875$, we have shown that $(\mathcal{C}^L, C_{cyc}) \in \mathbf{X}$ for any event log complexity measure $\mathcal{C}^L \in LoC$. \square

Theorem 35. $(\mathcal{C}^L, C_{CNC}) \in \mathbf{X}$ for any log complexity measure $\mathcal{C}^L \in LoC$.

Proof. Consider the following event logs:

$$\begin{aligned} L_1 &= [\langle a, a, b, b, c, c, d, d \rangle^2, \langle b, c, d \rangle^3] \\ L_2 &= L_1 + [\langle b, c, d \rangle, \langle a, a, b, b, c, c, d, d, e, e \rangle, \langle a, b, c, d, e \rangle] \\ L_3 &= L_2 + [\langle a, a, a, b, b, b, c, c, c, d, d, d, e, e, e \rangle, \langle u, v, x, x, y, z \rangle] \end{aligned}$$

Fig. 31 shows the directly follows graphs G_1, G_2, G_3 for the event logs L_1, L_2, L_3 . These graphs have the following complexity scores:

- $C_{CNC}(G_1) \approx 1.6667$,
- $C_{CNC}(G_2) \approx 1.8571$,
- $C_{CNC}(G_3) \approx 1.6667$,

so these graphs fulfill $C_{CNC}(G_1) < C_{CNC}(G_2)$, $C_{CNC}(G_2) > C_{CNC}(G_3)$, and $C_{CNC}(G_1) = C_{CNC}(G_3)$. But the event logs L_1, L_2, L_3 have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	C_{TL-avg}	C_{TL-max}	C_{LOD}	C_{t-comp}	C_{LZ}	$C_{DT-\#}$	$C_{DT-\%}$
L_1	25	4	5	5	8	2	3	13	2	0.4
L_2	43	5	8	5.375	10	4	4	20	4	0.5
L_3	64	10	10	6.4	15	5	8	30	6	0.6

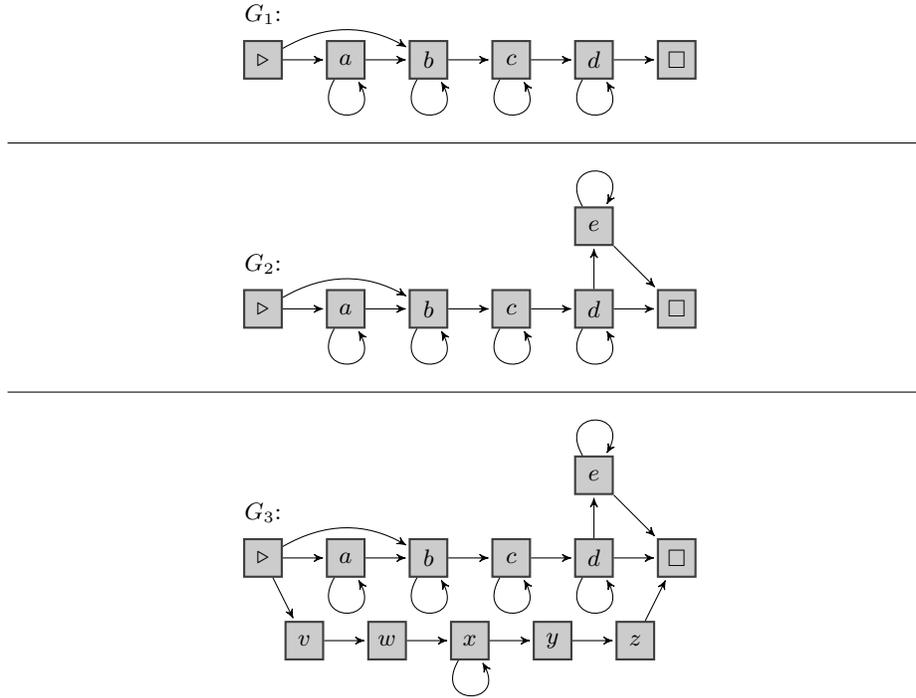


Fig. 31. The directly follows graphs for the logs L_1, L_2, L_3 from the example in Theorem 35. G_1 is the DFG for L_1 , G_2 the one for L_2 and G_3 the one for L_3 .

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	3.4	0.5714	0.6646	3	6.4455	0.2444	16.3355	0.203
L_2	3.75	0.533	0.6668	3.3929	16.2978	0.3384	37.38	0.2311
L_3	4	0.4181	0.6897	6.3111	53.0449	0.4112	89.058	0.3346

Therefore, $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) < \mathcal{C}^L(L_3)$ for any event log complexity measure $\mathcal{C}^L \in (\text{LoC} \setminus \{C_{\text{affinity}}\})$. For C_{affinity} , consider the following event logs:

$$\begin{aligned}
 L_1 &= [\langle a, a, b, b, c, c, d, d \rangle, \langle b, c, d \rangle] \\
 L_2 &= L_1 + [\langle a, a, b, b, c, c, d, d, e, e \rangle] \\
 L_3 &= L_2 + [\langle a, a, a, b, b, b, c, c, c, d, d, d, e, e, e \rangle^3, \langle u, v, x, x, y, z \rangle]
 \end{aligned}$$

Since only the frequencies of traces changed in contrast to the previous event logs, the directly follows graphs G_1, G_2, G_3 for the new event logs L_1, L_2, L_3 are the same as the ones shown in Fig. 31. But since the new event logs fulfill $C_{\text{affinity}}(L_1) \approx 0.2857 < C_{\text{affinity}}(L_2) \approx 0.4286 < C_{\text{affinity}}(L_3) \approx 0.4898$, we have shown that $(\mathcal{C}^L, C_{\text{CNC}}) \in \mathbf{X}$ for any log complexity measure $\mathcal{C}^L \in \text{LoC}$. \square

Theorem 36. $(\mathcal{C}^L, C_{\text{dens}}) \in \mathbf{X}$ for any log complexity measure $\mathcal{C}^L \in \text{LoC}$.

Proof. Consider the following event logs:

$$L_1 = [\langle a \rangle, \langle a, b, c, d \rangle]$$

$$L_2 = L_1 + [\langle a, b, b, c, c, d, d, e, e \rangle]$$

$$L_3 = L_2 + [\langle a, e \rangle, \langle a, b, b, c, b, c, d, d, e, e \rangle^2, \langle v, v, x, x, y, x, y, y, z, z \rangle]$$

Fig. 32 shows the directly follows graphs G_1, G_2, G_3 for the event logs L_1, L_2, L_3 . These graphs have the following complexity scores:

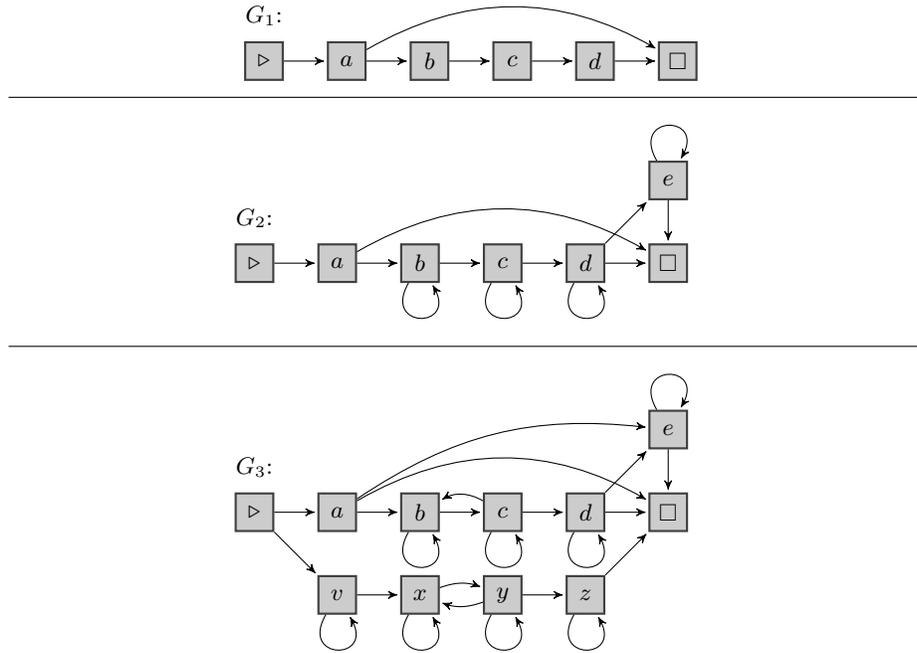


Fig. 32. The directly follows graphs for the logs L_1, L_2, L_3 from the example in Theorem 36. G_1 is the DFG for L_1 , G_2 the one for L_2 and G_3 the one for L_3 .

- $C_{\text{dens}}(G_1) = 0.24$,
- $C_{\text{dens}}(G_2) \approx 0.3333$,
- $C_{\text{dens}}(G_3) = 0.24$,

so these graphs fulfill $C_{\text{dens}}(G_1) < C_{\text{dens}}(G_2)$, $C_{\text{dens}}(G_2) > C_{\text{dens}}(G_3)$, and $C_{\text{dens}}(G_1) = C_{\text{dens}}(G_3)$. But the event logs L_1, L_2, L_3 have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-}}\%$
L_1	5	4	2	2.5	4	2	3	4	2	1
L_2	14	5	3	4.6667	9	3	4	8	3	1
L_3	46	9	7	6.5714	10	5	6	23	6	0.8571

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	2.5	0	0.4796	3	0	0	0	0
L_2	3.3333	0.125	0.683	5.3333	7.2103	0.2734	9.7041	0.2626
L_3	3.7143	0.1753	0.7408	8.1905	40.3588	0.4326	67.077	0.3809

Thus, we have $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) < \mathcal{C}^L(L_3)$ for any event log complexity measure $\mathcal{C}^L \in (\text{LoC} \setminus \{C_{\text{DT-}\%}\})$. For $C_{\text{DT-}\%}$, consider the following event logs:

$$\begin{aligned} L_1 &= [\langle a \rangle^4, \langle a, b, c, d \rangle] \\ L_2 &= L_1 + [\langle a, b, b, c, c, d, d, e, e \rangle] \\ L_3 &= L_2 + [\langle a, e \rangle, \langle a, b, b, c, b, c, d, d, e, e \rangle^2, \langle v, v, x, x, y, x, y, y, z, z \rangle] \end{aligned}$$

Since only the frequencies of traces changed in contrast to the previous event logs, the directly follows graphs G_1, G_2, G_3 for the new event logs L_1, L_2, L_3 are the same as the ones shown in Fig. 32. But since the new event logs fulfill $C_{\text{DT-}\%}(L_1) = 0.4 < C_{\text{DT-}\%}(L_2) = 0.5 < C_{\text{DT-}\%}(L_3) = 0.6$, we have shown that $(\mathcal{C}^L, C_{\text{dens}}) \in \mathbf{X}$ for any log complexity measure $\mathcal{C}^L \in \text{LoC}$. \square

Except for the size and the control flow complexity, none of the existing log complexity measures directly predict the model complexity of the directly follows graph. The maximum connector degree and the diameter of two directly follows graphs G_1, G_2 for event logs L_1, L_2 are always increasing or staying unchanged when $L_1 \sqsubset L_2$, so even for these measures, we did not find a direct connection between log and model complexity. In the following, we will analyze how the model complexity scores of the directly follows graph can be described using properties of the underlying event log. Thus, let $G = (V, E)$ be the directly follows graph for an event log L over a set of activities A . Since G contains exactly one node for every activity in L , as well as the two special nodes \triangleright and \square , the amount of nodes in G is $|V| = 2 + C_{\text{var}}(L)$. Furthermore, by definition of the directly follows graph, we know that G has $|E| = |>_L| + |A_I| + |A_O|$ edges, where $A_I := \{a \in A \mid \exists \sigma \in L : \sigma(1) = a\}$ and $A_O := \{a \in A \mid \exists \sigma \in L : \sigma(|\sigma|) = a\}$. Using the relation $>_L$, we define the following sets for activities $a, b \in A$:

$$\begin{aligned} \succ_L(a) &:= \{b \in A \mid a >_L b\} \cup \{\square \mid a \in A_O\} \\ \succ_L^{-1}(b) &:= \{a \in A \mid a >_L b\} \cup \{\triangleright \mid b \in A_I\} \end{aligned}$$

Furthermore, to keep the formulas as simple as possible, we define

$$\begin{aligned} S_{\text{xor}}^G &= \{a \in A \mid 1 < |\succ_L(a)|\} \\ J_{\text{xor}}^G &= \{a \in A \mid 1 < |\succ_L^{-1}(a)|\} \\ C_{\text{xor}}^G &= S_{\text{xor}}^G \cup J_{\text{xor}}^G \end{aligned}$$

- **Size C_{size} :** As argued before, the directly follows graph G contains exactly $2 + C_{\text{var}}(L)$ nodes, so by definition $C_{\text{size}}(G) = 2 + C_{\text{var}}(L)$.

- **Mismatch** C_{MM} : Since the DFG G contains only **xor**-connectors, the connector mismatch can be described by

$$C_{\text{MM}}(G) = \left| \sum_{a \in S_{\text{xor}}^G} |\succ_L(a)| + \sum_{a \in J_{\text{xor}}^G} |\succ_L^{-1}(a)| \right|.$$

- **Cross Connectivity** C_{CC} : The cross connectivity depends on all paths through the directly follows graph G . While it would be possible to describe it formally by using properties of L , such a description would be complex and thus of little value. We therefore omit this measure.
- **Control Flow Complexity** C_{CFC} : This measure sums the number of edges exciting split nodes in G . Since we have only one type of connectors in G , this means $C_{\text{CFC}}(G) = \sum_{a \in S_{\text{xor}}^G} |\succ_L(a)|$.
- **Separability** C_{sep} : The separability depends on all paths through the directly follows graph G . While it would be possible to describe it formally by using properties of L , such a description would be complex and thus of little value. We therefore omit this measure.
- **Average Connector Degree** C_{acd} : With the notions defined above, the average connector degree of G is

$$C_{\text{acd}}(G) = \frac{\sum_{a \in C_{\text{xor}}^G} (|\succ_L(a)| + |\succ_L^{-1}(a)|)}{|C_{\text{xor}}^G|},$$

since the degree of a node a in G is $|\succ_L(a)| + |\succ_L^{-1}(a)|$.

- **Maximum Connector Degree** C_{mcd} : With the notions defined above, the maximum connector degree of G is

$$C_{\text{acd}}(G) = \max\{|\succ_L(a)| + |\succ_L^{-1}(a)| \mid a \in C_{\text{xor}}^G\}.$$

- **Sequentiality** C_{seq} : We will reuse our definition of the set of connectors C_{xor}^G in G and find

$$C_{\text{seq}}(G) = \frac{|\{(a, b) \in (A \cup \{\triangleright\}) \times (A \cup \{\square\}) \mid a, b \notin C_{\text{xor}}^G\}|}{|\succ_L| + |A_I| + |A_O|}.$$

- **Depth** C_{depth} : The depth depends on all paths through the directly follows graph G . While it would be possible to describe it formally by using properties of L , such a description would be complex and thus of little value. We therefore omit this measure.
- **Diameter** C_{diam} : The diameter depends on all paths through the directly follows graph G . While it would be possible to describe it formally by using properties of L , such a description would be complex and thus of little value. We therefore omit this measure.
- **Cyclicity** C_{cyc} : The cyclicity depends on all paths through the directly follows graph G . While it would be possible to describe it formally by using properties of L , such a description would be complex and thus of little value. We therefore omit this measure.

- **Coefficient of Network Connectivity C_{CNC} :** Since $|V| = 2 + C_{\text{var}}(L)$ and $|E| = |>_L| + |A_I| + |A_O|$, we get $C_{\text{CNC}}(G) = \frac{|>_L| + |A_I| + |A_O|}{2 + C_{\text{var}}(L)}$.
- **Density C_{dens} :** With $|V| = 2 + C_{\text{var}}(L)$ and $|E| = |>_L| + |A_I| + |A_O|$, we get $C_{\text{dens}}(G) = \frac{|>_L| + |A_I| + |A_O|}{(2 + C_{\text{var}}(L)) \cdot (1 + C_{\text{var}}(L))}$.

These findings conclude our analysis of the directly follows graph. Table 12 summarizes these findings for quick reference.

Table 12. The complexity scores of the DFG G for an event log L over A .

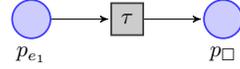
$C_{\text{size}}(G)$	$2 + C_{\text{var}}(L)$
$C_{\text{MM}}(G)$	$\left \sum_{a \in S_{\text{xor}}^G} \succ_L(a) + \sum_{a \in J_{\text{xor}}^G} \succ_L^{-1}(a) \right $
$C_{\text{CFC}}(G)$	$\sum_{a \in S_{\text{xor}}^G} \succ_L(a) $
$C_{\text{acd}}(G)$	$\frac{\sum_{a \in C_{\text{xor}}^G} (\succ_L(a) + \succ_L^{-1}(a))}{ C_{\text{xor}}^G }$
$C_{\text{mcd}}(G)$	$\max\{ \succ_L(a) + \succ_L^{-1}(a) \mid a \in C_{\text{xor}}^G\}$
$C_{\text{seq}}(G)$	$\frac{ \{(a,b) \in (A \cup \{\triangleright\}) \times (A \cup \{\square\}) \mid a, b \notin C_{\text{xor}}^G\} }{ >_L + A_I + A_O }$
$C_{\text{CNC}}(G)$	$\frac{ >_L + A_I + A_O }{2 + C_{\text{var}}(L)}$
$C_{\text{dens}}(G)$	$\frac{ >_L + A_I + A_O }{(2 + C_{\text{var}}(L)) \cdot (1 + C_{\text{var}}(L))}$

4.5 Directly Follows Miner

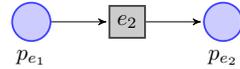
The directly follows miner [20] combines the easy readability of directly follows graphs and the expressiveness and theoretical foundation of Petri nets. For an event log L , this discovery technique first creates the directly follows graph G of L , including edge weights indicating how often two events follow each other. In a second step, the traces corresponding to the most infrequent edge weights are filtered from the event log, until a user-chosen maximum number of traces was deleted. Finally, the algorithm transforms the resulting directly follows graph $G' = (V', E')$ into a sound workflow net by performing the following steps:

- Create a place p_e for every node $e \in V'$.
- For all edges $(e_1, e_2) \in E'$, add the following construct to the already constructed places of the Petri net:

1. If $e_2 = \square$:



2. If $e_1 \neq \square$:



By setting $p_i := p_{\triangleright}$ and $p_o := p_{\square}$, this construction always results in a sound workflow net [20]. In our analyses, we will skip the filtering step of the directly follows miner, and assume that the event logs are already filtered, as filtering can be performed in a preprocessing step. Fig. 33 shows the workflow net found for the event log L of Fig. 1, whose directly follows graph is shown in Fig. 2. Due

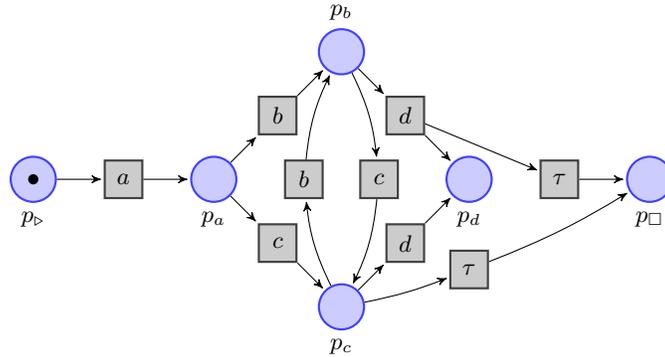


Fig. 33. The result of the directly follows miner for the event log L of Fig. 1.

to its construction, many complexity scores of a model M found by the directly follows miner for an event log L can be described by the complexity scores of its underlying directly follows graph $G = (V, E)$. In contrast to the previous

sections, we will start by comparing the complexity scores of models found by the directly follows miner to the complexity scores of their underlying directly follows graph, as these findings will render some analyses trivial.

- **Size** C_{size} : Every node in G becomes a place in M , so the number of places in M is $|P| = |V|$. Furthermore, every edge in G issues the creation of exactly one transition in M , so $|T| = |E|$. Therefore, we can describe the size of M as $C_{\text{size}}(M) = C_{\text{size}}(G) + |E| = 2 + C_{\text{var}}(L) + |A_I| + |A_O|$.
- **Connector Mismatch** C_{MM} : By construction, only places in M can be connectors, as all transitions have exactly one incoming and one outgoing edge. A place p_v in M has x incoming and y outgoing edges if its corresponding node $v \in V$ has x incoming and y outgoing edges. Thus, the set of connectors in M is the same as in G , and every connector in M has the same in- and out-degree as its corresponding node in G . Therefore, $C_{\text{MM}}(M) = C_{\text{MM}}(G) = \left| \sum_{a \in S_{\text{xor}}^G} |\succ_L(a)| + \sum_{a \in J_{\text{xor}}^G} |\succ_L^{-1}(a)| \right|$.
- **Connector Heterogeneity** C_{CH} : In directly follows graphs, it did not make sense to calculate the entropy of connectors, as this modeling type does not contain semantics for parallelism. A model found by the directly follows miner, on the other hand, is a workflow net and thus has the required semantics. However, due to its construction, M contains only **xor**-connectors, so $C_{\text{CH}}(M) = -(1 \cdot \log_2(1) + 0 \cdot \log_2(0)) = 0$.
- **Token Split** C_{ts} : In directly follows graphs, it did not make sense to calculate the entropy of connectors, as this modeling type does not contain semantics for parallelism. A model found by the directly follows miner, on the other hand, is a workflow net and thus has the required semantics. However, due to its construction, M contains no transitions with more than one outgoing edge, so $C_{\text{ts}}(M) = 0$.
- **Control Flow Complexity** C_{CFC} : Every transition in M has exactly one incoming and one outgoing arc by construction, so there are no **and**-connectors in M . But as argued earlier, every **xor**-connector in G has a corresponding **xor**-connector in M with the same amount of incoming and outgoing edges. Therefore, $C_{\text{CFC}}(M) = C_{\text{CFC}}(G) = \sum_{a \in S_{\text{xor}}^G} |\succ_L(a)|$.
- **Average Connector Degree** C_{acd} : As argued earlier, every **xor**-connector in G has a corresponding **xor**-connector in M with the same amount of incoming and outgoing edges. Since there are no other connectors in M , we get $C_{\text{acd}}(M) = C_{\text{acd}}(G) = \frac{\sum_{a \in C_{\text{xor}}^G} (|\succ_L(a)| + |\succ_L^{-1}(a)|)}{|C_{\text{xor}}^G|}$.
- **Maximum Connector Degree** C_{acd} : As argued before, all **xor**-connectors in G have a corresponding **xor**-connector in M with the same amount of incoming and outgoing edges. Since there are no other connectors in M , we get $C_{\text{mcd}}(M) = C_{\text{mcd}}(G) = \max\{|\succ_L(a)| + |\succ_L^{-1}(a)| \mid a \in C_{\text{xor}}^G\}$.
- **Sequentiality** C_{seq} : In M , no transition can be a connector of any type. Thus, all edges in M have at least one non-connector endpoint. Whether the other endpoint p_v of such an edge is also a non-connector depends on whether its corresponding node $v \in V'$ is a connector. If p_v is not a connector, then it has exactly one incoming and one outgoing edge when $v \notin \{\triangleright, \square\}$, and

- exactly one adjacent edge otherwise. Thus, M has a sequentiality score of $C_{\text{seq}}(M) = 2|V' \setminus (C_{\text{xor}}^G \cup \{\triangleright, \square\})| + |\{p_i \mid \triangleright \in C_{\text{xor}}^G\}| + |\{p_o \mid \square \in C_{\text{xor}}^G\}|$.
- **Diameter** C_{diam} : By construction, every path $(\triangleright, v_1, \dots, v_k, \square)$ in G corresponds to a path $(p_{\triangleright}, v_1, p_{v_1}, \dots, v_k, p_{v_k}, \tau, p_{\square})$ in M , where $k \in \mathbb{N}_0$. Since there are no other paths in M , the longest path in G of length ℓ corresponds to the longest path in M , which has length $2\ell - 1$. Thus, $C_{\text{diam}}(M) = 2C_{\text{diam}}(G) - 1$.
 - **Coefficient of Network Connectivity** C_{CNC} : Since each transition in M has exactly one incoming and one outgoing edge, and contains $|\triangleright_L| + |A_I| + |A_O|$ transitions in total, there are $2(|\triangleright_L| + |A_I| + |A_O|)$ edges in M . Thus, $C_{\text{CNC}}(M) = \frac{2(|\triangleright_L| + |A_I| + |A_O|)}{2 + C_{\text{var}}(L) + |\triangleright_L| + |A_I| + |A_O|} = \frac{2|V| \cdot C_{\text{CNC}}(G)}{|V| + |E|}$.
 - **Density** C_{dens} : As argued before, M contains $2(|\triangleright_L| + |A_I| + |A_O|)$ edges in total. Thus, $C_{\text{dens}}(M) = \frac{2(|\triangleright_L| + |A_I| + |A_O|)}{2(|\triangleright_L| + |A_I| + |A_O|) \cdot (1 + C_{\text{var}}(L))} = \frac{1}{1 + C_{\text{var}}(L)}$.
 - **Number of Empty Sequence Flows** C_{\emptyset} : Since M does not contain any **and**-connectors, there cannot be any places in M that have just **and**-connectors in their pre- and postset. In turn, $C_{\emptyset}(M) = 0$.

Table 13 summarizes these observations by showing how the complexity scores of the model found by the directly follows miner are defined, base on the notions of the previous subsection for the directly follows graph G .

Table 13. The complexity scores of the result M of the directly follows miner for an event log L over a set of activities A . $G = (V, E)$ is the directly follows graph for L .

$C_{\text{size}}(M)$	$2 + C_{\text{var}}(L) + \triangleright_L + A_I + A_O $	$C_{\text{size}}(G) + E $
$C_{\text{MM}}(M)$	$ \sum_{a \in S_{\text{xor}}^G} \triangleright_L(a) + \sum_{a \in J_{\text{xor}}^G} \triangleright_L^{-1}(a) $	$C_{\text{MM}}(G)$
$C_{\text{CH}}(M)$	0	0
$C_{\text{ts}}(M)$	0	0
$C_{\text{CFC}}(M)$	$\sum_{a \in S_{\text{xor}}^G} \triangleright_L(a) $	$C_{\text{CFC}}(G)$
$C_{\text{acd}}(M)$	$\frac{\sum_{a \in C_{\text{xor}}^G} (\triangleright_L(a) + \triangleright_L^{-1}(a))}{ C_{\text{xor}}^G }$	$C_{\text{acd}}(G)$
$C_{\text{mcd}}(M)$	$\max\{ \triangleright_L(a) + \triangleright_L^{-1}(a) \mid a \in C_{\text{xor}}^G\}$	$C_{\text{mcd}}(G)$
$C_{\text{seq}}(M)$	$2 V' \setminus (C_{\text{xor}}^G \cup \{\triangleright, \square\}) + \{p_i \mid \triangleright \in C_{\text{xor}}^G\} + \{p_o \mid \square \in C_{\text{xor}}^G\} $	
$C_{\text{diam}}(M)$		$2C_{\text{diam}}(G) - 1$
$C_{\text{CNC}}(M)$	$\frac{2(\triangleright_L + A_I + A_O)}{2 + C_{\text{var}}(L) + \triangleright_L + A_I + A_O }$	$\frac{2 V \cdot C_{\text{CNC}}(G)}{ V + E }$
$C_{\text{dens}}(M)$	$\frac{1}{C_{\text{var}}(L) + 1}$	$\frac{1}{ V - 1}$
$C_{\emptyset}(M)$	0	0

Next, we will start the analysis of the relations between log- and model complexity. Table 14 shows the relations we found while fixing the directly follows miner. With the observations of Table 13, the analysis of C_{MM} , C_{CFC} , C_{acd} , and

Table 14. The relations between the complexity scores of two nets M_1 and M_2 found by the directly follows miner for the event logs L_1 and L_2 as input respectively, where $L_1 \sqsubset L_2$ and the complexity of L_1 is lower than the complexity of L_2 .

	C_{size}	C_{MM}	C_{CH}	C_{CC}	C_{ts}	C_{CFC}	C_{sep}	C_{acc}	C_{mcd}	C_{seq}	C_{depth}	C_{diam}	C_{cyc}	C_{CNC}	C_{dens}	C_{dup}	C_{\emptyset}
C_{mag}	\leq	X	=	X*	=	\leq	X	X	\leq	X	X	\leq	X	X	\geq	\leq	=
C_{var}	$<$	X	=	X*	=	$<$	X	X	\leq	X	X	\leq	X	X	$>$	$<$	=
C_{len}	\leq	X	=	X*	=	\leq	X	X	\leq	X	X	\leq	X	X	\geq	\leq	=
C_{TL-avg}	\leq	X	=	X*	=	\leq	X	X	\leq	X	X	\leq	X	X	\geq	\leq	=
C_{TL-max}	\leq	X	=	X*	=	\leq	X	X	\leq	X	X	\leq	X	X	\geq	\leq	=
C_{LOD}	$<$	X	=	X*	=	$<$	X	X	\leq	X	X	\leq	X	X	$>$	$<$	=
C_{t-comp}	$<$	X	=	X*	=	$<$	X	X	\leq	X	X	\leq	X	X	$>$	$<$	=
C_{LZ}	\leq	X	=	X*	=	\leq	X	X	\leq	X	X	\leq	X	X	\geq	\leq	=
$C_{DT-#}$	\leq	X	=	X*	=	\leq	X	X	\leq	X	X	\leq	X	X	\geq	\leq	=
$C_{DT-\%}$	\leq	X	=	X*	=	\leq	X	X	\leq	X	X	\leq	X	X	\geq	\leq	=
C_{struct}	\leq	X	=	X*	=	\leq	X	X	\leq	X	X	\leq	X	X	\geq	\leq	=
$C_{affinity}$	\leq	X	=	X*	=	\leq	X	X	\leq	X	X	\leq	X	X	\geq	\leq	=
C_{dev-R}	\leq	X	=	X*	=	\leq	X	X	\leq	X	X	\leq	X	X	\geq	\leq	=
$C_{avg-dist}$	\leq	X	=	X*	=	\leq	X	X	\leq	X	X	\leq	X	X	\geq	\leq	=
C_{var-e}	\leq	X	=	X*	=	\leq	X	X	\leq	X	X	\leq	X	X	\geq	\leq	=
C_{nvar-e}	\leq	X	=	X*	=	\leq	X	X	\leq	X	X	\leq	X	X	\geq	\leq	=
C_{seq-e}	\leq	X	=	X*	=	\leq	X	X	\leq	X	X	\leq	X	X	\geq	\leq	=
C_{nseq-e}	\leq	X	=	X*	=	\leq	X	X	\leq	X	X	\leq	X	X	\geq	\leq	=

*We did not find examples showing that $C^L(L_1) < C^L(L_2)$ and $C_{CC}(M_1) = C_{CC}(M_2)$ is possible.

C_{mcd} become trivial, since these measures return the exact same score for the directly follows graph and for the model found by the directly follows miner. Thus, we can reuse our results of Section 4.4 for these measures.

Theorem 37. Let $C^L \in (LoC \setminus \{C_{var}, C_{LOD}, C_{t-comp}\})$ be a log complexity measure and $C^M \in \{C_{size}, C_{CFC}\}$. Then, $(C^L, C^M) \in \leq$.

Proof. Let M be the model found by the directly follows miner for an event log L , and G be the directly follows graph for L . The claim of this theorem is obvious for C_{CFC} , since $C_{CFC}(M) = C_{CFC}(G)$, and $(C^L, C_{CFC}) \in \leq$ by Theorem 27. For C_{size} , we can use the same examples as in this theorem. First, consider the logs:

$$L_1 = [\langle a, b, c, c \rangle^2, \langle c, c, d, e \rangle]$$

$$L_2 = L_1 + [\langle a, b, c, d, e \rangle]$$

Let M_1, M_2 be the models found by the directly follows miner for L_1, L_2 . Then, $C_{size}(M_1) = 16 = C_{size}(M_2)$. As we have seen in Theorem 27, all log complexity scores except $C_{var}, C_{LOD}, C_{t-comp}$, and $C_{affinity}$ strictly increase for these event logs. For $C_{affinity}$, we can again use the event logs

$$L_1 = [\langle a, b, c, c \rangle, \langle c, c, d, e \rangle]$$

$$L_2 = L_1 + [\langle a, b, c, d, e \rangle]$$

in which affinity increases. But the directly follows graphs, and therefore the models found by the directly follows miner, are the same for L_1 and L_2 . Thus, $C^L(L_1) < C^L(L_2)$ and $C_{size}(M_1) = C_{size}(M_2)$ is possible.

To see that $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ and $C_{\text{size}}(M_1) < C_{\text{size}}(M_2)$ is also possible, consider the following event logs, which were already used and analyzed for their directly follows graph in Theorem 27:

$$\begin{aligned} L_1 &= [\langle a, b, c, d \rangle^2, \langle a, b, c, d, e \rangle^2, \langle d, e, a, b \rangle^2] \\ L_2 &= [\langle a, b, c, d, e \rangle^2, \langle d, e, a, b, c \rangle, \langle c, d, e, a, b \rangle, \langle e, c, d, a, b, c, f \rangle] \end{aligned}$$

The models M_1, M_2 found by the directly follows miner for these event logs fulfill $C_{\text{size}}(M_1) = 17 < 25 = C_{\text{size}}(M_2)$, but Theorem 27 shows that all log complexity scores strictly increase for these two event logs. Thus, $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ and $C_{\text{size}}(M_1) < C_{\text{size}}(M_2)$ is also possible.

Finally, it is not possible that C_{size} decreases, as the size of the directly follows model M is exactly the amount of nodes and edges in its underlying directly follows graph G . The latter can only increase when adding behavior to the underlying event log, as already discussed in Section 4.4. \square

Theorem 38. *Let $\mathcal{C}^L \in (\text{LoC} \setminus \{C_{\text{var}}, C_{\text{LOD}}, C_{t\text{-comp}}\})$ be a log complexity measure and $\mathcal{C}^M \in \{C_{\text{size}}, C_{\text{CFC}}\}$. Then, $(\mathcal{C}^L, \mathcal{C}^M) \in <$.*

Proof. The claim is trivial for $\mathcal{C}^M = C_{\text{CFC}}$, since for any model M found by the directly follows miner for an event log L , we have $C_{\text{CFC}}(M) = C_{\text{CFC}}(G)$, where $G = (V, E)$ is the directly follows graph for L . Theorem 28 shows that the claim is true for $C_{\text{CFC}}(G)$, so we can deduce that it also holds for $C_{\text{CFC}}(M)$. Furthermore, Theorem 28 discusses that an increase in \mathcal{C}^L means that at least one new edge gets introduced to the directly follows graph. Since $C_{\text{size}}(M) = C_{\text{size}}(G) + |E|$, we can immediately see that $C_{\text{size}}(M_1) < C_{\text{size}}(M_2)$ for two models M_1, M_2 found by the directly follows miner for event logs L_1, L_2 , if $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$. \square

Theorem 39. $(\mathcal{C}^L, C_{\text{MM}}) \in \mathbf{X}$ for any log complexity measure $\mathcal{C}^L \in \text{LoC}$.

Proof. Let $L_1 \sqsubset L_2$ be event logs, G_1, G_2 their directly follows graphs, and M_1, M_2 the models found by the directly follows miner for L_1, L_2 . Then, we know that $C_{\text{MM}}(M_1) = C_{\text{MM}}(G_1)$ and $C_{\text{MM}}(M_2) = C_{\text{MM}}(G_2)$. Furthermore, by Theorem 25, we know $C_{\text{MM}}(G_1) < C_{\text{MM}}(G_2)$, $C_{\text{MM}}(G_1) > C_{\text{MM}}(G_2)$, and $C_{\text{MM}}(G_1) = C_{\text{MM}}(G_2)$ are possible when event log complexity increases. Thus, $C_{\text{MM}}(M_1) < C_{\text{MM}}(M_2)$, $C_{\text{MM}}(M_1) > C_{\text{MM}}(M_2)$, and $C_{\text{MM}}(M_1) = C_{\text{MM}}(M_2)$ are all possible as well. \square

Theorem 40. $(\mathcal{C}^L, \mathcal{C}^M) \in =$ for any log complexity measure $\mathcal{C}^L \in \text{LoC}$ and any $\mathcal{C}^M \in \{C_{\text{CH}}, C_{\text{ts}}, C_{\emptyset}\}$.

Proof. Let L be an event log and M be the model found by the directly follows miner for L . By construction, all transitions in M have exactly one incoming and one outgoing edge. Thus, there are no **and**-connectors in M . In turn, we get $C_{\text{CH}}(M) = 0$, $C_{\text{ts}}(M) = 0$, and $C_{\emptyset}(M) = 0$, so for two event logs L_1, L_2 and their directly follows models M_1, M_2 , we always have $\mathcal{C}^M(M_1) = \mathcal{C}^M(M_2)$. \square

Theorem 41. $(\mathcal{C}^L, C_{\text{CC}}) \in \mathbf{X}$ for any log complexity measure $\mathcal{C}^L \in \text{LoC}$.

Proof. We can use the same counter examples as those of Theorem 26. For models M_1, M_2, M_3 found by the directly follows miner for the event logs

$$\begin{aligned} L_1 &= [\langle a, b \rangle^5, \langle c, d \rangle, \langle e, f \rangle, \langle g \rangle] \\ L_2 &= L_1 + [\langle a, b, c, d \rangle, \langle s, t, u, v, w, x, y, z \rangle] \\ L_3 &= L_2 + [\langle h, i, j, k, l, m, n, o, p \rangle] \end{aligned}$$

we get $C_{CC}(M_1) \approx 0.8893 > C_{CC}(M_2) \approx 0.8775 < 0.8911$. Since C_{affinity} and $C_{\text{nvar-e}}$ do not strictly increase for these event logs, we also use the second counter example of Theorem 26. For models M_1, M_2, M_3 found by the directly follows miner for the event logs

$$\begin{aligned} L_1 &= [\langle a, b, c, d \rangle, \langle c, d, e, f \rangle, \langle e, f, g \rangle, \langle a, b \rangle, \langle c, d \rangle, \langle e, f \rangle, \langle g \rangle] \\ L_2 &= L_1 + [\langle a, b, c, d \rangle^2, \langle q, r, s, t \rangle, \langle u, v, w, x, y, z \rangle] \\ L_3 &= L_2 + [\langle a, b, c, d \rangle^3, \langle h \rangle, \langle i \rangle, \langle j \rangle] \end{aligned}$$

we have $C_{CC}(M_1) \approx 0.9675 > C_{CC}(M_2) \approx 0.931 < C_{CC}(M_3) \approx 0.9496$, while the scores of C_{affinity} and $C_{\text{nvar-e}}$ strictly increase. Thus, in total it is not possible to predict the behaviour of C_{CC} when log complexity increases. \square

Theorem 42. $(C^L, C_{\text{sep}}) \in \mathbf{X}$ for any log complexity measure $C^L \in \text{LoC}$.

Proof. Consider the following event logs:

$$\begin{aligned} L_1 &= [\langle a \rangle, \langle a, b, c \rangle] \\ L_2 &= L_1 + [\langle a, b, c \rangle, \langle i, j, j, k \rangle] \\ L_3 &= L_2 + [\langle a, b, c, d \rangle, \langle a, a, b, b, c, c \rangle, \langle i, i, j, j, k, k \rangle] \end{aligned}$$

Fig. 34 shows the models M_1, M_2, M_3 found by the directly follows miner for the event logs L_1, L_2, L_3 . The complexity scores of these models are:

- $C_{\text{sep}}(M_1) = 0.75$,
- $C_{\text{sep}}(M_2) \approx 0.9375$,
- $C_{\text{sep}}(M_3) = 0.75$,

so $C_{\text{sep}}(M_1) < C_{\text{sep}}(M_2)$, $C_{\text{sep}}(M_2) > C_{\text{sep}}(M_3)$, and $C_{\text{sep}}(M_1) = C_{\text{sep}}(M_3)$. But the event logs L_1, L_2, L_3 have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-\%}}$
L_1	4	3	2	2	3	2	2	3	2	1
L_2	11	6	4	2.75	4	3	4	7	3	0.75
L_3	27	7	7	3.8571	6	4	5	14	6	0.8571

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	2	0	0.3764	2	0	0	0	0
L_2	2.5	0.1667	0.5565	3.8333	4.7804	0.3509	7.2103	0.2734
L_3	2.8571	0.1937	0.6766	5.2381	24.842	0.4775	35.0271	0.3936

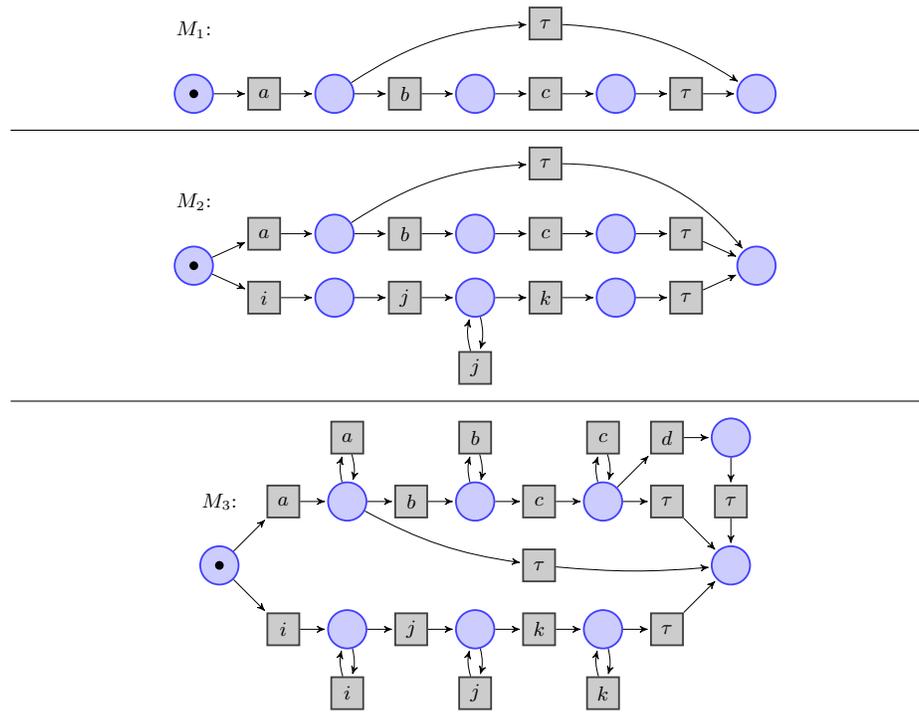


Fig. 34. The results of the directly follows miner for the input logs L_1, L_2, L_3 from the example in Theorem 42. M_1 is the model mined from the log L_1 , M_2 the model mined from the log L_2 , and M_3 the model mined from the log L_3 .

Therefore, $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) < \mathcal{C}^L(L_3)$ for any event log complexity measure $\mathcal{C}^L \in (\text{LoC} \setminus \{C_{\text{DT-}\%}\})$. For $C_{\text{DT-}\%}$, consider the following event logs:

$$\begin{aligned} L_1 &= [\langle a \rangle^4, \langle a, b, c \rangle] \\ L_2 &= L_1 + [\langle a, b, c \rangle, \langle i, j, j, k \rangle] \\ L_3 &= L_2 + [\langle a, b, c, d \rangle, \langle a, a, b, b, c, c \rangle, \langle i, i, j, j, k, k \rangle] \end{aligned}$$

These event logs are the same as before, but the frequency of the trace $\langle a \rangle$ increased. Thus, the directly follows models for these logs are the same as those in Fig. 34. But these logs have an increasing percentage of unique traces, i.e., $C_{\text{DT-}\%}(L_1) = 0.4 < C_{\text{DT-}\%}(L_2) \approx 0.4286 < C_{\text{DT-}\%}(L_3) = 0.6$. Thus, we have $(\mathcal{C}^L, C_{\text{sep}}) \in \mathbf{X}$ for all $\mathcal{C}^L \in \text{LoC}$. \square

Theorem 43. $(\mathcal{C}^L, C_{\text{acd}}) \in \mathbf{X}$ for any log complexity measure $\mathcal{C}^L \in \text{LoC}$.

Proof. Let $L_1 \sqsubset L_2$ be event logs, G_1, G_2 be their directly follows graphs, and M_1, M_2 the models found by the directly follows miner for L_1, L_2 . By previous discussion, we know that $C_{\text{acd}}(M_1) = C_{\text{acd}}(G_1)$ and $C_{\text{acd}}(M_2) = C_{\text{acd}}(G_2)$. Furthermore, by Theorem 30, we know $C_{\text{acd}}(G_1) < C_{\text{acd}}(G_2)$, $C_{\text{acd}}(G_1) > C_{\text{acd}}(G_2)$, and $C_{\text{acd}}(G_1) = C_{\text{acd}}(G_2)$ are possible when log complexity increases. Thus, $C_{\text{acd}}(M_1) < C_{\text{acd}}(M_2)$, $C_{\text{acd}}(M_1) > C_{\text{acd}}(M_2)$, and $C_{\text{acd}}(M_1) = C_{\text{acd}}(M_2)$ are all possible as well. \square

Theorem 44. $(\mathcal{C}^L, C_{\text{mcd}}) \in \leq$ for any log complexity measure $\mathcal{C}^L \in \text{LoC}$.

Proof. Let $L_1 \sqsubset L_2$ be event logs, G_1, G_2 be their directly follows graphs, and M_1, M_2 the models found by the directly follows miner for L_1, L_2 . By previous discussion, we know that $C_{\text{mcd}}(M_1) = C_{\text{mcd}}(G_1)$ and $C_{\text{mcd}}(M_2) = C_{\text{mcd}}(G_2)$. Furthermore, by Theorem 31, we know that $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ always implies $C_{\text{mcd}}(G_1) \leq C_{\text{mcd}}(G_2)$, and $C_{\text{mcd}}(G_1) < C_{\text{mcd}}(G_2)$ and $C_{\text{mcd}}(G_1) = C_{\text{mcd}}(G_2)$ are both possible outcomes. Thus, we can deduce that $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ always implies $C_{\text{mcd}}(M_1) \leq C_{\text{mcd}}(M_2)$, and both $C_{\text{mcd}}(M_1) < C_{\text{mcd}}(M_2)$ and $C_{\text{mcd}}(M_1) = C_{\text{mcd}}(M_2)$ are possible outcomes. \square

Theorem 45. $(\mathcal{C}^L, C_{\text{seq}}) \in \mathbf{X}$ for any log complexity measure $\mathcal{C}^L \in \text{LoC}$.

Proof. Consider the following event logs:

$$\begin{aligned} L_1 &= [\langle a \rangle, \langle a, b, c \rangle] \\ L_2 &= L_1 + [\langle a, a, b, b, c, c, d, d \rangle] \\ L_3 &= L_2 + [\langle a, a, b, b, c, c, d, d \rangle, \langle f, g, h, i, j, k, l, m, n, o, p, q \rangle] \end{aligned}$$

Fig. 35 shows the models M_1, M_2, M_3 found by the directly follows miner for the event logs L_1, L_2, L_3 . The complexity scores of these models are:

- $C_{\text{seq}}(M_1) = 0.5$,
- $C_{\text{seq}}(M_2) = 0.9545$,
- $C_{\text{seq}}(M_3) = 0.5$,

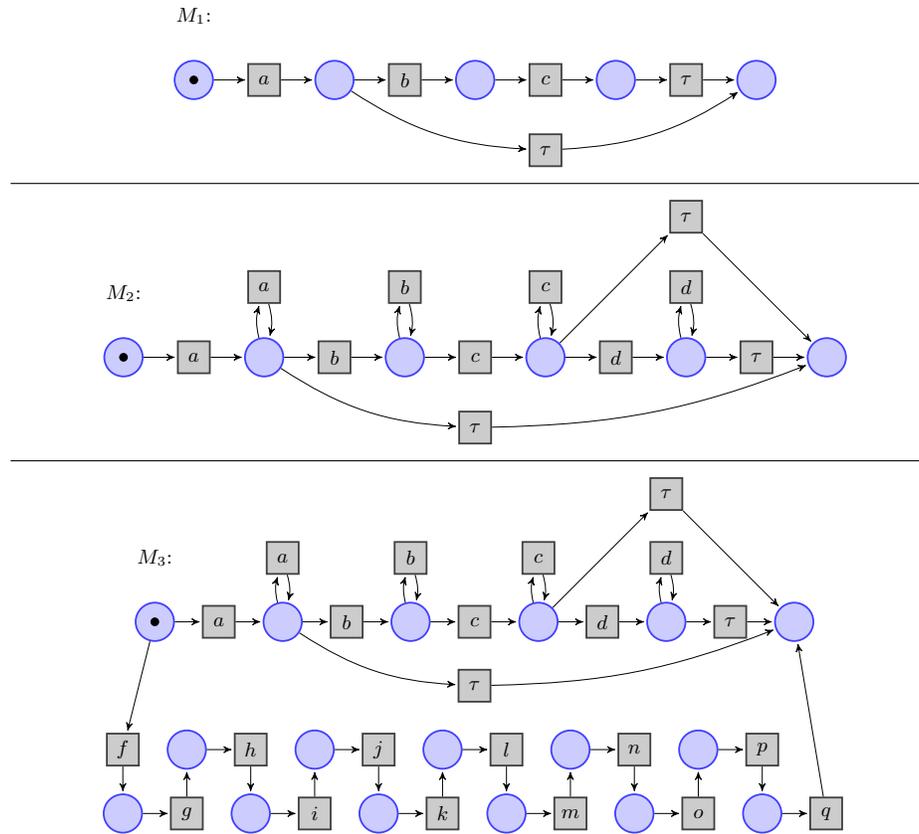


Fig. 35. The results of the directly follows miner for the input logs L_1, L_2, L_3 from the example in Theorem 45. M_1 is the model mined from the log L_1 , M_2 the model mined from the log L_2 , and M_3 the model mined from the log L_3 .

so $C_{\text{seq}}(M_1) < C_{\text{seq}}(M_2)$, $C_{\text{seq}}(M_2) > C_{\text{seq}}(M_3)$, and $C_{\text{seq}}(M_1) = C_{\text{seq}}(M_3)$. But the event logs L_1, L_2, L_3 have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-}\%}$
L_1	4	3	2	2	3	2	2	3	2	1
L_2	12	4	3	4	8	3	3	8	3	1
L_3	32	16	5	6.4	12	4	14	23	4	0.8

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	2	0	0.3764	2	0	0	0	0
L_2	2.6667	0.0952	0.687	4.6667	6.1086	0.2653	8.1503	0.2733
L_3	4.8	0.1571	0.7484	9.4	21.2668	0.3127	33.3873	0.301

Therefore, $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) < \mathcal{C}^L(L_3)$ for any event log complexity measure $\mathcal{C}^L \in (\text{LoC} \setminus \{C_{\text{DT-}\%}\})$. For $C_{\text{DT-}\%}$, consider the following event logs:

$$\begin{aligned} L_1 &= [\langle a \rangle, \langle a, b, c \rangle^5] \\ L_2 &= L_1 + [\langle a, a, b, b, c, c, d, d \rangle] \\ L_3 &= L_2 + [\langle a, a, b, b, c, c, d, d \rangle, \langle f, g, h, i, j, k, l, m, n, o, p, q \rangle] \end{aligned}$$

These event logs are the same as before, but the frequency of the trace $\langle a, b, c \rangle$ increased. Thus, the directly follows models for these logs are the same as those in Fig. 35. But these logs have an increasing percentage of unique traces, i.e., $C_{\text{DT-}\%}(L_1) \approx 0.3333 < C_{\text{DT-}\%}(L_2) \approx 0.4286 < C_{\text{DT-}\%}(L_3) \approx 0.4444$. Thus, we have $(\mathcal{C}^L, C_{\text{seq}}) \in \mathbf{X}$ for all $\mathcal{C}^L \in \text{LoC}$. \square

Theorem 46. $(\mathcal{C}^L, C_{\text{depth}}) \in \mathbf{X}$ for any log complexity measure $\mathcal{C}^L \in \text{LoC}$.

Proof. Consider the following event logs:

$$\begin{aligned} L_1 &= [\langle a, b \rangle^2, \langle c, x \rangle^2, \langle d, y \rangle^2, \langle e, z \rangle] \\ L_2 &= L_1 + [\langle a, b \rangle, \langle a, g, b \rangle, \langle a, g, g, b \rangle] \\ L_3 &= L_2 + [\langle a, g, g, g, b \rangle^2, \langle b, c \rangle, \langle h, i \rangle] \end{aligned}$$

Fig. 36 shows the models M_1, M_2, M_3 found by the directly follows miner for the event logs L_1, L_2, L_3 . The complexity scores of these models are:

- $C_{\text{depth}}(M_1) = 1$,
- $C_{\text{depth}}(M_2) = 2$,
- $C_{\text{depth}}(M_3) = 1$,

thus, we get that $C_{\text{depth}}(M_1) < C_{\text{depth}}(M_2)$, $C_{\text{depth}}(M_2) > C_{\text{depth}}(M_3)$, and $C_{\text{depth}}(M_1) = C_{\text{depth}}(M_3)$. But the event logs L_1, L_2, L_3 have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-}\%}$
L_1	14	8	7	2	2	4	4	11	4	0.5714
L_2	23	9	10	2.3	4	5	6	15	6	0.6
L_3	37	11	14	2.6429	5	14	8	21	9	0.6429

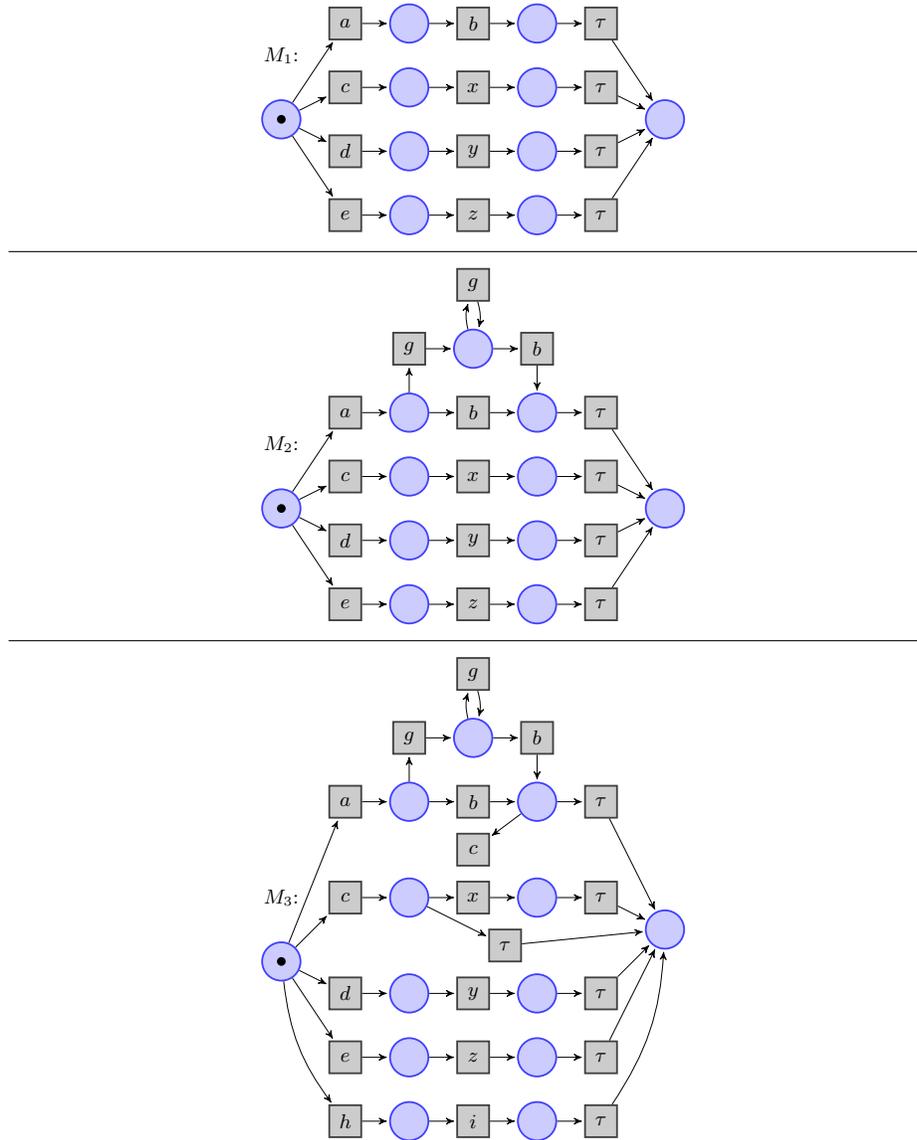


Fig. 36. The results of the directly follows miner for the input logs L_1, L_2, L_3 from the example in Theorem 46. M_1 is the model mined from the log L_1 , M_2 the model mined from the log L_2 , and M_3 the model mined from the log L_3 .

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	2	0.1429	0.5003	3.4286	11.0904	0.6667	18.925	0.5122
L_2	2.2	0.1259	0.616	3.4889	21.5011	0.7211	38.3221	0.5314
L_3	2.2857	0.1099	0.6295	3.8571	39.55	0.7602	76.1913	0.5703

Therefore, $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) < \mathcal{C}^L(L_3)$ for any event log complexity measure $\mathcal{C}^L \in (\text{LoC} \setminus \{C_{\text{affinity}}\})$. For C_{affinity} , consider the following event logs:

$$\begin{aligned} L_1 &= [\langle a, b \rangle, \langle c, x \rangle, \langle d, y \rangle, \langle e, z \rangle] \\ L_2 &= L_1 + [\langle a, b \rangle, \langle a, g, g, b \rangle] \\ L_3 &= L_2 + [\langle a, g, g, g, b \rangle^3, \langle b, c \rangle, \langle h, i \rangle] \end{aligned}$$

The directly follows models for these logs are the same as those in Fig. 36. But, for these logs, $C_{\text{affinity}}(L_1) = 0 < C_{\text{affinity}}(L_2) \approx 0.0667 < C_{\text{affinity}}(L_3) \approx 0.1273$. Thus, we have $(\mathcal{C}^L, C_{\text{depth}}) \in \mathbf{X}$ for all $\mathcal{C}^L \in \text{LoC}$. \square

Theorem 47. $(\mathcal{C}^L, C_{\text{diam}}) \in \leq$ for any log complexity measure $\mathcal{C}^L \in \text{LoC}$.

Proof. Let $L_1 \sqsubset L_2$ be event logs, G_1, G_2 be their directly follows graphs, and M_1, M_2 the models found by the directly follows miner for L_1, L_2 . By the introductory discussion of this subsection, we know that $C_{\text{diam}}(M_1) = 2C_{\text{diam}}(G_1) - 1$ and that $C_{\text{diam}}(M_2) = 2C_{\text{diam}}(G_2) - 1$. Furthermore, by Theorem 31, we know that $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ always implies $C_{\text{diam}}(G_1) \leq C_{\text{diam}}(G_2)$. Thus, such an increase in log complexity also implies that the diameter scores of M_1 and M_2 fulfill $C_{\text{diam}}(M_1) = 2C_{\text{diam}}(G_1) - 1 \leq 2C_{\text{diam}}(G_2) - 1 = C_{\text{diam}}(M_2)$. \square

Theorem 48. $(\mathcal{C}^L, C_{\text{cyc}}) \in \mathbf{X}$ for any log complexity measure $\mathcal{C}^L \in \text{LoC}$.

Proof. Consider the following event logs:

$$\begin{aligned} L_1 &= [\langle a \rangle, \langle a, b, c, c \rangle] \\ L_2 &= L_1 + [\langle a, b, b, c, d, e \rangle] \\ L_3 &= L_2 + [\langle a, b, b, b, c, d, d, e \rangle^2, \langle v, w, x, y, z \rangle] \end{aligned}$$

Fig. 37 shows the models M_1, M_2, M_3 found by the directly follows miner for the event logs L_1, L_2, L_3 . The complexity scores of these models are:

- $C_{\text{cyc}}(M_1) \approx 0.2222$,
- $C_{\text{cyc}}(M_2) \approx 0.2667$,
- $C_{\text{cyc}}(M_3) \approx 0.2222$,

so $C_{\text{cyc}}(M_1) < C_{\text{cyc}}(M_2)$, $C_{\text{cyc}}(M_2) > C_{\text{cyc}}(M_3)$, and $C_{\text{cyc}}(M_1) = C_{\text{cyc}}(M_3)$. But the event logs L_1, L_2, L_3 have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-\%}}$
L_1	5	3	2	2.5	4	2	2	3	2	1
L_2	11	5	3	3.6667	6	3	4	8	3	1
L_3	32	10	6	5.3333	8	4	8	18	5	0.8333

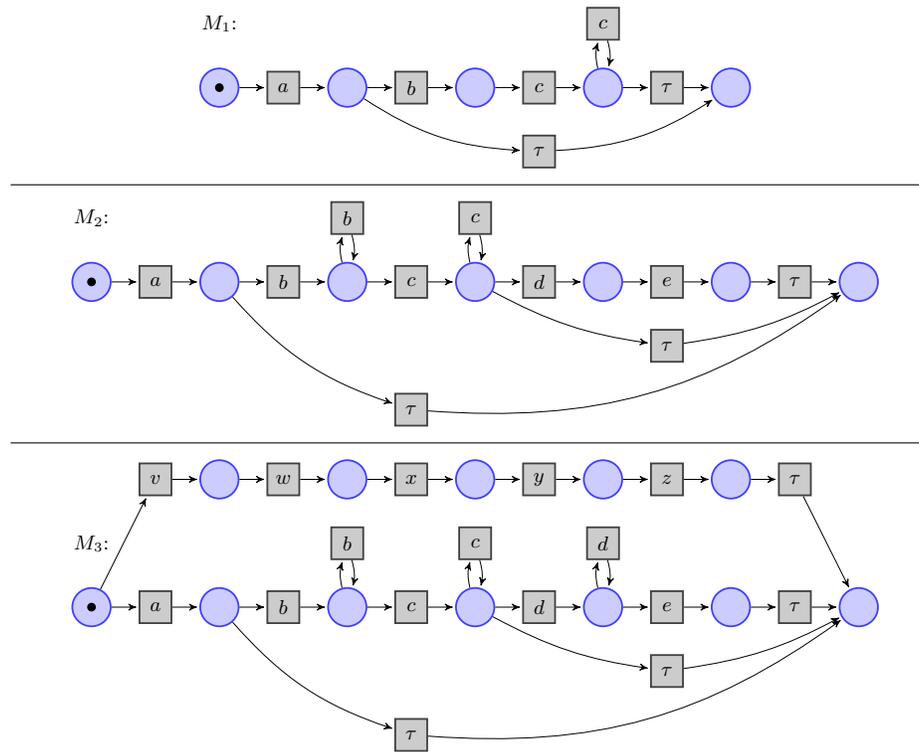


Fig. 37. The results of the directly follows miner for the input logs L_1, L_2, L_3 from the example in Theorem 48. M_1 is the model mined from the log L_1 , M_2 the model mined from the log L_2 , and M_3 the model mined from the log L_3 .

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	2	0	0.5286	3	0	0	0	0
L_2	3	0.1111	0.6159	4	5.5452	0.3333	7.2103	0.2734
L_3	4	0.2381	0.662	6.2667	24.842	0.4775	42.7031	0.385

Therefore, $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) < \mathcal{C}^L(L_3)$ for any event log complexity measure $\mathcal{C}^L \in (\text{LoC} \setminus \{C_{\text{DT-}\%}\})$. For $C_{\text{DT-}\%}$, consider the following event logs:

$$\begin{aligned} L_1 &= [\langle a \rangle^3, \langle a, b, c, c \rangle] \\ L_2 &= L_1 + [\langle a, b, b, c, d, e \rangle] \\ L_3 &= L_2 + [\langle a, b, b, b, c, d, d, e \rangle^2, \langle v, w, x, y, z \rangle] \end{aligned}$$

These event logs are the same as before, but the frequency of the trace $\langle a \rangle$ increased. Thus, the directly follows models for these logs are the same as those in Fig. 37. But these logs have an increasing percentage of unique traces, i.e., $C_{\text{DT-}\%}(L_1) = 0.5 < C_{\text{DT-}\%}(L_2) = 0.6 < C_{\text{DT-}\%}(L_3) = 0.625$. Thus, we have $(\mathcal{C}^L, C_{\text{cyc}}) \in \mathbf{X}$ for all $\mathcal{C}^L \in \text{LoC}$. \square

Theorem 49. $(\mathcal{C}^L, C_{\text{CNC}}) \in \mathbf{X}$ for any log complexity measure $\mathcal{C}^L \in \text{LoC}$.

Proof. Consider the following event logs:

$$\begin{aligned} L_1 &= [\langle a, a, b, b, c, c, d, d \rangle, \langle b, c, d \rangle^3] \\ L_2 &= L_1 + [\langle b, c, d \rangle, \langle a, a, b, b, c, c, d, d, e, e \rangle, \langle a, b, c, d, e \rangle] \\ L_3 &= L_2 + [\langle a, a, a, b, b, b, c, c, c, d, d, d, e, e, e \rangle, \langle u, v, x, x, y, z \rangle] \end{aligned}$$

Fig. 38 shows the models M_1, M_2, M_3 found by the directly follows miner for the event logs L_1, L_2, L_3 . The complexity scores of these models are:

- $C_{\text{CNC}}(M_1) = 1.25$,
- $C_{\text{CNC}}(M_2) = 1.3$,
- $C_{\text{CNC}}(M_3) = 1.25$,

thus, we get the inequalities $C_{\text{CNC}}(M_1) < C_{\text{CNC}}(M_2)$, $C_{\text{CNC}}(M_2) > C_{\text{CNC}}(M_3)$, and $C_{\text{CNC}}(M_1) = C_{\text{CNC}}(M_3)$. But the event logs L_1, L_2, L_3 have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-}\#}$	$C_{\text{DT-}\%}$
L_1	17	4	4	4.25	8	2	3	9	2	0.5
L_2	35	5	7	5	10	4	4	17	4	0.5714
L_3	56	10	9	6.2222	15	5	8	27	6	0.6667

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	3.25	0.6429	0.6045	2.5	6.4455	0.2444	11.7541	0.244
L_2	3.7143	0.5538	0.6489	3.2381	16.2978	0.3384	33.1288	0.2662
L_3	4	0.4094	0.6925	6.5556	53.0449	0.4112	82.0258	0.3639

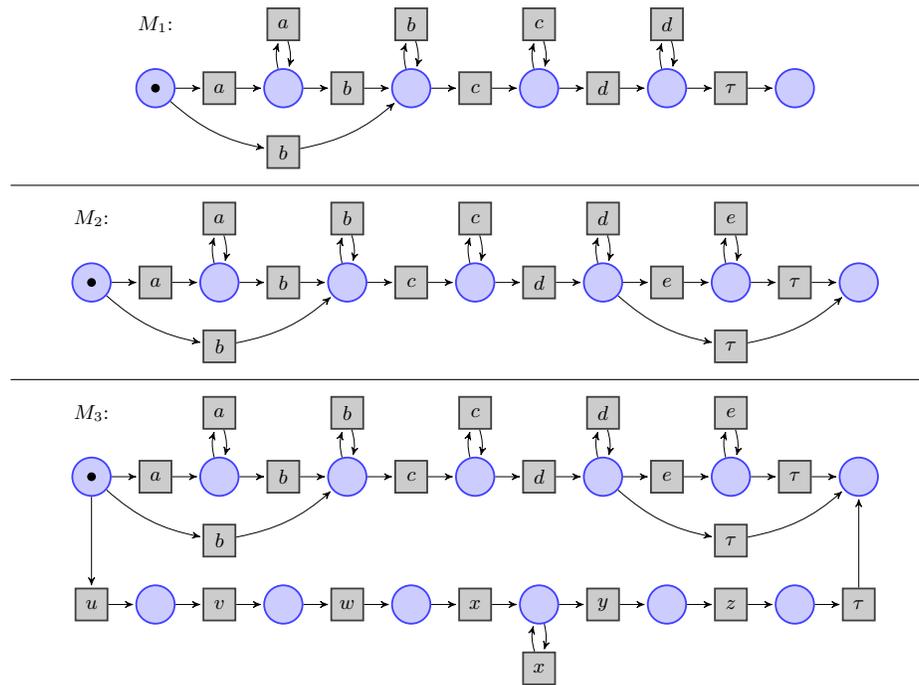


Fig. 38. The results of the directly follows miner for the input logs L_1, L_2, L_3 from the example in Theorem 49. M_1 is the model mined from the log L_1 , M_2 the model mined from the log L_2 , and M_3 the model mined from the log L_3 .

Therefore, $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2) < \mathcal{C}^L(L_3)$ for any event log complexity measure $\mathcal{C}^L \in (\text{LoC} \setminus \{C_{\text{affinity}}\})$. For C_{affinity} , consider the following event logs:

$$\begin{aligned} L_1 &= [\langle a, a, b, b, c, c, d, d \rangle, \langle b, c, d \rangle] \\ L_2 &= L_1 + [\langle a, a, b, b, c, c, d, d, e, e \rangle, \langle a, b, c, d, e \rangle] \\ L_3 &= L_2 + [\langle a, a, a, b, b, b, c, c, c, d, d, d, e, e, e \rangle^3, \langle u, v, x, x, y, z \rangle] \end{aligned}$$

These event logs differ from those from before only in their frequencies. Thus, the directly follows models for these logs are the same as those in Fig. 38. But these event logs have increasing affinity scores, since we can calculate that $C_{\text{affinity}}(L_1) \approx 0.2857 < C_{\text{affinity}}(L_2) \approx 0.4342 < C_{\text{affinity}}(L_3) \approx 0.4621$. Thus, we have $(\mathcal{C}^L, C_{\text{CNC}}) \in \mathbf{X}$ for all $\mathcal{C}^L \in \text{LoC}$. \square

Theorem 50. *Let $\mathcal{C}^L \in (\text{LoC} \setminus \{C_{\text{var}}\})$ be any log complexity measure. Then, $(\mathcal{C}^L, C_{\text{dens}}) \in \geq$.*

Proof. Let $L_1 \sqsubset L_2$ be event logs and M_1, M_2 the models found by the directly follows miner for L_1, L_2 . By the introductory discussion at the start of this subsection, we know that $C_{\text{dens}}(M_1) = \frac{1}{C_{\text{var}}(L_1)+1}$ and $C_{\text{dens}}(M_2) = \frac{1}{C_{\text{var}}(L_2)+1}$. By 1, we know that $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ and $C_{\text{dens}}(M_1) = C_{\text{dens}}(M_2)$ is possible, since we can increase \mathcal{C}^L without changing variety, and thus not changing density. To see that $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ and $C_{\text{dens}}(M_1) > C_{\text{dens}}(M_2)$ is also possible, consider the following event logs:

$$\begin{aligned} L_1 &= [\langle a, b, c, d \rangle^2, \langle a, b, c, d, e \rangle^2, \langle d, e, a, b \rangle^2] \\ L_2 &= L_1 + [\langle a, b, c, d, e \rangle^2, \langle d, e, a, b, c \rangle, \langle c, d, e, a, b \rangle, \langle e, c, d, a, b, c, f \rangle] \end{aligned}$$

Then, for the models M_1, M_2 found by the directly follows miner for L_1, L_2 , we have $C_{\text{dens}}(M_1) = \frac{1}{6} > \frac{1}{7} = C_{\text{dens}}(M_2)$, because $C_{\text{var}}(L_1) = 5$ and $C_{\text{var}}(L_2) = 6$. However, all log complexity scores increase between these event logs:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-}}$
L_1	26	5	6	4.3333	5	6	5	13	3	0.5
L_2	53	6	11	4.8182	7	30	8	22	6	0.5455

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	4.3333	0.56	0.5757	2.6667	6.1827	0.3126	16.0483	0.1894
L_2	4.7273	0.5721	0.5995	3.0909	30.24	0.4447	62.1108	0.2952

Therefore, $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$ for all $\mathcal{C}^L \in \text{LoC}$, and $C_{\text{dens}}(M_1) > C_{\text{dens}}(M_2)$. \square

Theorem 51. $(C_{\text{var}}, C_{\text{dens}}) \in >$.

Proof. Let $L_1 \sqsubset L_2$ be event logs and M_1, M_2 be the models found by the directly follows miner for L_1, L_2 . Suppose $C_{\text{var}}(L_1) < C_{\text{var}}(L_2)$. Then, by the results of the introductory discussion at the start of this subsection, we get $C_{\text{dens}}(M_1) = \frac{1}{C_{\text{var}}(L_1)+1} > \frac{1}{C_{\text{var}}(L_2)+1} = C_{\text{dens}}(M_2)$. \square

Theorem 52. Let $\mathcal{C}^L \in (\text{LoC} \setminus \{C_{\text{var}}, C_{\text{LOD}}, C_{\text{t-comp}}\})$ be a log complexity measure. Then, $(\mathcal{C}^L, C_{\text{dup}}) \in \leq$.

Proof. Let $L_1 \sqsubset L_2$ be event logs, G_1, G_2 their directly follows graphs, and M_1, M_2 be the models found by the directly follows miner for L_1, L_2 . We first observe that duplicate labels in the directly follows models appear whenever a node v in the directly follows graph has multiple incoming edges. Suppose $\mathcal{C}^L(L_1) \leq \mathcal{C}^L(L_2)$. Then, every edge of G_1 is also part of G_2 . In turn, every node in G_2 has at least as many incoming edges as the same node in G_1 . Since we cannot delete any edges in the directly follows graph by adding behavior to an event log, this means $C_{\text{dup}}(M_1) \leq C_{\text{dup}}(M_2)$. What remains to be shown is that both $C_{\text{dup}}(M_1) = C_{\text{dup}}(M_2)$ and $C_{\text{dup}}(M_1) < C_{\text{dup}}(M_2)$ are possible when $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$.

For the former, we have seen in Lemma 7 that it is possible to increase the log complexity scores for \mathcal{C}^L without changing the directly follows graph. By construction of the directly follows miner, then M_1 and M_2 also don't change, and thus $C_{\text{dup}}(M_1) = C_{\text{dup}}(M_2)$. To see that $C_{\text{dup}}(M_1) < C_{\text{dup}}(M_2)$ is also possible, consider the following event logs:

$$\begin{aligned} L_1 &= [\langle a, b, d \rangle^2, \langle a, c, d \rangle^2, \langle e \rangle] \\ L_2 &= [\langle a, b, d, e \rangle, \langle a, c, d, e \rangle, \langle a, b, c, d \rangle, \langle a, b, c, b, d, e, f \rangle, \langle a, b, c, b, c, b, d, e, f \rangle] \end{aligned}$$

These event logs have the following log complexity scores:

	C_{mag}	C_{var}	C_{len}	$C_{\text{TL-avg}}$	$C_{\text{TL-max}}$	C_{LOD}	$C_{\text{t-comp}}$	C_{LZ}	$C_{\text{DT-#}}$	$C_{\text{DT-%}}$
L_1	13	5	5	2.6	3	3	4	8	3	0.6
L_2	41	6	10	4.1	9	14	6	18	8	0.8

	C_{struct}	C_{affinity}	$C_{\text{dev-R}}$	$C_{\text{avg-dist}}$	$C_{\text{var-e}}$	$C_{\text{nvar-e}}$	$C_{\text{seq-e}}$	$C_{\text{nseq-e}}$
L_1	2.6	0.2	0.5417	2.4	6.0684	0.5645	11.1636	0.3348
L_2	3.7	0.2316	0.6705	3.1333	32.1247	0.5742	61.0512	0.401

Fig. 39 shows the models M_1, M_2 found by the directly follows miner for the event logs L_1, L_2 . For these models, we have $C_{\text{dup}}(M_1) = 2 < 6 = C_{\text{dup}}(M_2)$. \square

Theorem 53. Let $\mathcal{C}^L \in \{C_{\text{var}}, C_{\text{LOD}}, C_{\text{t-comp}}\}$. Then, $(\mathcal{C}^L, C_{\text{dup}}) \in <$.

Proof. Let $L_1 \sqsubset L_2$ be event logs, G_1, G_2 their directly follows graphs, and M_1, M_2 be the models found by the directly follows miner for L_1, L_2 . In the proof of Theorem 52, we already argued that $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$, since duplicate labels in M come from multiple edges entering a node in G . Therefore, we get $C_{\text{dup}}(M_1) \leq C_{\text{dup}}(M_2)$. Suppose $\mathcal{C}^L(L_1) < \mathcal{C}^L(L_2)$. In the proof of Theorem 28, we argued that this means G_2 contains a new path starting in \triangleright and ending in \square that is not part of G_1 . But then, there must be a node v in G_1 whose number of incoming edges increased in G_2 . The directly follows miner creates transitions with the same labels for all of these edges, so the number of duplicate labels increases, i.e., $C_{\text{dup}}(M_1) < C_{\text{dup}}(M_2)$. \square

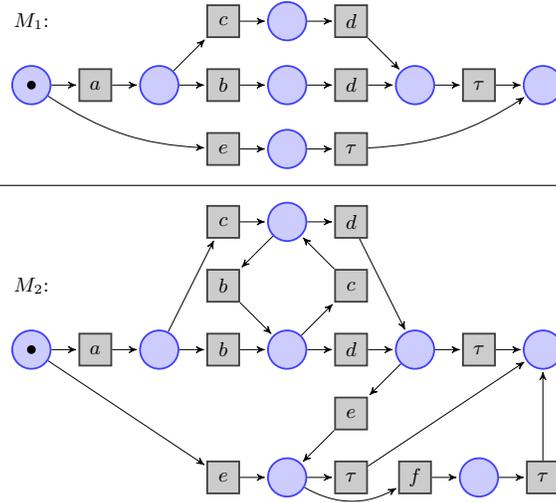


Fig. 39. The results of the directly follows miner for the input logs L_1, L_2 from the example in Theorem 52. M_1 is the model mined from the log L_1 and M_2 the model mined from the log L_2 .

4.6 Other Discovery Algorithms

Apart from the ones in the previous sections, we also investigated the relations between event log and model complexity for models found by the Inductive Miner [21], the Heuristics Miner [22], the Hybrid ILP Miner [23], and several versions of the Alpha Miner [24,25,26]. The results of these analyses are reported in Table 15. Similar to the alpha miner, we were able to show that none of the log complexity measures are able to predict the complexity of discovered models, as almost all table entries contain an X . The only exceptions are the complexity measure C_{dup} and C_\emptyset that contain the entry $=$ for some discovery algorithms. As such, the Inductive Miner and the Heuristics Miner never create empty sequence flows, so $C_\emptyset(M) = 0$ for any model M discovered by one of these algorithms. The different versions of the Alpha Miner, on the other hand, create exactly one transition for each event name, and no other transitions, so $C_{dup}(M) = 0$ for any model M found by these algorithms. We can find a similar argument for the Hybrid ILP Miner, which creates exactly one transition for each event name, alongside two transitions labeled τ . Therefore, a model M found by the Hybrid ILP Miner always contains exactly one label repetition, and hence $C_{dup}(M) = 1$. The counter-examples that show the X -entries in Table 15 can be reproduced by the `anaLOG` tool available at <https://github.com/Pati-nets/anaLOG>.

5 Conclusion

Mature process discovery algorithms must give their users formal guarantees on the returned results [6]. Such formal guarantees may predict what happens to

Table 15. The relations between the complexity scores of two nets M_1 and M_2 found by Inductive Miner, Heuristics Miner, Hybrid ILP Miner, and several versions of the Alpha Miner for the event logs L_1 and L_2 as input respectively, where $L_1 \sqsubset L_2$ and the complexity of L_1 is lower than the complexity of L_2 .

	C_{size}	C_{MM}	C_{CH}	C_{CC}	C_{ts}	C_{CFC}	C_{sep}	C_{acd}	C_{mcd}	C_{seq}	C_{depth}	C_{diam}	C_{cyc}	C_{CNC}	C_{dens}	C_{dup}	C_{\emptyset}
C_{mag}	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X/=	X/=
C_{var}	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X/=	X/=
C_{len}	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X/=	X/=
C_{TL-avg}	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X/=	X/=
C_{TL-max}	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X/=	X/=
C_{LOD}	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X/=	X/=
C_{t-comp}	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X/=	X/=
C_{LZ}	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X/=	X/=
$C_{DT-#}$	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X/=	X/=
$C_{DT-}\%$	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X/=	X/=
C_{struct}	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X/=	X/=
$C_{affinity}$	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X/=	X/=
C_{dev-R}	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X/=	X/=
$C_{avg-dist}$	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X/=	X/=
C_{var-e}	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X/=	X/=
C_{nvar-e}	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X/=	X/=
C_{seq-e}	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X/=	X/=
C_{nseq-e}	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X/=	X/=

discovered models when the complexity of the underlying event log increases. Multiple authors define log complexity measures to use as a predictor for model complexity [1,5]. But so far, no formal guarantees exist on whether these measures actually predict the complexity of discovered models. In this paper, we thus investigated 18 log complexity measures and 17 model complexity measures that found recent interest from researchers, across a total of 10 discovery algorithms. We found that even some complexity scores of the trace net could not be predicted by the complexity of the underlying event log. For the alpha algorithm and other more intricate discovery techniques³, we found no connections between log- and model complexity at all. Across the complexity scores of the directly follows miner and the directly follows graph, we found that only the size, control flow complexity, density, and the number of duplicate tasks can be described by current log complexity measures. Our analyses showed that especially the variety (number of distinct activity names), the level of detail (number of distinct, simple paths in the directly follows graph), and the number of directly follows relations have the highest influence on the investigated discovery algorithms. We further deepened our analysis by describing the model complexity scores of models found by the investigated discovery algorithms using only properties of the underlying event log. We invite inventors of future discovery algorithms to perform these analyses as well, to provide insights into which log complexity measures predict the complexity of their results. To help with this endeavor, we provided a publicly available command-line tool³ that can also be used to reproduce the results presented in this paper.

³ Tool available at: <https://github.com/Pati-nets/anaLOG>

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